

PM112 PERSONALITY MODULE FOR THE MULTIBUS

INSTRUCTION MANUAL



PLEASE CHECK FOR CHANGE INFORMATION AT THE REAR OF THIS MANUAL.



INSTRUCTION MANUAL

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PM 112

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OPERATOR'S SAFETY SUMMARY

The general safety information in this part of the summary is for both operating and service personnel. Specific warnings and cautions will be found throughout the manual where they apply, but may not appear in this summary.

Terms in This Manual

CAUTION statements identify conditions or practices that could result in damage to the equipment or to other property.

WARNING statements identify conditions or practices that could result in personal injury or loss of life.

Grounding the Product

This product is grounded through the grounding conductor of the logic analyzer power cord. To avoid electrical shock, plug the power cord into a properly wired receptacle before connecting the product input or output terminals. This protective ground connection is essential for safe operation.

Danger Arising From Loss of Ground

Upon loss of the protective ground connection, all accessible conductive parts can render an electric shock.

Do Not Operate in Explosive Atmospheres

To avoid explosion, do not operate this product in an explosive atmosphere unless it has been certified for such operation.

Do Not Operate Without Shield

To avoid instrument damage, do not operate this product without its insulating shield installed.

Disconnect Power Before Servicing

Disconnect power before removing insulating shield, soldering, or replacing components.

Conductive Jewelry

Do not wear conductive jewelry while servicing the PM 112.

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PM 112 Personality Module (shown with a Multibus-type cardcage)

Section 1 - PM 112

INTRODUCTION

ABOUT THIS MANUAL

Overview

This manual describes operation and servicing of the PM 112 Personality Module.

The operator's portion provides an overview of the PM 112, connection instructions, operation information, and specifications.

The service portion is located after the colored divider. It contains maintenance information, circuit descriptions, performance check procedures, diagnostic and service procedures, schematics, and parts lists. The service portion of this manual is intended to be used only by qualified service personnel.

At the rear of the manual is a signal glossary. It gives a brief description of signals going to and from the PM 112. After the signal glossary you will find a tab divider, behind which manual change information may be placed.

Conventions Used In This Manual

The following is a list of conventions used throughout this manual:

- Unless distinctions are relevant to operation of the PM 112, any version of Intel's Multibus specification, including the IEEE P796 Proposed Microcomputer System Bus Standard (proposed October, 1980), will be referred to as a Multibus specification or a Multibus system under test (SUT). (Multibus is a registered trademark of the Intel Corporation.) Where mentioned, the IEEE version of the Multibus will be referred to as the IEEE P796 bus.
- All of the simulated 7D02 displays in this manual depict a 7D02 equipped with the Timing Option. The Timing Option causes TIMING WR=X to appear in the word recognizer displays, allows a choice between a MAIN or TIMING trigger in the trigger displays, and causes MAIN to appear following ACQMEM in the bottom inverse video portion of the acquisition memory display.

The 7D02 need not be equipped with the Timing Option for use

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with the PM 112. Operation instructions for the Timing Option are provided in the 7D02 Operator's Manual.

- In the text an (H) or (L) following a signal name indicates that the signal is asserted in the (high) or in the (low) electrical state.
- On the circuit diagrams a bar () over a signal name or portion of a signal name indicates that the signal is asserted in the low electrical state.

The PM 112 shares many of the 7D02 logic analyzer's line names. Therefore, on a PM 112 circuit diagram, the absence of a bar over a line name does not necessarily mean that the signal carried is asserted in the high electrical state.

- On the logic analyzer's display screen and in this manual's simulated screen displays, a slash (/) preceding a field name or portion of a field name indicates that a 0 placed in this field will specify the active condition. For example, placing a 0 in the R/W field will specify that a Write operation be the active condition. (Note that it is possible to invert the active condition for a field, using bus inversion in the Format mode. Doing this will not change the appearance of the field's name on the display.)
- Slashes (/) are also used to denote an active low signal on circuit board mnemonic labels, and are used in the text when referring to board labels.

Other References

The Tektronix 7D02 Logic Analyzer (with Expansion Option) supports the PM 112. You will need to be familiar with the following documentation:

- 7D02 Logic Analyzer Operators Manual (070-2918-00)
- 7D02 Logic Analyzer Service Manual (070-2919-00)

You should also have access to and be familiar with all literature supporting the system under test, including microprocessor documentation, and documentation for the version of bus specification used.

INTRODUCTION TO THE PM 112

The PM 112 Personality Module is designed to facilitate logic analysis of systems based on Intel Multibus and IEEE P796 bus specifications. This is achieved in the following ways:

- The PM 112 connects the logic analyzer to a Multibus system under test (SUT). It plugs into the SUT's backplane in the same manner as any other Multibus-compatible circuit board, and gives the logic analyzer access to all address, data, status, and clock lines. Rather than acting as a bus master or slave, the PM 112 acquires information on the bus as a passive listener. Because the PM 112 monitors only the bus, it does not directly monitor microprocessor operations, and does not follow such on-board functions as local memory programs.
- Hardware in the personality module isolates, buffers, latches, and in some cases encodes information from the SUT bus. The information is organized in a format which is standard to the logic analyzer. Together the PM 112 and the logic analyzer generate a state clock which is used to strobe information from the PM 112 to the logic analyzer's acquisition memory.
- If all the slots in the backplane are in use, the PM 112 can act as an extender for the Pl bus connector.
- Firmware in the personality module personalizes the logic analyzer's display for use with Multibus SUTs, and allows the logic analyzer to disassemble bus commands into descriptive command mnemonics. Because the Multibus specification can be used with a variety of microprocessors, no disassembly of specific microprocessor mnemonics is performed.

NOTE

For use with the PM 112, the 7D02 Logic Analyzer should be equipped with the Expansion Option (Option 03).

Jumper Wires (Optional Accessory)

You may require jumper wires for connecting the user-defined control (UDC) lines to various bus signals not accessed by UDC jumper straps. In particular, jumper wires are necessary for connecting UDC lines to the upper four address lines (ADRl4(L)-ADRl7(L)(HEX)) in Multibus systems using 24-bit addressing. A set of ten 40 cm Individual Connector wires (with female square-pin connectors at one end and Pomona Grabbers at the other) can be ordered as an optional accessory (part number 012-0670-00).

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OPERATION INSTRUCTIONS

CONNECTING THE PM 112

CAUTION

Always switch the logic analyzer mainframe power off before connecting the personality module. Always switch off system-under-test (SUT) power before inserting the personality module into the SUT backplane. Failure to take these precautions may cause permanent damage to the logic analyzer, the personality module, and the system under test.

CONNECTING THE PM 112 TO THE LOGIC ANALYZER

- 1. Switch OFF logic analyzer mainframe power.
- 2. Insert the PM 112's logic analyzer plug, label side up, into the logic analyzer's front panel receptacle.

NOTE

For use with the PM 112, the 7D02 Logic Analyzer should be equipped with the Expansion Option (Option 03).

CONNECTING THE PM 112 TO THE SYSTEM UNDER TEST (SUT)

WARNING

Dangerous voltages may be present within your SUT. Before disassembling the SUT and/or connecting the PM 112, consult documentation supporting the SUT for safety and servicing information. Be sure to perform work as directed, or if required, have the work performed by gualified service personnel.

- 1. Switch off power to the SUT and the logic analyzer.
- 2. Ground yourself to drain static electricity.
- 3. Check to be sure that the jumper strap on jumper W3085 (located on the edge of the PM 112 circuit board near the ribbon cable) is placed in the NORM (rather than the TEST) position. If you do install the PM 112 configured in the self-test mode, the acquisition display DATA values will

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appear as all zeros on the display screen. This serves as a reminder to move the jumper to the NORM position.

- 4. If your SUT uses parallel bus priority resolution, you will want to place the strap on jumper W3015 (shown in Figure 2-6) in the PAR position; if serial bus priority resolution is used place this strap in the SER position.
- 5. At this point you may wish to re-configure the user-defined control (UDC) lines. These lines enable the user to monitor a variety of signals, including the upper four address lines of later bus specifications that use 24-bit addressing. Refer to USING UDC LINES in this section.
- 6. Insert the personality module circuit board into a free slot in the SUT's backplane, with the PM 112's components facing the same direction as those of the SUT's.

CAUTION

When inserting or removing the PM 112, take care to avoid touching components on neighboring circuit boards; electrical and/or physical damage can occur to both the PM 112 and the system under test.

If all slots in the backplane are being used or if the remaining slots are inaccessible, the PM 112's extender socket may be used. Remove one of the SUT's circuit boards that does not require access to the P2 bus connector (the PM 112's extender carries only P1 signals), and insert the PM 112 in its place. Then insert the displaced circuit board into the PM 112's extender socket.

CAUTION

A short-circuit on the PM 112 extender's power runs can cause damage to the SUT and to the PM 112. To prevent damage, be sure that no conductive materials contact the P1 extender's socket assembly. Refer to Specifications section for extender power run current limits.

7. Switch on logic analyzer mainframe power, and power up your system under test.

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DISCONNECTING THE PM 112

- Be sure that power to both the logic analyzer and to the SUT is switched off when disconnecting the PM 112 from the SUT and/or the logic analyzer.
- 2. Ground yourself to drain static electricity.
- 3. Use the white plastic ejector tab (at the ribbon cable corner of the PM 112) to remove the circuit board from the SUT backplane. Avoid contacting components of neighboring circuit boards while removing the PM 112.

STORING AND TRANSPORTING THE PM 112

The PM 112 should be stored and transported in its carrying case using the original packing materials. The carrying case is designed to protect the module from static electricity and physical impact. Keep the personality module in a clean area where the temperature remains between -62 and +85 degrees centigrade, and where humidity does not exceed 95% (non-condensing). Do not flex the PM 112's ribbon cable at temperatures below -15 degrees centigrade.

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USING THE PM 112

The 7D02 Operator's Manual provides general operating information for use with all PM 100 Series personality modules. However, the 7D02 will operate slightly differently with each personality module. This subsection is devoted specifically to operating the 7D02 with the PM 112 Personality Module.

The 7D02 screen displays of the word recognizer, acquired data, clock qualifiers, and FORMAT mode all contain elements that are specific to the PM 112, and are discussed in the following subsections.

WORD RECOGNIZER DISPLAY

The word recognizer can be used to specify recognition of a reference point (trigger event) in the SUT's program for general data acquisition and storage. It can also be used for data qualification, specifying that all information stored in the acquisition memory conforms to parameters selected in the word recognizer. Refer to the 7D02 Operator's Manual for detailed programming information.

When the PM 112 is attached to the 7D02, the 7D02 WD RECOGNIZER key will produce the display shown in Figure 2-1.

Scan by Zenith Operation - PM 112

TEST 1 1 IF 1 WORD RECOGNIZER 1 DATA=XX XX /BHEN 1 ADDR=XXXXX 1 R/W=X MEM/IO=X 1 INTR=X IPR=X 1 /INH1=X /INH2=X 1 TIMING WR=X 1THEN DO 1	# 1 =X INTA+AVAL=X EXT. TRIG. IN=X
DISPLAY <- PROGR	AM
	4288-01

Figure 2-1. 7D02/PM 112 word recognizer display. This display shows the default radices of the address, data and IPR field values (hexadecimal, hexadecimal, and octal, respectively). You can change these radices, as well as invert any word recognizer field value, in the 7D02's FORMAT mode.

A l or a 0 should always be entered in the INTA+AVAL field. If you leave this field don't cared (Xed) the word recognizer will not distinguish I/O operations from Bus Available/Interrupt Acknowledge cycles, nor will it distinguish memory transfers from invalid cycles. These cycle relationships are defined in Table 2-1.

Word Recognizer Fields

The following paragraphs describe elements in the 7D02 word recognizer display that are specific to the PM 112:

DATA--These are actually two separate fields representing recognition values for the high and low bytes of the data bus. While the signals on the data bus are active low, they are firmware-inverted to appear active high on the display. They are normally displayed in hexadecimal radix unless changed in FORMAT mode. FORMAT mode BUS INVERSION also allows you to specify DATA recognition values in their active low form.

During 8-bit cycles (or any time BHEN(L)=1), the high byte of the DATA field specifies recognition values on the eight user-defined control (UDC) lines. Normally BHEN(L)=1 on 8-

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bit data transfers, but you can force BHEN(L) to appear permanently high to the PM 112 by moving a jumper strap (see Monitoring UDC Lines on All Cycles, in this section under USING UDC LINES). Moving this jumper will cause the high DATA byte to specify UDC recognition values on all cycles.

NOTE

When you change the word recognizer DATA field's radix to octal, remember that this field is split into two separate bytes. The most significant octal digit in each of the fields represents only two bits and therefore has a maximum value of 3. For example, to specify recognition of the 16 bit octal word 177777 (all binary 1s), you must enter the value 377 377 (again all binary 1s) in the two DATA fields.

Because the acquisition memory display's DATA field is not split on 16 bit cycles, the number will there be represented as 17777.

/BHEN--When this Multibus signal is asserted (low), it indicates that the high byte on the data bus is enabled (a 16bit data transfer is taking place). Therefore, when you enter a 0 in the word recognizer /BHEN field, you specify that the value in the upper half of the word recognizer DATA field is expected on the upper data bus. Entering a 1 specifies that the value in the upper half of the DATA field is expected on the UDC lines.

ADDR--This is a 20-bit address field. You can change its radix and/or invert its values in FORMAT mode. The default is hexadecimal radix, with bus signals inverted to appear active high on the display. If you are testing a system using 24-bit addressing, you may wish to monitor the upper four address bits ADRl4(L)-ADRl7(L) (HEX) with user-defined control (UDC) lines. Refer to USING UDC LINES in this section of the manual.

R/W--By entering a l in this field of the display, you specify recognition of a Read operation. Entering a 0 specifies a Write operation.

MEM/IO--By entering a l in this field, you specify recognition of a data transfer to/from memory. Entering a 0 specifies an I/O operation.

INTA+AVAL--By entering a 1 in this field you specify that the event recognized be either an Interrupt Acknowledge, or

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a cycle on which the bus is Available (i.e., BUSY(L) is not asserted - either the bus is not in use or a Bus Exchange is taking place). A 0 specifies that the recognized event is not to be any of those above.

Table 2-1 summarizes the types of cycles that can be specified using the R/W, MEM/IO and INTA+AVAL fields of the word recognizer.

NOTE

A 1 or 0 should always be specified in the INTA+AVAL field. If you leave this field don't cared (Xed), the word recognizer will not distinguish I/O operations from Bus Available/Interrupt Acknowledge cycles, nor will it distinguish memory transfers from invalid cycles. These relationships are defined in Table 2-1.

INTR--By entering a 1 in this field of the word recognizer display you specify recognition of a cycle on which at least one Interrupt Request is pending. O specifies that no requests be pending. (This line is active low on the bus, but is inverted by PM 112 firmware to appear active high on the display.)

IPR--You can specify recognition of an interrupt's priority from zero to seven in this field (zero is the highest priority interrupt). Only the highest priority interrupt request can be seen by the PM 112 on a given cycle. For example, if interrupts of priority 2 and 4 are both pending, only priority 2 can be recognized. When INTR=0, IPR will always have the value 7 (lowest priority). Bits in this field may be individually don't-cared (Xed) if the binary radix is selected. For example, you could use this method to define the event to be recognized as an interrupt of priority higher than 4 (i.e., 0, 1, 2, or 3) by specifying IPR=0XX.

/INH1--By entering a 0 in this field you specify recognition of cycles on which RAM is inhibited (when ROM or memory-mapped I/O is being addressed).

/INH2--By entering a 0 in this field you specify recognition of a cycle on which ROM and memory mapped I/O are inhibited (when RAM is being addressed).

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Table 2-1 DISTINGUISHING CYCLE TYPES

INTA+AVAL ¹	MEM/IO	R/W	Cycle Type	Acquisition Memory Display Mnemonic
0	0	0	I/O Write	IOW
0	0	1	I/O Read	IOR
0	1	0	Memory Write	MWT
0	1	1	Memory Read	MRD
1	о	0	Bus Available ²	AVL
1	0	1	Interrupt Acknowledge	INA
1	ı	0	Invalid ₃	* * *
1	1	1	Invalid	* * *

¹ A l or 0 should be specified in the INTA+AVAL field, or the word recognizer will not distinguish I/O operations from Bus Available/Interrupt Acknowledge cycles, nor will it distinguish memory transfers from Invalid cycles.

²BUSY not asserted. Indicates either bus is not in use or Bus Exchange.

 3 Should not occur with properly operating PM 112, logic analyzer, and SUT. See note 1 .

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TRIGGER DISPLAY (CLOCK QUALIFICATION)

The only two aspects of the 7D02 trigger display specific to the PM 112 are clock qualification and use of the System Under Test Halt feature. Figure 2-2 shows the 7D02/PM 112 Trigger Menu. Refer to the 7D02 Operator's Manual for general information on trigger use.

Figure 2-2. 7D02/PM 112 trigger display. This display shows the trigger display following the word recognizer. Clock qualification and the SYSTEM UNDER TEST CONT. (HALT) feature are the only items of the trigger display that are specific to the PM 112 (see text).

This display shows one of the most basic programs possible for data acquisition. To call up this program, press the TRIGGER button after the 7D02 has powered up.

System Under Test Halt

The HALT SUT(L) signal is accessed in the trigger menu by moving the cursor to the SYSTEM UNDER TEST CONT. field. The menu will expand to offer:

0-SYSTEM UNDER TEST CONT. 0 SYSTEM UNDER TEST CONT. 1 SYSTEM UNDER TEST HALT

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If you enter a l in this field, HALT SUT(L) will be asserted after data acquisition is completed. The line carrying this signal terminates at a square pin on the PM ll2 circuit board marked /HALT SUT (see Figure 2-3). If you wish to use this feature, you must connect HALT SUT(L) by wire to an appropriate SUT line. When connecting, be sure to avoid electrical contention with existing Halt line inputs to the microprocessor. Refer to Specifications section for electrical information.



Figure 2-3. /HALT SUT Pin. The signal HALT SUT(L) will go low after data acquisition is complete, if you have selected this option in the trigger display. HALT SUT(L) terminates at this pin. To use the signal, you must connect it to an appropriate SUT line (see accompanying text, and electrical information in Specifications).

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Clock Qualification

Clock qualification qualifies not only the nature of the trigger condition, but also the nature of all subsequent cycles of data that are stored.

Standard Clock Qualification. The PM 112 provides powerup default values for clock qualification (shown in trigger display as STAN-DARD CLOCK QUAL.) that are appropriate for most Multibus SUT users. Default clock qualification causes data to be acquired on the falling edge of every PM 112 clock signal, which is derived from the falling edge of XACK(L) ORed with the rising edge of BUSY(L). (Refer to the circuit diagrams and Theory of Operation for more information on clock generation.)

User Clock Qualification. You can select non-default values for the PM 112's clock qualification lines C9-C4. This causes the PM 112 clock signal to be qualified by the specified state of one or more of the Multibus signals carried on these lines.

NOTE

Deleting the trigger command from the 7D02 program will not remove user clock qualification values. Clock qualification can only be returned to default by replacing 0 in the STANDARD CLOCK QUAL. field, or by switching the logic analyzer mainframe OFF for five seconds, then back ON.

You access user clock qualification by moving the cursor to the trigger menu's STANDARD CLOCK QUAL. field. The menu will expand as follows:

0-STANDARD CLOCK QUAL. 0 STANDARD CLOCK QUAL. 1 USER CLOCK QUAL.

Entering a l in this field further expands the menu with EDGE OF CLOCK and ANDED CLOCKS selection fields:

1-USER CLOCK QUAL. 1-FALLING EDGE OF CLOCK 0 RISING EDGE OF CLOCK 1 FALLING EDGE OF CLOCK C9-C4 (ANDED CLOCKS)=XXXXXX

(Note the default values. These are the values that are restored whenever you place 0 in the USER CLOCK QUAL. field.) You can choose the clock's falling edge by entering a 1 or by simply moving the cursor to the next field (falling edge is the default value).

By entering a 0 in the FALLING EDGE OF CLOCK field you can select the rising edge of the PM 112 clock. This is not recommended, as the PM 112 operates correctly only when using the falling edge of its clock signal.

C9-C4 are PM 112 control lines that carry Multibus signals, and can be used as clock qualifiers. Entering a 1 or 0 in one or more of these fields (C9 at left to C4 at right) causes the 7D02 to qualify (store) data on clocks occurring when the selected control lines are in their specified states. For example, if you specified C9 (the leftmost bit in the field) equal to 1, and C4 (the rightmost bit) equal to 0, then only those clocks on which C9 (BUSY(H)) = 1 and C4 (INH1(L)) = 0 would be qualified and stored.

The following paragraphs describe the clock qualifier signals carried on lines C9-C4:

- C9 BUSY(H) This is the Multibus Bus Busy signal (inverted). BUSY(H)=0 indicates that no master is using the bus, or that an exchange of bus masters is taking place. By qualifying on C9=1, you can eliminate storage of cycles on which no master is using the bus.
- C8 ACLO(H) In the Intel bus specification, this is the Multibus AC line voltage Low signal. In the IEEE specification this line is reserved; if you are testing this type of system, leave C8 don't cared (Xed).
- C7 LOCK(L) A bus master generating LOCK(L)=0 prevents another processor from accessing the memory during readmodify-write operations. (In some early versions of the bus, this is the Advanced Acknowledge line, AACK(L). A master that detects AACK(L)=0 may eliminate some wait states.)
- C6 CBRQ(L) This is the Multibus Common Bus Request signal. CBRQ(L)=1 indicates to the Bus Master that no other master is requesting the bus. Qualifying on C6=0 will cause the logic analyzer to sample only on those cycles on which the bus is being requested by multiple bus masters.
- C5 INH2(L) This is the Multibus Inhibit ROM signal. It prevents ROM memory addresses from responding to the address on the bus, thereby enabling auxiliary (shadow) ROMs to override ROM memory and share address space. Qualifying on C5=1 will cause only the normal ROM accesses to be sampled.

C4 INH1(L) This is the Multibus Inhibit RAM signal. It prevents RAM memory devices from responding to the address on the address bus, enabling ROM or memory-mapped I/O devices to override RAM memory. Qualifying on C4=1 will cause only the normal RAM accesses to be sampled.

DISPLAYING ACQUIRED DATA

The PM 112 does not decode specific microprocessor mnemonics. The menu offering a choice of absolute or mnemonic display of data, located below the data display in inverse video, has no effect when the PM 112 is used with an Expansion Option-equipped 7D02.

NOTE

If the your 7D02 is not equipped with the required Expansion Option (Option 03), a special error display will occur when you attempt to display acquired data in the default mnemonic mode. This display notifies you that the Expansion Option is required. It also lists the PM 112 functions that are invalid without the expansion option: the upper eight data/UDC lines, the PM 112's address lines (Al9-Al6), four the upper interrupt request and encoded interrupt priority lines. If you use the PM 112 without the Expansion Option, the invalid word recognizer fields are ignored by the 7D02, but do not disappear from the screen.

If you wish to proceed with limited capabilities, the error display is exited by selecting "O ABSOLUTE" in the menu at the display's bottom. Acquired data can then be displayed by the 7D02, but all values in the above-mentioned fields will be invalid.

When you use the default radices for the data display, each word (bus cycle) of data requires one line on the 7D02's screen. When you select binary radix for display of the address bus and/or data bus values, or if you select ASCII for display of the address bus value, then the display uses a three-line format for each word of data.

One-Line Data Display Format

Each word (bus cycle) of acquired data will appear on a single line when the address bus is being displayed in octal or hex radices and the data bus is being displayed in a non-binary radix. Figure 2-4 shows the one-line display format.

CTR	1=00000	EVT TRI	G LOC :	= 002	2
CTR	2=00000	EVT TRI	G IN T	EST 1	
LOC	ADDR	UDC7-0	DATA	CMND	I
000	1133455	01010101	332	IOR	7
001	1133456	543	321	IOW	
7	31314	66	42	MRD	0
003	22222	С	<c></c>	INA	1
004	1133455		125332	IOR	7
005	1133456		543321	IOW	
006	31314		6642	MRD	0
007	22222		C <c></c>	INA	•
DI	SPLAY <-	- ACQMEM	O-MAIN		
	1-MNEM	DNIC			
O ABSOLUTE					
1 MNEMONIC					

4288-04

Figure 2-4. Hypothetical one-line data display. This display shows how varying radix selections affect the formatting of fields in a one-line display. (In actual use the radices would not change from line to line of the display.) Line (LOC) 000 demonstrates octal radices for the address and data buses, and binary for the UDC lines. Line 001 demonstrates octal radices for all three fields. Line 002 is the trigger location (denoted by ---T) and demonstrates hexadecimal radix for all three fields. Line 003 demonstrates the address bus in hexadecimal, and the UDC lines and data bus fields in ASCII.

Lines 000-003 all show data on 8-bit (BHEN(L)=1) operations.

Lines 004-007 show the same information on 16-bit (BHEN(L)=0) operations. Note that the UDC field is empty and that an additional eight high-order bits appear in the data bus field.

The mnemonic/absolute menu at bottom has no effect on the data display when the PM 112 is used with an Expansion Option-equipped 7D02. (See the discussion of special Expansion Option conditions at the beginning of DISPLAYING ACQUIRED DATA.)

Operation - PM 112

The following paragraphs describe the heading and contents of each column in the one-line format data display:

- LOC This column contains the acquisition memory location (000-255) of the word (bus cycle) of data displayed on each line. The oldest word of data is in location 000, the newest in location 255. The location of the trigger word is denoted by "---T" in place of the location number.
- ADDR This column contains the address bus value. The values of all 20 address lines are shown regardless of validity. For instance, all 20 address lines are shown on I/O cycles, even though only Al5-AO have meaningful information on these cycles.

(If you are testing a Multibus system having 24 address lines and wish to monitor ADR14(L)-ADR17(L)(HEX), the most significant four bits, you will need to use UDC lines. Refer to USING UDC LINES later in this section.)

- UDC7-0 This column contains the value of the eight user-defined control lines. UDC7 is located furthest left in the column, UDC0 furthest right. This field will be blank on l6-bit data-transfer cycles, unless BHEN(L) is forced to appear permanently low by using the 8/16 jumper strap (refer to USING UDC LINES later in this section).
- DATA This column contains the data bus value. Only the low byte is present on 8-bit cycles.
- CMND This column contains mnemonics identifying the type of cycle (the Multibus command that was being executed). The mnemonics are derived by encoding several of the Multibus command lines (as defined in Table 2-1). The identified cycle types are:

IOW	=	I/O Write
IOR	=	I/O Read
MWT	=	Memory Write
MRD	=	Memory Read
AVL	=	Bus Available (BUSY not asserted
		either bus not in use or Bus Exchange)
INA	=	Interrupt Acknowledge
* * *	=	Invalid (should not occur with
		correctly operating PM 112 and SUT)

This column contains interrupt request information. A number (0-7) in this column indicates the highest priority interrupt active on the cycle (0 is the highest possible priority). If no interrupt is pending, a "." will appear in this column.

Ι

Three-Line Data Display Format

Each data word (bus cycle) will require three display lines when binary radix has been selected for display of either the data or the address bus, or when ASCII radix has been selected for display of the address bus.



Figure 2-5. Hypothetical three-line data display. This display shows how varying radix selections affect the formatting of fields in a three-line format data display. (In actual use the radices would not change from line to line of the display). Line 000 (LOC) shows an 8-bit data operation; the address bus is in binary, the UDC lines are in hexadecimal, and the data bus is in octal. Line 001 is a trigger word (denoted by ---T), also an 8-bit operation, with the address in ASCII, and both the data bus and the UDC lines shown in binary. Line 002 shows a 16-bit operation with the address in hexadecimal and the data bus in binary.

The mnemonic/absolute menu at bottom has no effect on the data display when the PM 112 is used with an Expansion Option-equipped 7D02. (See the discussion of special Expansion Option conditions at the beginning of DISPLAYING ACQUIRED DATA.)

Operation - PM 112

The three-line format data display's LOC and I column headings have the same meanings as those described previously in the One-Line Data Display Format subsection.

The format for a word of data on a 16-bit cycle (BHEN(L)=0) is as follows:

i

i

On an eight-bit cycle (when BHEN(L)=1) the format is:

The fields "lll," "ccc," and "i" represent memory location, cycle type, and interrupt priority, respectively. These fields have the same functions as described previously for the one-line format data display. Each b above represents one binary digit. If binary radix is not selected for one of the fields, that field will be shorter.

FORMAT MODE

The PM 112 personalizes elements of the 7D02's FORMAT mode display. These elements appear when choosing non-default radices for fields in the word recognizer and data display, and also when inverting buses (making active low lines appear active high and vice versa).

Press the Format key on the 7D02 front panel to enter or exit the the Format mode.

Note that when a signal labeled with a slash is inverted in the FORMAT mode, the appearance of the signal's label will not change on any of the displays.

Operation - PM 112

MANUAL CLOCK SWITCH

The PM 112 has a push-button manual clock switch. This switch is located on the circuit board corner next to the 64-conductor ribbon cable.

The manual clock switch generates an acquisition strobe for the 7D02, in place of a strobe generated by the default PM 112 clock. (The default clock is derived from the falling edge of XACK(L) ORed with the rising edge of BUSY(L) -- for details refer to Theory of Operation.) The manual clock signal is asynchronous, and will give a snapshot of whatever is on the bus during the acquisition strobe. Each snapshot is stored as a data word (bus cycle) by the 7D02.

You might want to use the manual clock for instance, when the 7D02 is running, does not trigger, and displays the message NO CLOCK in the upper left corner of the display screen. XACK(L) and/or BUSY(L) may be stuck high or low, or not present at all (bus inactive).

To use the manual clock, follow these directions:

- Obtain the 7D02 program shown in Figure 2-2 by turning the 7D02 mainframe power off for five seconds, back on, and then push the TRIGGER button. This program, with all field values in the default condition, will allow the 7D02 to trigger regardless of the state of the bus.
- 2. Push the 7D02's START/STOP button.
- 3. Push the manual clock switch. The message SLOW CLOCK will take the place of NO CLOCK on the screen dislay. Push the switch at least two more times.
- 4. Push the START/STOP button to display the acquired data.

PARALLEL AND SERIAL BUS PRIORITY RESOLUTION

The PM 112 has a three-pin jumper to accommodate both parallel and serial bus priority resolution schemes. This jumper, labeled SER PAR, is shown in Figure 2-6. If your SUT uses parallel priority resolution, place this jumper strap in the PAR position. For SUTs using serial priority resolution systems, place the strap in the SER position.

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USING UDC LINES

The user-defined control lines allow a variety of Multibus signals to be monitored and to be used for word recognition. The signals are selected with the use of jumper straps (included with the PM 112) and/or jumper wires. (Jumper wires with grabber tips are recommended, and are available from Tektronix as an optional accessory. Refer to the Introduction section for their part number.) The PM 112 data lines 15-8 effectively become UDC lines 7-0 whenever the SUT performs 8-bit operations (as indicated by BHEN(L)=1).



Switch off power to both the logic analyzer and the SUT before moving jumper straps, attaching jumper wires, or inserting/removing the PM 112. Voltages present within the SUT may be lethal. Damage to the SUT, the PM 112, and the logic analyzer may result if work is performed with power on.

Monitoring UDC Lines on All Cycles

The PM 112 perceives an 8-bit operation as occurring whenever BHEN(L)=1. To force BHEN(L)=1 on all cycles, as seen by the PM 112, move the strap on jumper W3011, labeled 8/16 8, to the 8 position. Moving this jumper strap has no effect on operation of the SUT, but it does prevent the logic analyzer from monitoring the upper eight bits of the data bus. The most significant 8 bits in the word recognizer DATA field will now specify UDC recognition values at all times. The 8/16 8 jumper is located with the other UDC jumpers, as shown in Figure 2-6.

Operation - PM 112



Figure 2-6. UDC jumper pins and straps. The large numeral next to each jumper indicates the UDC line number. Signals accessible by jumper strap are labeled next to the required strap position. In this illustration the straps are shown in their default positions. Jumpers for UDC7 and UDC0 have four possible strap positions; UDC6-1 have two possible positions. The 8 8/16 jumper (near bottom of row) allows UDC lines to be monitored on both 8 and 16-bit cycles when in the 8 position.

Note the SER PAR jumper at bottom of the row; place the jumper strap in the SER position if your SUT uses serial bus priority resolution, or in the PAR position if parallel priority resolution is used.

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Default UDC Line Assignments

Each UDC line is assigned to its default signal when its jumper strap is placed on the leftmost pair of pins, also indicated by tick marks, as shown in Figure 2-5. Table 2-2 is a listing of signals that can be accessed by jumper strap at each UDC jumper.

NOTE

Jumper straps must be in default positions, indicated by tick marks, for the PM 112 to pass self-test.

Optional UDC Line Assignments

By moving the UDC jumper straps to positions other than default, or by removing jumper straps and using jumper wires (connected to the center pins of UDC jumpers) several other Multibus signal lines can be accessed.

Jumper Strap Selected Signals. Each UDC line has either three pins in a row (UDC lines 6-1), or five pins arranged in a cross (UDC7 and UDC0). The three-pin arrangement has two possible jumper strap positions, and the five-pin arrangement has four. Signal names are labeled on the circuit board next to the UDC jumper strap position required, as shown in Figure 2-6. Table 2-2 is a listing of signals that can be accessed by jumper strap at each UDC jumper.

UDC Line	Default	Optional			
UDC0	MRDC(L)	INTRO(L), CBRQ(L), INIT(L)			
UDCl	MWTC(L)	INTR1(L)			
UDC2	IORC(L)	INTR2(L)			
UDC3	IOWC (L)	INTR3(L)			
UDC4	INTA(L)	INTR4(L)			
UDC5	INH2(L)	INTR5(L)			
UDC6	LOCK(L) *	INTR6(L)			
UDC7	INH1(L)	INTR7(L), ACLO(H), BPRN(L)			

		Ta	able	2-2		
DEFAULT	AND	OPTIONAL	UDC	JUMPER	STRAP	POSITIONS

*AACK(L) in early bus specification versions.

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Jumper Wire Selected Signals. The PM 112 provides test point pins for several Multibus signals that can be connected to the UDC jumpers by jumper wires. These test point pins are shown in Figure 2-7. You can also connect UDC lines to TTL level signals in the SUT.

NOTE

At the UDC jumpers, any signals selected by jumper wires have an extra delay of approximately 2 ns. This is subtracted from hold time and added to setup time.



Figure 2-7. Test points accessible by UDC jumper wires. This illustration shows (A) jumper wires connecting the most significant four Multibus address lines (ADR14(L)-ADR17(L)(HEX) of a 24-bit address system), found at Test Point 4079, to UDC lines 4, 5, 6, and 7, and (B) a jumper wire connecting BREQ(L), found at Test Point 1027, to UDC3. Table 2-3 provides a listing of the signals that can be selected by UDC jumper wires.

To connect a signal to a UDC line, remove the jumper strap on the desired UDC line's jumper and connect a jumper wire to the center pin, as shown in Figure 2-6. Connect the other end of the lead to the selected signal's test point pin (or to a convenient connection point for a TTL signal that is within the SUT).

The PM 112 provides test point pins for the signals listed in Table 2-3.

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Test Point Pin	Signal			
TP1027-1	CCLK(L)			
" "-2	XACK (L)			
-3	BREO(L)			
" "-4	BUSY(L)			
-5	BPRO(L)			
" "-6	BCLK(L)			
TP4079-13	PFSR(L)*			
" "-17	PFSN(L) *			
-19	PFIN(L)*			
" "-20	MPRO(L)*			
-27	PARl(L)*			
" "-28	HALT(L) *			
-29	PAR2(L)*			
" "-30	WAIT(L)*			
-31	PLC (H) *			
" "-32	ALE(H) *			
-36	BD RESET(L)*			
" "-38	AUX RESET(L)*			
TP4079-55	ADR16(L)*			
" "-56	ADR17(L) *			
-57	ADR14(L) *			
" "-58	ADR15(L)*			

Table 2-3 SIGNALS ACCESSIBLE BY UDC JUMPER WIRES

*Consult SUT documentation -- these signals carried on Multibus P2 connector with same pin number. May be reserved and/or not bussed on some bus versions.
Section 3 - PM 112

PM 112 SPECIFICATIONS

Overview

This section of the manual provides specifications tables of the following categories:

TABLE	TABLE NUMBER
GENERAL CHARACTERISTICS	3-1
CONTROL LINE USAGE	3-2
ELECTRICAL MECHANICAL	3-3
ENVIRONMENTAL	3-5
LOGIC ANALYZER CABLE	3-6

Listings in Performance Requirements columns are specifications of the instrument that may be verified. If verification of these listed specifications is required for customer incoming inspection or other purposes, procedures and test equipment are described in the Performance Check section of this manual.

Listings in Supplemental Information columns are either explanatory notes or performance characteristics for which no limits are specified. They are not tested in the Performance Check section of this manual.

Safety Certification

The PM 112 complies with the requirements of U.L. 1244, IEC 348, and CSA 556B.

Specifications - PM 112

Table 3-1 PM 112 GENERAL CHARACTERISTICS

CHARACTERISTIC	DESCRIPTION
Channels Stored and Displayed	
Max. Number of Channels	44
Address Lines	20 ADRO(L)-ADRl3(L)(HEX) 24 (using user-defined control lines)
Data Lines 7-0	8 DATO(L)-DAT7(L)(HEX)
Data Lines 15-8, UDC Lines 7-0	<pre>8 DAT8(L)-DATF(L)(HEX) When the upper 8 bits of the data bus are not used, the lines are stored as UDC7- UDC0 (user-defined control).</pre>
Interrupt Priority	3 INTO(L)-INT7(L) (encoded on A22-A20)
Interrupt Request	l INTR(L) (carried on A23)
Command Lines	<pre>4 MWTC(L), MRDC(L), IOWC(L), IORC(L), INTA(L), BUSY(H) (encoded onto C2-C0) BHEN(L)</pre>
	(carried on C3)

1

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Table 3-2 PM 112 CONTROL LINE USAGE

SIGNAL		CONTROL LINE	STORED	WORD RECOGNIZER	CLOCK QUALIFIER
MWTC(L) MRDC(L) IOWC(L) IORC(L) INTA(L) BUSY(H)	encoded on	to C2-C0	x	x	x
BHEN(L) INH1(L) INH2(L) CBRQ(L) LOCK(L) ACLO(H) BUSY(H)		C3 C4 C5 C6 C7 C8 C9	X	X X X	X X X X X X X

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Table 3-3 ELECTRICAL SPECIFICATIONS

CHARACTERISTIC	PERFORMANCE REQUIREMENTS	SUPPLEMENTAL INFORMATION
PM 112 SPECIFICATIONS		
All Signal Inputs		TTL Compatible
v _{iH}	2.0 V min	
v _{iL}	0.6 V max	
V _{max}		5.5 V
V _{min}		-0.5 V
I _{iH} max		20 uA @ 2.7 V
I _{iL} max		200 uA @ 0.4 V
I _{in} @ V max		100 uA
Hysteresis		0.2 V min
Threshold		+1.4 V nominal
Minimum Signal Pulse Widths		50 ns
Input Capacitance		35 pF typical, 60 pF max

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Table 3-3 (cont.) ELECTRICAL SPECIFICATIONS

CHARACTERISTIC	PERFORMANCE REQUIREMENTS	SUPPLEMENTAL INFORMATION
SYSTEM SPECIFICATIONS (with 7D02)		
Clock		
Clock Propagation Delay XACK(L) to CLK (at 7D02)		50 ns min 63 ns max
Clock Period	200 ns min.	
Clock Pulse Width	50 ns min.	
Setup and Hold Measurements made with respe except as denoted by "*" edge of BUSY(L). Data Lines	ct to the fallin - measured with	g edge of XACK(L), respect to the rising
Setup Time Hold Time	0 ns 35 ns	
Address Lines		
Setup Time Hold Time		-5 ns 55 ns
UDC Lines		
Setup Time Hold Time		-5 ns 55 ns (at the UDC jumpers, a signal selected using jumper straps or jumper wires has approximately 2 ns delay. This is sub- tracted from hold time and added to setup time.)

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Table 3-3 (cont.) ELECTRICAL SPECIFICATIONS

CHARACTERISTIC	PERFORMANCE REQUIREMENTS	SUPPLEMENTAL INFORMATION
Commands (MRDC(L), MWTC(L), IORC(L), IOWC(L) and INTA(L))		
Setup Time Hold Time	0 ns 35 ns	30 ns typical
Interrupt Lines (INT0-INT7)		
Setup Time Hold Time		50 ns 45 ns
INHl(L) and INH2(L) (as Word Recognizer inputs)		
Setup Time Hold Time		10 ns 50 ns
BHEN(L)		
Setup Time Hold Time		-5 ns 55 ns
Clock Qualification INH1(L), INH2(L), LOCK(L), ACLO(H)		
Setup Time Hold Time		30 ns 35 ns
CBRQ(L)		
Setup Time Hold Time		25 ns* 35 ns*
Timing Option		
Setup Time Hold Time	-5 ns 50 ns	-5 ns* 65 ns*

*Measured with respect to the rising edge of BUSY(L)

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Table 3-3 (cont.) ELECTRICAL SPECIFICATIONS

ELECTRICAL SPECIFICATIONS		
CHARACTERISTIC	PERFORMANCE REQUIREMENTS	SUPPLEMENTAL INFORMATION
HALT SUT(L)		
Delay		Two qualified State Clocks plus 58 ns max. after 7D02 com- pletes data acquisition
Output Drive		
V _{oL}		0.5 V @ -5 mA m
V _{OH}		2.4 V @ 0.5 mA
Self-Test Clock Accuracy	20 MHz <u>+</u> 5%	
Pl Extender Run Current Limits		
+5 V MB (pins 3, 4, 5, 6)		7.5 A max
+12 V MB (pins 7, 8)		4.3 A max
Reserved (pins 9,10)		4.3 A max
Reserved (pins 77, 78)		4.3 A max
-12 V MB (pins 79,80)		4.3 A max
+5 V MB (pins 81, 82, 83, 84)		7.5 A max
Power Dissipation		3.3 W max. (without self-t

Specifications - PM 112

CHARACTERISTIC	DESCRIPTION
Size	12" by 6.75" 30.5 cm by 17.15 cm (conforms to Intel Multibus and IEEE P796 specifications)
Weight	l 1b. 9 oz. .71 kg
Cable Length (logic analyzer to personality module)	4 ft. <u>+</u> 1.0 ft. 122 cm <u>+</u> 2.5 cm

Table 3-4 MECHANICAL SPECIFICATIONS

Table 3-5 ENVIRONMENTAL SPECIFICATIONS

CHARACTERISTIC	DESCRIPTION
Temperature Operating Non-operating	-15 ⁰ C to +55 ⁰ C -62 ⁰ C to +85 ⁰ C
Relative Humidity	95 to 97% non-condensing
Altitude Operating Non-operating	15,000 ft. (4.5 km) 50,000 ft. (15 km)

Specifications - PM 112

PM 112 J1075 PIN	SIGNAL	DESCRIPTION
1	GROUND	GROUND
2	CLK	Differential ECL level; high=-0.8 V, low=-1.7 V
3	CLK(L)	Differentially ter- minated into 124 ohms; ECL level
4	GND	GROUND
5	AIO	*
6	AIL	*
7	AI2	*
8	AI3	*
9		*
10	ALD ATC	*
12		*
13		*
14	ΔΤΘ	*
15	ATIO	*
16	ATII	*
17	AIL2	*
18	AII3	*
19	AI14	*
20	AI15	*
21	AI16	*
22	AI17	*
23	AI18	*
24	AI19	*
25	AI20 (IPR)	*
26	AI21 (IPR)	*
27	AI22 (IPR)	*
28	AI23 (INTR)	*
29	DIO	*
30	DIL	*
31 32		*
32		*
34		*
35		*
36	DI7	*

Table 3-6 LOGIC ANALYZER CABLE SPECIFICATIONS

*STTL output back terminated into 68 ohms.

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Table 3-6 (cont.) LOGIC ANALYZER CABLE SPECIFICATIONS

PM 112 J1075 PIN	SIGNAL	DESCRIPTION
37	DI8, UDCO	*
38	DI9, UDC1	*
39	DI10, UDC2	*
40	DI11, UDC3	*
41	DI12, UDC4	*
42	DI13, UDC5	*
43	DI14, UDC6	*
44	DI15, UDC7	*
45	+5 V	+5 V supply
	Commands encoded:	
46]	INTA(L), BUSY(H),	(CI0, *
47	MRDC(L), MWTC(L),	CIL *
48	IORC(L), IOWC(L)	(C12, *
49	BHEN (L)	CT3 *
50	TNH1(L)	CIJ
51		CIII,
52		CI5, *
52		CIO, *
53		
54		
56	+5 V	+5 V supply
50	+5 77	+5 V supply
58	+15 V	± 15 V supply
59		-15 V supply
60		
61		1/2 ISTUT input load
62		3 ISTTI input loade
63		3 ISTIL INPUT LOADS
64		CDOUND
04	GND	GROOND

)

*STTL output back terminated into 68 ohms.

WARNING

THE FOLLOWING SERVICING INSTRUCTIONS ARE FOR USE BY QUALIFIED PERSONNEL ONLY. TO AVOID PERSONAL INJURY, DO NOT PERFORM ANY SERVICING OTHER THAN THAT CONTAINED IN OPERATING INSTRUCTIONS UNLESS YOU ARE QUALIFIED TO DO SO. REFER TO OPERATORS SAFETY SUMMARY AND SERVICE SAFETY SUMMARY PRIOR TO PERFORMING ANY SERVICE.

SERVICE SAFETY SUMMARY

For Qualified Service Personnel Only

Terms in This Manual

CAUTION statements identify conditions or practices that could result in damage to the equipment or to other property.

WARNING statements identify conditions or practices that could result in personal injury or loss of life.

Grounding the Product

This product is grounded through the grounding conductor of the logic analyzer power cord. To avoid electrical shock, plug the power cord into a properly wired receptacle before connecting the product input or output terminals. A protective ground connection by way of the grounding conductor in the power cord is essential for safe operation.

Danger Arising From Loss of Ground

Upon loss of the protective ground connection, all accessible conductive parts can render an electric shock.

Do Not Operate Without Shield

To avoid instrument damage, do not operate this product without its insulating shield installed.

Disconnect Power Before Servicing

Disconnect power before removing insulating shield, soldering, or replacing components.

Conductive Jewelry

Do not wear conductive jewelry while servicing the PM 112.

Scan by Zenith Section 4 - PM 112

SECTION 4 THEORY OF OPERATION

OVERVIEW

The primary function of a personality module is to collect data from a system under test (SUT) and transfer this data to the logic analyzer in a format that the analyzer and the user can easily interpret.



Figure 4-1. Block diagram of Multibus-SUT/PM 112/7D02 system.

The PM 112 Personality Module performs its function in the following ways:

• The PM 112 connects the logic analyzer to a Multibus SUT. It plugs into the SUT's card-cage in the same manner as any other Multibus-compatible circuit board (or acts as a Pl extender if all the backplane's slots are in use). Unlike other PM 100 Series personality modules, the PM 112 does not directly monitor a microprocessor in the system under test. Instead, it gives the logic analyzer access to all address, Theory of Operation - PM 112

data, command, status, and clock lines carried on the SUT bus.

- Circuitry in the PM 112 works together with logic analyzer circuitry to generate the state clock. The state clock strobes information from the PM 112 into the logic analyzer's acquisition memory.
- The PM 112 transfers data from the SUT to the logic analyzer in a standard format. The PM 112 also contains firmware that allows the logic analyzer to disassemble the states of the Multibus command lines into descriptive command mnemonics.
- Because the Multibus is a general-purpose bus specification that may be used with a variety of microprocessors, the PM 112 does not disassemble data into the opcode mnemonics of a particular microprocessor.
- In the self-test mode, the PM 112 self-test circuitry generates a predefined set of simulated Multibus signals. These signals are fed into the PM 112 acquisition circuitry and may be used to test both the PM 112 and the logic analyzer.

SIGNAL-NAMING CONVENTIONS

- In the text an (H) or (L) following a signal name indicates that the signal is asserted in the high or in the low electrical state.
- On the circuit diagrams and block diagram, a bar (---) over a signal name or portion of a signal name indicates that the signal is asserted in the low electrical state.

The PM 112 shares many of the logic analyzer's line names. Therefore the absence of a bar over a PM 112 line name does not necessarily mean the signal carried is asserted in the high electrical state.

- On the 7D02's display screen and in this manual's simulated screen displays, a slash (/) preceding a field name or portion of a field name indicates that a 0 placed in this field specifies the active low condition. For example, placing a 0 in the word recognizer R/W field specifies that a Write operation is the active low condition. (Note that it is possible to invert the active condition for a field by entering Format mode and specifying bus inversion. Doing this will not change the appearance of the field's name on the display.)
- Slashes (/) are also used to denote an active low signal on circuit board mnemonic labels, and are used in the text when referring to board labels.

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GENERAL INFORMATION

- All buffers are of hysteresis type, minimizing susceptibility to noise on the SUT bus lines.
- The PM 112's P4039 connector is equivalent to the Multibus P1 connector.
- The PM 112's P4079 connector is equivalent to the Multibus P2 connector.

DETAILED CIRCUIT DESCRIPTION

ACQUISITION CIRCUITRY (1)

Command and Miscellaneous Buffers

Various Multibus signals are buffered by U4021 and U4025A. Some signals are output to the UDC jumpers (W2011-7 through W2011-0), others are carried on control lines to the 7D02, and still others are input to the command encoder.

Command Encoder

The command encoder encodes the four Multibus commands (MRDC(L), MWTC(L), IORC(L), and IOWC(L)), and the INTA(L) and BUSY(H) signals into codes representing the six valid Multibus cycle types: Memory Read, Memory Write, I/O Read, I/O Write, Interrupt Acknowledge, and Bus Available (BUSY(L) not asserted). Because the six signals are mutually exclusive, they can be encoded onto only 3 lines. Codes are carried to the logic analyzer on lines CI2-CI0.

Interrupt Encoder and Buffers

The seven Multibus Interrupt lines, INTRO(L)-INTR7(L), are buffered by U4031 and then priority encoded by U2025. The code output by U2025 identifies the highest priority interrupt line currently asserted. However, U2025 cannot distinguish between 1) only the lowest priority input, INTR7(L), asserted and 2) no interrupts asserted. The enable output (EO) of U2025 is high whenever at least one input is low (asserted), and indicates that at least one interrupt is active. The EO signal is inverted by U2031G and carried to the 7D02 on AI23. The three outputs of U2025 are buffered by U3021, and then carried on AI22-AI20 to the 7D02.



Theory of Operation - PM 112



Figure 4-2. Block diagram of PM 112 acquisition circuitry.

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HALT SUT(L) Buffer

The 7D02 HALT PUT(L) signal (equal to PM 112 HALT SUT(L)) is buffered by U1015E and terminates at TP1025. This signal can be connected by the user, if desired, to an appropriate line in the SUT. HALT SUT(L) will go low when data acquisition is completed by the 7D02, if specified by the user in the 7D02 trigger display.

UDC Jumpers and Buffer

The user-defined control (UDC) lines can access a variety of lines from the Multibus SUT; 20 different signals are available (8 simultaneously) using jumper straps on UDC jumpers W2011-7 through W2011-0. The user can access still other signals with jumper wires attached to the UDC jumpers' middle pins. UDC signals are inverted and buffered by Ul021. The Multibus signal BHEN(L) is inverted by U2031A and enables Ul021. (Ul021 is enabled during 8-bit SUT cycles, or whenever the user places jumper W3011 in the "8" position.) UDC signals are then carried to the logic analyzer on DI15-DI8. (On the 7D02's display screen, the UDC signals are reinverted to appear active in the same state as the original SUT signal appeared.)

Clock Generation

The PM 112 derives its clock signal (CLK) from the Multibus signals XACK(L) and BUSY(L), or from the PM 112 signal MCLK(L). The falling edge of XACK(L) is logically ORed with the rising edge of of BUSY(L). The resulting output is XORed with MCLK(L) (the manual clock switch's output). Implementation of these functions is discussed under the following Manual Clock Switch and TTL-to-ECL Clock Translator headings. Figure 4-5 shows the timing relationships between XACK(L), BUSY(L), and MCLK(L). Figures 4-3 and 4-4 show the timing relationship of Multibus data read and write commands, respectively, to XACK(L).

Manual Clock Switch

The manual clock switch provides an asynchronous clock to the 7D02. For each push of the button, the result is acquisition of a snapshot of the SUT's bus. Gates U4079B and C are cross-coupled, forming a debouncing latch for the switch's output (MCLK(L)). Minimum pulse duration is approximately 50 ns.





Figure 4-3. Multibus SUT memory and I/O read timing. This diagram shows how XACK(L), the Multibus Transfer Acknowledge signal, relates to Multibus read timing. The PM 112 uses XACK(L) for clock generation.



Figure 4-4. Multibus SUT memory and I/O write timing.

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TTL-to-ECL Clock Translator

The TTL-to-ECL clock translator serves three functions:

- to delay the signals used for clock generation, in order to optimize setup and hold relationships between the CLK signal and data;
- 2. to form a signal from XACK(L) logically ORed with BUSY(H), then to logically XOR this signal with the manual clock switch debouncer output, MCLK(L); and
- 3. to generate differential ECL clock signals (CLK(L) and CLK(H)) for the 7D02 from three TTL inputs (XACK(L), BUSY(H), and MCLK(L)). The clock signals cause data acquired by the PM 112 to be strobed into the 7D02.



Figure 4-5. PM 112 Clock Generation.

DL3081 performs the first function, delaying XACK(L) and BUSY(H) by 30 ns.

The second two functions are implemented as follows. Q2086 and R1083 form a 19 mA current source, which feeds the differential comparator. Q2083 is the inverting side of the comparator. R2082 and R2081 serve as a voltage divider, and provide the comparator with a 2.11 V reference voltage.

The remaining transistors execute the logic function. Q2084 is normally on and Q2085 is normally off. When Q2081 and/or Q2087 are turned on by XACK(L) or BUSY(H), the comparator switches, and the CLK(H) signal goes from high to low.

When the manual clock switch is pushed, Q2084 turns off, and 50 ns later Q2085 turns on. This produces a minimum 50 ns clock pulse, as shown in Figure 4-5. The clock pulse occurs regardless of the states of XACK(L) and BUSY(L), because they have in effect been disconnected by Q2084 and bypassed by Q2085.

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68 Ohm Termination

The 68 ohm back-termination resistors improve transmission line characteristics of signals carried on the logic analyzer cable.

ACQUISITION CIRCUITRY $\langle 2 \rangle$

Inhibit Sensor

The inhibit sensor disables the data buffers when it senses Multibus power (+5MB) and self-test power (+5T) simultaneously. This situation can only occur when the PM 112 is configured in the self-test mode and plugged into an SUT. The result of the inhibition is that all zeroes appear in the acquisition memory display's DATA field. This should alert the user that the PM 112 is configured in the self-test mode, and that jumper W3085 should be moved to the NORM, rather than the TEST, position.

Data Buffers

Multibus SUT Data (DATO(L)-DATF(L)) enters the PM 112 at P4039, and is double-buffered to optimize the setup and hold timing relationship between the SUT and the 7D02. When BHEN(L) goes high, buffer Ul045 is disabled. This allows UDC signals to be carried on the upper eight data lines, DI16-DI8, during 8-bit SUT bus cycles or whenever the user forces BHEN(L) to appear high by using jumper W3011. The 7D02 LOOK(H) signal tri-states buffer U2055 when data acquisition is completed, allowing the EPROM to use DI7-DI0 for output to the 7D02.

Address Buffers

Multibus SUT address information (ADR0(L)-ADR13(L), hexadecimal) enters the PM 112 at P4039; is buffered by U4041, U4035, and U3021B; and is then carried to the 7D02 on AI19-AI0. (Note that AI23-AI20 are used only to carry interrupt request information.) The 7D02 LOOK(H) signal tri-states buffers U4041 and U4035 when data acquisition is completed. This allows the 7D02 to use AI10-AI0 (bidirectional) for addressing the EPROM.

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EPROM and Buffer

When the 7D02 has completed data acquisition, it pulls the LOOK(H) line high, which tri-states selected data and address buffers (as described previously). This allows use of AI10-AI0 and DI7-DI0 to access the EPROM (U2041). After a short delay, the 7D02 signal SELP(L) enables the EPROM and buffer U2045, allowing information to flow to the logic analyzer. The timing of these events is diagrammed in Figure 4-6.



Figure 4-6. LOOK(H), SELP(L), and EPROM Data timing relationships. This diagram shows the timing relationship of the 7D02's LOOK(H) and SELP(L) signals to acquisition of data stored within the PM 112's EPROM.

68 Ohm Termination

The 68 ohm back-termination resistors improve transmission line characteristics of signals carried on the logic analyzer cable.

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SELF-TEST GENERATOR <3

The self-test generator provides a set of simulated Multibus signals to the PM 112's acquisition circuitry. They compose a predefined pattern of 16 simulated bus cycles, representing variations on all of the major Multibus cycle types. Figure 4-10 shows timing relationships of the signals in the self-test pattern. Figure 5-3, in the Performance Checks section of this manual, shows this pattern as acquired by the PM 112/7D02. The self-test generator's data and command signals meet the worstcase system timing specifications. Working in concert with the self-test and acquisition circuitry, the 7D02 firmware diagnostics provide a high degree of confidence that the PM 112 hardware is functioning properly.



Figure 4-7. Block diagram of PM 112 self-test generator.

Self-Test Oscillator

The +5T voltage source powers a discrete LC oscillator, providing a 20 MHz output (TCLK(H)). The -15PM voltage source

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provides biasing for the oscillator. The oscillator's output is pulse-shaped by a hysteresis Schmitt-trigger gate (U4079D) to generate a square wave. The self-test oscillator signal may also be provided by an external TTL level clock. This is accomplished by moving jumper W4075 from the INT to the EXT position, and connecting the external TTL clock's output to TP4075.

Power-On Reset

The power-on reset circuitry insures that the outputs of phase counters A and B (U4071 and U2065, respectively) are held low until after the self-test oscillator is up and running. This delay is accomplished by charging C4089 up to the threshold of inverting gate U4079A. When U4079's output goes low, Q4071 shuts off and the phase counters' CLR inputs are released. The sequence takes place independently of the self-test oscillator, and requires approximately 110 ns from the time the +5T voltage source is first powered.

Power Circuitry

The power circuitry is comprised of W3085 (NORM/TEST jumper), which enables power to the self-test circuitry when in the TEST position; an LED (DS2037) that indicates power from the 7D02 (in both the NORM and TEST modes); and decoupling capacitors to reduce noise on power lines.

Output Inhibit Sensor

The output inhibit sensor tri-states all outputs of the selftest generator when it senses Multibus power (+5MB). This eliminates possible contention with signals from the Multibus SUT.

Timing Generator, Phase A Counter, and Phase B Counter

The timing generator provides timing reference edges for deskew latches and synchronizes generation of PXACK(L). PXACK(L) then returns to the timing generator. Outputs from the deskew latches will change on the rising edge of signals TA(H), TC(H), or TD(H) (depending on the particular latch). Timing relationships of the timing generator's input and output signals are shown in Figure 4-8.

U3075B of the timing generator receives TCLK, divides it by two, and outputs complementary 10 MHz signals. The Q(L) output of U3075B, when inverted by U2071B, is TA(H). TA(H) is used to clock the command decoder's deskew latch.

The phase A counter (U4071) is also clocked by TA(H). This

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counter's outputs are: PXACK(L) @ 5 MHz, IO(H)/M(L) @ 2.5 MHz, R(H)/W(L) @ 1.25 MHz, PBPRN(L) @ .62 MHz, and the ripple-carry output, PBUSY(H) @ .62 MHz (once in every 16 TA(H) clocks).

TB(H) is generated by ANDing PXACK(L) with the inverted Q(H) output of U3075B. This is accomplished by components U3071D and U2071C. TB(H) clocks the phase B counter and flip-flop U3075A. Figure 4-8 shows the timing relationship of TB(H) to other timing generator signals.

TC(H) is generated by U4075B as a logical function of U3075B's Q(H) and Q(L), PXACK(L), and QB(H); refer to the Self-Test circuit diagram and Figure 4-8 for details. Because both the Q(H) and Q(L) outputs of U3075B are fed to U4075B, a 2:1 multiplexer function is formed. TC(H) clocks the data generators' deskew latches. On alternate AA data cycles, the data setup time at the output of the self-test generator is reduced from approximately 50 ns to 0 ns, with respect to XACK(L). The 0 ns data setup time simulates worst-case bus timing specifications.

TD(H) is generated by NORing the 10 MHz Q(H) output of U3075B with PXACK(L) (5 MHz). TD(H) clocks the address generator and deskew latches, the interrupt deskew latch, and the miscellaneous deskew latch. Figure 4-8 shows the timing relationship of TD(H) to other timing generator signals.



Figure 4-8. Timing generator inputs and outputs.

The phase B counter (U2065) is clocked by TB(H), operates at one-half the rate of the phase A counter, and is 180 degrees out of phase with the phase A counter.

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The phase B counter's QA(H) output, and its inverted (U2031F) form, QA(L), are the inputs to the address generator and deskew latches.

The phase B counter's QB(H), QC(H), and QD(H) outputs are decoded by the interrupt decoder to simulate the eight priorities of Multibus interrupt signals. QB(H), QC(H), and QD(H) also provide input to the miscellaneous deskew latch, which simulates various other Multibus signals.

The phase B counter's ripple-carry output, PINTA(H), is a primary component for generation of INTA(L), XACK(L), and BUSY(L).

AA-55 Address Generator and Deskew Latches

This function block supplies an AA-55 (hexadecimal) pattern to the address bus on alternate bus cycles. Stimulus is provided by QA(H) and QA(L) from the phase B counter, and is strobed into deskew latches U3041, U3035, and U3025B by timing signal TD(H). Figure 4-10 shows the timing relationships of the selftest generator's address and other outputs.

AA-55 Data Generators and Deskew Latches

This function block supplies an AA-55 (hexadecimal) pattern to the data bus on alternate bus cycles. Stimulus is provided by QB(L) and PXACK(H), and is strobed into deskew latches U3051 and U3045 by timing signal TC(H). Figure 4-10 shows the selftest generator's data and other outputs (note varying data setup time).

Interrupt Decoder and Deskew Latch

The phase B counter's outputs QB(H), QC(H), and QD(H) are decoded by U3055, and are strobed into deskewing latch U3031 by the timing signal TD(H). U3031 outputs INT0-7(L). When PINTA(L) goes high, the decoder is inhibited and no outputs are asserted, simulating a cycle with no interrupts pending. (The 7D02 displays acquisition of such a cycle with a "." in the interrupt (I) field.)

Command Decoder and Deskew Latch

The command decoder generates MRDC(L), MWTC(L), IORC(L), and IOWC(L) by decoding IO(H)/M(L) and R(H)/W(L) from the phase B counter. The decoder's outputs are inhibited during Interrupt Acknowledge (displayed INA) and Bus Available (displayed AVL) cycles. Its outputs are enabled by PXACK(L) low, and are latched into U4061, along with PBPRN(L), INTA(L), XACK(L), BUSY(L), by the timing signal TA(H).

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Miscellaneous Deskew and Buffer

The miscellaneous deskew and buffer function block latches and buffers QB(L), QC(L), and QD(L) from the phase B counter, to simulate various Multibus signals.

XACK(L), BUSY(L) and INTA(L) Generator

PXACK(L) is simply TA(H) divided by two. On every second cycle that PBUSY(L) is asserted, one cycle of PXACK(L) is deleted to form XACK(L), and one cycle of BUSY(L) is generated in its place.

On alternate cycles of PBUSY(H), PINTA(H) is generated to form INTA(L). BUSY(L) and XACK(L) are generated using flip-flop U3075A. When PINTA(H) is low and PBUSY(H) goes high, a low signal is clocked into the flip-flop by timing signal TB(H). The flip-flop Q(H) output goes low, disabling the command decoder, and the Q(L) output goes high, inhibiting U2071A and XACK(L) for one cycle. The signal BUSY(L) is enabled by the low on pin 10 of U3071C.

On cycles where there is no coincidence of PINTA(L) and PBUSY(H), a l is loaded into flip-flop U3075A. This enables the command decoder, allows the BUSY(L) line to remain low, and allows the XACK(L) line to be a function of PXACK(L). Figure 4-9 shows timing relationships of the pertinent signals.

хаск(L)	
РВUSY(H)	
BUSY(L)	
PINTA(H)	
	4288-

Figure 4-9. XACK(L), BUSY(L), and INTA(L) generator timing relationships.

Theory of Operation - PM 112

XACK(L) 0123456789ABCDEF0123456789ABCDEF0123456789ABCD
BUSY(L) I
INTA(L)
ADDR(L) A \$ 5 \$ A
DATA(L) A T 5 TA 5 A 5 A 5 A 5 A 5 A 5 A 5 A 5
BPRN(L)
CBRQ(L),
INH2(L)
BHEN(L), ACLO(H)
LOCK(L),
INTRO(L)
INTR1(L)
INTR2(L)
INTR3(L)
INTR4(L)
INTR5(L)
INTR6(L)
INTR7(L) 4288-36

Figure 4-10. Timing relationships of self-test generator outputs.

MULTIBUS PL EXTENDER $\langle 4 \rangle$

The PM 112 can serve as an extender board in a Multibus SUT. It will function normally while providing all Multibus Pl (PM 112 P4039) signals to an SUT board at connector socket J1030. Multibus P2 (PM 112 P4079) signals are not extended. Cl010, Cl012, Cl051, and Cl057 are decoupling capacitors, used to reduce noise on the extender power traces.

logic analyzer plug $\langle 5 \rangle$

The plug board is connected to the PM 112's 64-conductor ribbon cable at J1010, and outputs to the logic analyzer at P7020. It serves to connect the PM 112's signals from the 64-conductor ribbon cable to the 7D02, which uses a different pin numbering system.

Section 5 - PM 112

PERFORMANCE CHECKS

OVERVIEW

The procedures which follow are methods for checking operation and performance requirements of the PM 112 Personality Module. These procedures should be performed in sequence. It is assumed that the 7D02 Logic Analyzer has already passed its performance check, as detailed in the 7D02 Service Manual.

The Diagnostic Monitor portion of this section uses the 7D02 Logic Analyzer's Diagnostic Monitor to test the PM 112 Personality Module, and to test the PM 112/7D02 Timing Option circuitry (for 7D02s that are so equipped).

The Extended Diagnostics portion of this section is composed of: the Acquisition vs.Self-Test Check, used for determining whether self-test or acquisition circuitry is responsible for Diagnostic Monitor failure (requires the Optional Test Equipment listed in Table 5-1); Self-Test Acquisition check; the Word Recognizer Control Line Check; and the Clock Qualification Check.

Use the Performance Requirements Tests to verify the PM 112's Performance Requirements (listed in the Specifications section of the manual).

If the personality module is suspected of being faulty, complete the Diagnostic Monitor, all Extended Diagnostics (for which equipment is available), and the Performance Requirements Tests. Error numbers are provided for test failures; these numbers refer to symptoms and procedures in the Troubleshooting Error List, which is located in the Maintenance and Troubleshooting section.

EQUIPMENT LIST

Table 5-1 lists both required and optional test equipment. The optional test equipment is used only for the Acquisition vs. Self-Test Check (in the Extended Diagnostics portion of this section). Refer to the documentation supporting the test equipment for detailed operating instructions.

Performance Checks - PM 112

	ŗ	Fable	e 5-1	
TEST	EQUIPMENT	FOR	PERFORMANCE	CHECKS

Required Equipment			
DESCRIPTION	ITEM (with Tektronix part number)		
Logic Analyzer	Tektronix 7D02 Logic Analyzer with Option 03 (Expansion Option); Option 01 (Timing Option) - needed for Perf. Req. Test 5 & Diag. Mod. B		
Mainframe	Tektronix 7603 Oscilloscope; 100 MHz (or equivalent 7000 Series mainframe)		
Timing Option Probe (T.Oequipped 7D02s only)	Tektronix P6451 Data Acquisition Probe (010-6451-03)		
Test Oscilloscope	Tektronix 465B Oscilloscope; 100 MHz (or equivalent 100 MHz oscilloscope)		
Oscilloscope Probes (2 required)	Tektronix P6105; 100 MHz (010-6105-01)		
TM 500 Mainframe	Tektronix TM 503 (or larger) Mainframe		
Pulse Generator	Tektronix PG 502 Pulse Generator		
Pulse Generator	Tektronix PG 508 Pulse Generator		
Frequency Counter	Tektronix DC 504 Counter/Timer (or equivalent 50 MHz counter)		
Coaxial Cable (10 in.)	50 ohm Coaxial Cable (012-0208-00)		
BNC-to-Dual-Lead Adapters (2 required)	BNC Female to EZ Ball (013-0076-01)		
BNC Male to BNC Male Adapters (2 required)	Adapter (103-0029-00)		
40 cm Lead Set	10 Wires with Pomona Grabbers (012-0670-00)		
Connector Socket	86-pin Edge Connector (131-2848-00)		
Square Pin Row (T.Oequipped 7D02s only)	Square Pin Row (131-1614-00)		

Performance Checks - PM 112

Table 5-1 (cont.)

TEST EQUIPMENT FOR PERFORMANCE CHECKS

Optional Equipment

DESCRIPTION	ITEM (with Tektronix part number) PM 112 Personality Module	
Test PM 112		
2nd Logic Analyzer	Tektronix 7D02 Logic Analyzer with Option 03 (Expansion Option)	
2nd Mainframe	Tektronix 7603 Oscilloscope (or equivalent 7000 Series mainframe)	
Harmonica Cable (T.Oequipped 7D02s only)	Cable Set (012-0800-00)	

PRELIMINARY SETUP

CAUTION

Always turn off the mainframe power before connecting or disconnecting the personality module to avoid damage to any of the instruments.

- 1. Turn off the logic analyzer's mainframe power.
- Insert the PM 112's logic analyzer cable plug into the 7D02's front panel receptacle. (The PM 112 should not be plugged into a Multibus cardcage.)
- 3. Move the strap on jumper W3085 (located near the ribbon cable and on the edge of the board) to the TEST position.
- 4. Move all straps on jumpers W2011-0 through W2011-7, W3011, W3015, and W4075 to their default positions (indicated by tick marks on the leftmost pairs of pins).
- 5. (Timing Option-equipped 7D02s only.) Using Table 5-2, connect the P6451 Timing Option Probe to the row of pins (TP1021) labeled TIMING OPT. STIMULUS, located in the extender socket corner of the PM 112.

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NOTE

If you use the optional harmonica cable with the P6451 Timing Option Probe, the wires from the P6451 should be connected to the harmonica cable with square pins of the proper size. You can then use the harmonica cable as a convenient method of connection to the timing option pins at TP1021.

COLOR CODE	WIRE #	TP1021 PIN
White	GND	l, GND
Black	0 (lsb)	2, CH0
Brown	1	3, CH1
Red	2	4, CH2
Orange	3	5, CH3
Yellow	4	6, CH4
Green	5	7, CH5
Blue	6	8, CH6
Violet	7 (msb)	9, СН7

	Ta	able 5-2	2
P6451	TIMING	OPTION	CONNECTION

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DIAGNOSTIC MONITOR

OVERVIEW

The following subsection describes procedures needed to perform the 7D02 Diagnostic Module tests for the personality module and Timing Option. The tests confirm the 7D02's ability to do the following:

- Read and recognize pre-programmed word recognizers.
- Compare the data in the personality module EPROM to the logic information in the 7D02.
- Fill the acquisition memory upon recognition of the appropriate word recognizers. (This requires the PM 112 to properly generate and acquire its self-test stimulus.)
- Compare acquisition memory checksums to checksums stored in the personality module EPROM. (This also requires proper generation and acquisition of the self-test stimulus.)
- Display error codes.

For detailed explanation of these tests and their failure codes, refer to the Diagnostic Module 9 and Diagnostic Module B subsections of this manual's Maintenance and Troubleshooting section, and to the 7D02 Service Manual.

NOTE

Diagnostic Module tests 0, 9, and B will pass only if the PM 112 is configured in the self-test mode (described in Preliminary Setup). When you select one of these tests from the Diagnostic Monitor Menu, the reminder message PLEASE CONNECT SELF-TEST STIMULUS will appear whether or not the PM 112 is already configured in self-test mode.

DIAGNOSTIC MODULE 9 (PER. MOD.-SYSTEM)

To run the subtests of diagnostic module 9, use the following procedure:

 Turn on the mainframe power and press any 7D02 front panel key (except X or START) within two seconds. Keep the key depressed for at least five seconds to simulate a keyboard failure. Simulating a keyboard failure allows entry into the DIAGNOSTIC MONITOR. Performance Checks - PM 112

- 2. Press the X key to bring the DIAGNOSTIC MONITOR menu to the screen.
- Press the 9 key to test the PER. MOD.- SYSTEM (personality module system).
- 4. Press the E key to select ENABLE LOOPING.
- 5. Press the START/STOP key to run Test 1.
- 6. A number such as 1566-XX (the part number of the personality EPROM), is associated with Test 1 and is normal.
- 7. Wait at least 5 seconds and press the START/STOP key to run the next test.
- 8. Repeat part 7 until all of the tests have been completed.
- 9. A number associated with any test other than Test 1 is a failure. A number associated with any PASS message indicates a transient failure. A number associated with a FAIL message indicates a solid failure. Write down all numbers associated with any PASS or FAIL messages. If any failures are noted, refer to Troubleshooting Error List, Error 1, and Diagnostic Module 9 (PER. MOD.-SYSTEM) in the Maintenance and Troubleshooting section of this manual.
- Press the START/STOP key, then the X key to return to the menu.

DIAGNOSTIC MODULE B (TIMING OPTION) (Timing Option-equipped 7D02s only)

To run the subtests of Diagnostic Module B, use the following procedure:

- If the 7D02 Diagnostic Module 9 (PER. MOD.-SYSTEM) was previously run, continue to step 2. If not, perform steps 1 and 2 of the PER. MOD.-SYSTEM test.
- 2. Press the B key to run the TIMING OPTION module.
- 3. Press the E key to ENABLE LOOPING.
- 4. Press the START/STOP key.
- 5. Wait for five seconds in between all tests. Using the START/STOP key, run the remaining two tests.
- 6. A number associated with any test is a failure. A number associated with a PASS message indicates a transient failure. A number associated with a FAIL message indicates

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a solid failure. Write down all numbers associated with any PASS or FAIL messages. If any failures are noted, refer to Diagnostic Module B (TIMING OPTION) and Troubleshooting Error List, Error 2, located in the Maintenance and Troubleshooting section of this manual.

EXTENDED DIAGNOSTICS

If no failures were noted using the DIAGNOSTIC MONITOR portion of this section, the Extended Diagnostics need not be performed.

ACQUISITION vs. SELF-TEST CHECK

This test requires the Optional Test Equipment listed in Table 5-1: a PM 112 known to be working properly, and a second 7D02 with mainframe. Provided the equipment is available, this test is highly recommended.



Figure 5-1. Testing a suspect PM 112 with a known-good PM 112.

The Acquisition vs. Self-Test Check is an efficient way to determine whether the PM 112 under test fails DIAGNOSTIC MONITOR tests because its acquisition circuitry is faulty, or because the self-test circuitry itself is faulty. This determination is made by 1) using a known-good PM 112 to supply the self-test stimulus

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and observing whether this is correctly acquired by the PM 112under-test, and 2) using the known-good PM 112 to acquire the PM 112-under-test's self-test stimulus.

Preliminary Equipment Setup

- 1. Turn off power to both 7D02s.
- Plug the known-good PM 112 into the extra 7D02. (Both PM 112s will remain unplugged from a Multibus backplane).
- 3. Move jumper W3085 on the known-good PM 112 to the TEST position.
- 4. Move jumper W3085 on the PM 112 under test to the NORM position.
- 5. On both PM 112s, move jumpers W2011-0 through -7, W3011, W3015, and W4075 to their default positions (indicated by tick marks).
- 6. Plug P4039 of the PM 112 under test into J1030 (the Multibus extender socket) of the good PM 112, as shown in Figure 5-1.
- 7. Power up both 7D02s.

Acquisition Check

- Run the Self-Test Acquisition Check (located after the Self-Test vs. Acquisition Check) on the PM 112 under test using the equipment setup detailed above. A known-good stimulus will be generated by the other PM 112.
- 2. If any failures occur, the acquisition circuitry of the PM 112 under test is suspect. To further identify specific problems, Diagnostic Module 9 (PER. MOD.-SYSTEM) may be run on the PM 112 under test, using the same equipment setup. Note any resulting error codes, and refer to their explanations in the Maintenance and Troubleshooting section. Refer also to the Theory of Operation section and circuit diagrams.

Self-Test Check

- 1. Use the Preliminary Equipment Setup detailed previously.
- Move jumper W3085 on the known-good PM 112 to the NORM position.
- 3. Move jumper W3085 on the PM 112 under test to the TEST position.

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- 4. Run the SELF-TEST ACQUISITION CHECK (following in this section of the manual) on the good PM 112. A questionable stimulus will be generated by the PM 112 under test. Because it is acquired by a known-good PM 112, it will accurately reflect the health of the PM 112-under-test's self-test circuitry.
- 5. If any failures occur, the self-test circuitry of the PM 112 under test is suspect. To further identify specific problems, Diagnostic Module 9 (PER. MOD.-SYSTEM) may be run on the known-good PM 112, using the same equipment setup. Note any resulting error codes, and refer to their explanations in the Maintenance and Troubleshooting section. Refer also to the Theory of Operation section and circuit diagrams.

SELF-TEST ACQUISITION CHECK

The following check allows you to acquire a listing of the PM 112 self-test acquisition pattern and compare it to Figure 5-3.

Enter the program shown in Figure 5-2 into the 7D02:

- 1. Power up the 7D02.
- 2. Push the 7D02 TRIGGER button.
- 3. Use the 7D02 cursor keys and alphanumeric keypad to enter the values R/W="0", MEM/IO="1", INTA+AVAL="0", INTR="1", and IPR="7", as shown in Figure 5-2.

TEST 1
11F
1 WORD RECOGNIZER # 1
1 DATA=XX XX /BHEN=X
1 ADDRESS=XXXXX
1 R/W=0 MEM/ID=1 INTA+AVAL=0
1 INTR=1 IPR=7
1 /INH1=X /INH2=X EXT. TRIG. IN=X
1 TIMING WR=X
1THEN DO
1 TRIGGER O-MAIN
1 0-BEFORE DATA
1 0-SYSTEM UNDER TEST CONT.
1 O-STANDARD CLOCK QUAL.
END TEST 1
4288-09

Figure 5-2. 7D02 program for PM 112 self-test acquisition.
- 4. Press the 7D02 START/STOP key. The 7D02 should trigger on DATA="55 55", CMND="MWT", I="7".
- 5. Using the DATA SCROLLING keys, compare the screen display (0-255) to the display shown in Figure 5-3. The trigger location, marked by "---T", may appear on any line between 0 and 15. Wherever the trigger position occurs, the patterns starting with it should appear identical to the pattern starting with the trigger location shown in Figure 5-3. (The self-test program is a 16 line repeating pattern. The pattern will repeat 16 times in the 7D02 memory, for a total of 256 lines.)

LOC	ADDR	UDC7-0	DATA	CMND	I
T	55555		5555	MWT	7
016	AAAAA		AAAA	IOW	7
017	55555		5555	MRD	6
018	AAAAA		AAAA	IOR	6
019	55555		5555	MWT	5
020	AAAAA		AAAA	IOW	5
021	55555		5555	MRD	4
022	AAAAA		AAAA	IOR	4
023	55555	01011111	55	AVL	З
024	AAAAA	01010111	AA	IOW	з
025	55555	01111110	55	MRD	2
026	AAAAA	01111011	AA	IOR	2
027	55555	11011101	55	MWT	1
028	AAAAA	11010111	AA	IOW	1
029	55555	11111110	55	MRD	0
030	AAAAA	10101111	AA	INA	
031	55555		5555	MWT	7
				4	288-10

Figure 5-3. 7D02 display of PM 112 self-test acquisition pattern. This pattern is 16 lines long and will repeat throughout the 7D02 acquisition memory.

6. Any deviation from the pattern shown in Figure 5-3, except for the trigger LOC (location), and LOC of the lines of the pattern following it, should be considered a failure. If any failures occur, make note of the deviations and refer to Troubleshooting Error List, Error 3, in the Maintenance and Troubleshooting section of this manual.

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WORD RECOGNIZER CONTROL LINE CHECK

The following procedure verifies the correct operation of the PM 112's control lines C5-C0, which are connected to the 7D02's Word Recognizers.

- 1. Turn the 7D02 off for five seconds, then on again, to delete any previous programs.
- 2. Press the 7D02 TRIGGER key.
- 3. Using the CURSOR and NUMERIC ENTRY keys, change the R/W field to "1", the MEM/IO field to "1", and the INTA+AVAL field to "0", as shown in Figure 5-4.



Figure 5-4. 7D02 program for PM 112 Control Line Check.

- 4. Run the program by pressing the 7D02 START/STOP key.
- 5. The program should trigger on a Memory Read, indicated by "MRD" in the CMND column. (The trigger LOC, indicated by "---T", may occur anywhere from 0 to 15, and the UDC, DATA, and I fields may vary.)
- If the 7D02 does not trigger on a "MRD" cycle, refer to Troubleshooting Error List, Error 4, in the Maintenance and Troubleshooting section of this manual.
- 7. Using the CURSOR and NUMERIC ENTRY keys, change the R/W field to "0".
- 8. Run the program by pressing the 7D02 START/STOP key.

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- 9. The program should trigger on a Memory Write ("MWT"). (The trigger LOC and the UDC, DATA, and I fields may vary.)
- 10. If the program does not trigger on a Memory Write, refer to Troubleshooting Error List, Error 4, in the Maintenance and Troubleshooting section of this manual.
- 11. Using Table 5-4, repeat the previous procedure to test for "IOR", "IOW", "INA", and "AVL" type CMND cycles. If the 7D02 does not trigger on the intended CMND cycle type, refer to Troubleshooting Error List, Error 4, in the Maintenance and Troubleshooting section of this manual.
- 12. Using the CURSOR and NUMERIC ENTRY keys, return the R/W, MEM/IO, and INTA+AVAL fields to "X" (don't care).
- 13. Change the /BHEN field to "1".
- 14. Run the program by pressing the 7D02 START/STOP key.
- 15. The program should trigger on an 8-bit DATA transfer, accompanied by a display of eight bits under the UDC column.
- 16. If the 7D02 triggers on a cycle showing 16 bits of data, refer to Troubleshooting Error List, Error 5, in the Troubleshooting and Maintenance section of this manual.
- 17. Using the CURSOR and NUMERIC ENTRY keys, change the /BHEN field to "0".
- 18. Run the program by pressing the 7D02 START/STOP key.
- 19. The 7D02 should trigger on a cycle with a 16-bit DATA transfer. The UDC field on this cycle should be blank.
- 20. If the 7D02 triggers on an 8-bit cycle, refer to Troubleshooting Error List, Error 5, in the Maintenance and Troubleshooting section of this manual.
- 21. Using the CURSOR and NUMERIC ENTRY keys, place a "1" in the /BHEN field, and a "0" in the /INH1 field.
- 22. Run the program by pressing the 7D02 START/STOP key.
- 23. The program should trigger on a cycle with UDC7 (the leftmost bit in the UDC field) equal to "0". (The default signal carried on UDC7 is INH1(L).)
- 24. If the 7D02 does not trigger with UDC7="0", refer to Troubleshooting Error List, Error 6, in the Maintenance and Troubleshooting section of this manual.

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- 25. Leaving /BHEN="l", place a "l" in the /INHl field.
- 26. Run the program.
- 27. The 7D02 should now trigger on a cycle where UDC7="1".
- 28. If the 7D02 does not trigger with UDC7="1", refer to Troubleshooting Error List, Error 6, in the Maintenance and Troubleshooting section of this manual.
- 29. Return the /INHl field to "X" and place a "0" in the /INH2 field. Leave /BHEN="1".
- 30. Run the program.
- 31. The 7D02 should trigger with UDC5 (the third bit from left in the UDC field) equal to "0". (The default signal carried on UDC5 is INH2(L).)
- 32. If UDC5 does not equal "0", refer to Troubleshooting Error List, Error 7, in the Maintenance and Troubleshooting section of this manual.
- 33. Leaving /BHEN="1", place a "1" in the /INH2 field.
- 34. Run the program.
- 35. The 7D02 should now trigger on a cycle with UDC5="1".
- 36. If UDC5 does not equal "1", refer to Troubleshooting Error List, Error 7, in the Troubleshooting and Maintenance section of the manual.

CLOCK QUALIFICATION CHECK

The following procedure verifies correct operation for the PM 112's clock qualifier lines, C9 through C4.

- 1. Move the strap on W3011 to the "8" position.
- 2. Turn the 7D02 power off for five seconds, then on again, to remove any previous programs.
- 3. Press the 7D02 TRIGGER key.
- 4. Using the CURSOR and NUMERIC ENTRY keys, enter a "1" in the STANDARD CLOCK QUAL. field to specify USER CLOCK QUAL.
- 5. Move the cursor to C9-C4 (ANDED CLOCKS)=XXXXXX. Change C9 (the leftmost bit) to "0". (C9 is connected to BUSY. When "0" is placed in the C9 field, only the cycles on which the bus is Available ("AVL" = Not Busy) are qualified.

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- 6. Run the program by pressing the 7D02 START/STOP key.
- 7. Every cycle should be an "AVL" (Not Busy) CMND cycle type.
- 8. If any other types of cycles are acquired, refer to Troubleshooting Error List, Error 8, in the Troubleshooting and Maintenance section of this manual.
- 9. Now change C9 to "1".
- 10. Run the program. There should be no "AVL" CMND cycle types.
- 11. If any "AVL" cycles are acquired, refer to Troubleshooting Error List, Error 8, in the Maintenance and Troubleshooting section of this manual.
- 12. Return the C9 bit of the C9-C4 (ANDED CLOCKS) field to "X" (don't care), and enter "0" in C8 (to right of C9).
- 13. Move the W2011-7 (UDC7) jumper strap to the "ACLO" position.
- 14. Run the program.
- 15. Every cycle acquired should show UDC7 equal to "0". If not, refer to Troubleshooting Error List, Error 9, in the Maintenance and Troubleshooting section of the manual.
- 16. Change the "0" in the C8 field to "1" and run the program.
- 17. Every cycle acquired should now show UDC7="1". If not, refer to Troubleshooting Error List, Error 9, in the Maintenance and Troubleshooting section of this manual.
- 18. Return the C8 field to "X" (don't care).
- 19. Continue the procedure for the remaining clock qualifier lines C7 through C4, using the setup and expected results summarized in Table 5-3. After testing a line, return its clock qualifier field to "X" (don't care) before proceeding to the next field.
- 20. If any of the acquired cycle types are not as expected, the Error number corresponding to the line tested is given in Table 5-3.

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Control Line	Clk. Qual. Value	Move UDC Strap	Cycle Types Expected	Error Number*
C9	0		all AVL	8
C9	1		none AVL	8
C8	0	UDC7 to ACLO	all UDC7=0	9
C8	1	11 17 11	all UDC7=1	9
C7	0		all UDC6=0	10
C7	1		all UDC6=1	10
C6	0	UDC6 to /CBRQ	all UDC0=0	11
C6	1	11 17 17	all UDC0=1	11
C5	0		all UDC5=0	12
C5	1	44 17 17	all UDC5=1	12
C4	0	UDC7 to /INH1	all UDC7=0	13
C4	1	17 11 11	all UDC7=1	13

Table 5-3 CLOCK QUALIFICATION CHECK PROCEDURE SUMMARY

*If acquired cycle types are not as expected, refer to Troubleshooting Error List in the Maintenance and Troubleshooting section of this manual.

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PM 112 PERFORMANCE REQUIREMENTS TESTS

OVERVIEW

The Performance Requirements listed in the Specification Section of this manual may be verified using the procedures which follow.

The following performance test equipment setup procedure is required for verifying the data setup time (Test 1), the data hold time (Test 2), the command setup time (Test 3), the command hold time (Test 4) and the Timing Option setup and hold times (Test 5).

Self-test clock accuracy is measured in Test 6, which has its own test equipment setup procedure.

PRELIMINARY EQUIPMENT SETUP -- TESTS 1, 2, 3, 4, and 5

- 1. Insert the PM 112 logic analyzer plug into the 7D02.
- 2. Plug the PM 112 edge connector P4039 into the mating 86-pin edge connector socket (specified in the Required Test Equipment List). Subsequent references to P4039 in this equipment setup procedure and in Tests 1 through 5 will apply to this socket. Make connections to P4039 via the socket's pins, as shown in Figure 5-5.
- 3. Plug the PG 502 and PG 508 Pulse Generators into the TM 503 mainframe with the PG 502 on the left, and the PG 508 on the right.
- 4. Set up the PG 502 control knobs and switches as follows:
 - a) Pull out the BACK TERM knob.
 - b) Set the Pulse Duration range switch to 5 ns.
 - c) Set the Variable Pulse Duration knob to approximately the 12 o'clock position.
 - d) Set the Period range switch to 0.1 us.
 - e) Set the Variable Period knob to approximately the 10 o'clock position.
 - f) Press the Complement button (in).



Figure 5-5. Initial equipment connections for Tests 1 through 5. Note that odd-numbered P4039 pins are located on the top (component) side of the board, even numbered pins on the bottom (circuit) side.

5. Set up the PG 508 control knobs and switches as follows:

a) Set the Transition Time range switch to 5 ns.

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- b) Set the Leading and Trailing knobs to the Xl position.
- c) Set the Trigger Slope button to "-" (out), the Free Run button (out), and the Mode button to Delay (in).
- d) Set the Period range switch to EXT TRIG.
- e) Set the Variable Period knob fully counter-clockwise to the CAL position.
- f) Set the Delay range switch to 10 ns.
- g) Set the Variable Delay knob fully clockwise.
- h) Set the Duration range switch to 0.1 us.
- i) Set the Variable Duration knob fully counterclockwise.
- j) Set the NORM/COMPLEMENT button to the Normal (out) position.
- k) Set the PRESET/VAR button to the VAR (out) position.
- 1) Set the TRIG/GATE LEVEL knob to approximately the two o'clock position.
- Connect the 10 inch coaxial cable from the +Trigger Out of the PG 502 to the Trig/Gate In of the PG 508. (The PG 502 will trigger the PG 508.) Refer to Figure 5-5.
- 7. Set up the oscilloscope control knobs and switches as follows:
 - a) Set the horizontal TIME/DIV to 20 ns.
 - b) Set trigger slope to minus (-).
 - c) Set the INT TRIG to CH 1.
 - d) Set both CH 1 and CH 2 vertical attenuators to 1 VOLT/DIV.
 - e) Set Vert Mode to ALT.
 - f) Set both CH 1 and CH 2 vertical input coupling switches to the GND position.
- 8. Connect EZ Ball adapter to PG 502 OUTPUT, using BNC male to male adapter.

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- 9. Connect second EZ Ball adapter to PG 508 OUTPUT, using second BNC male-to-male adapter.
- 10. Connect scope CH 1 probe to PG 502 EZ Ball adapter.
- Connect scope CH 2 probe to PG 508 EZ Ball adapter. Refer to Figure 5-5.
- 12. Power up oscilloscope.
- 13. Power up TM 503 mainframe to power the PG 502 and PG 508.
- 14. Adjust the PG 508 TRIG/GATE LEVEL knob until the green TRIG^D/GATE indicator is blinking. (The blinking indicates that the PG 508 recognizes trigger/gate impulses and is triggering on them.)
- 15. Adjust scope CH 1 and CH 2 vertical positions for zero volts at the center graticule line.
- 16. Switch the CH l input coupling to DC and adjust the PG 502 output pulses for a low level of +0.6 V and a high level of +2.0 V.
- 17. Switch the CH l input coupling switch to ground, and position the trace 1.4 divisions below the center graticule line. Return the coupling switch to DC.
- 18. Adjust the PG 502 Variable Period knob to obtain a period of 200 ns at the center graticule. Refer to Figure 5-6.
- 19. Switch the horizontal TIME/DIV to 10 ns/DIV.
- 20. Adjust the PG 502 Variable Duration knob for a 50 ns pulse width low.
- 21. Switch the scope VERT MODE to CH 2.
- 22. Switch the CH 2 input coupling to DC and adjust the PG 508 output pulses for a low level of +0.6 V and a high level of +2.0 V.
- 23. Switch the CH 2 input coupling switch to ground, and position the trace 0.6 divisions above the center graticule line. Return the coupling switch to DC.
- 24. Adjust the PG 508 Variable Duration knob for a 50 ns pulse width low, at the graticule line 2 divisions above the center line. Refer to Figure 5-6.
- 25. Switch the scope VERT MODE to ALT.

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- 26. Set INT TRIG to CH 2.
- 27. Adjust the PG 508 VARIABLE DELAY knob to align the falling edges of the two traces, as shown in Figure 5-6.
- 28. Switch the horizontal TIME/DIV back to 20 ns/DIV.
- 29. Set up the PM 112 as follows:
 - a) Move the strap on jumper W3085 to the NORM position.
 - b) Connect a jumper wire from TP1010 (GND) to J1030, pin 17 (BUSY(L)).
 - c) Connect a second jumper wire from TP 1021, pin 1 (GND) to J1030, pin 27 (BHEN(L)).
- 30. Connect the red EZ Ball hook from the PG 508 to the PM 112 P4039, pin 23 (XACK(L)). Refer to Figure 5-5.
- 31. Connect the oscilloscope CH 2 probe to P4039, pin 23 (XACK(L)).
- 32. Connect the black ground clips from the scope CH 2 and the PG 508 to P4039, pin 1 (GND).

NOTE

The preceding Preliminary Equipment Setup procedure is required for the following Performance Requirements Tests 1 through 5.

TEST 1 -- DATA (DATO(L)-DATF(L)) SETUP TIME

- Connect the red EZ Ball hook from the PG 502 to the PM 112 P4039, pin 60 (DATF(L)).
- 2. Connect the scope CH 1 probe to P4039, pin 60 (DATF(L)).
- 3. Connect the black ground clips from the scope CH l and the PG 502 to P4039, pin 85 (GND).
- Confirm that the oscilloscope waveforms are as shown in Figure 5-6.

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Figure 5-6. DATA setup time (DATA TRUE).

- 5. Turn the 7D02 power off for five seconds, then on again, to delete any previous programs.
- 6. Press the 7D02 TRIGGER key to obtain the program shown in Figure 5-7.
- 7. Enter the Format mode by pressing the 7D02 FORMAT key.
- 8. Using the CURSOR and NUMERIC ENTRY keys, change the Word Recognizer DATA field to binary radix.
- 9. Exit the Format mode by pressing the FORMAT key.



Figure 5-7. 7D02 program for DATA setup time (Test 1).

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10. Check that the Word Recognizer DATA field appears as follows:

1 DATA=XXXXXXXX XXXXXXXX

- 11. Change DATF, the far left DATA bit in the 7D02 program, to "0". All other elements should be in the "X" (don't care) state.
- 12. Run the program by pressing the START/STOP key.
- 13. The program should run without triggering, or indicating SLOW CLOCK. This will demonstrate that the 7D02 is seeing the minimum clock and data pulse widths, and is meeting the 0 ns maximum setup time.
- 14. Stop the program by pressing the 7D02 STOP key.
- 15. If any failures occur, refer to Troubleshooting Error List, Error 14, in the Maintenance and Troubleshooting section.
- 16. Change the PG 502 Complement button to the NORM position (out) and adjust the oscilloscope to bring the pulses on the screen. Verify that the pulse out of the PG 502 is 0 ns before and 50 ns after the falling edge of the XACK(L) pulse (PG 508). Refer to Figure 5-8.
- 17. Change DATF, the far left DATA bit in the 7D02 program, to "1". Press the START/STOP key.



Figure 5-8. DATA setup time (DATA FALSE).

- 18. No SLOW CLOCK message should be present on the 7D02 display, and no trigger should be received. Press the STOP key.
- 19. Repeat the test for DATE. Move the PG 502 and scope probes from pin 60 of P4039 to pin 59 (in the row of pins

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corresponding to the top of the board).

- 20. Change the leftmost bit in the DATA field of the 7D02 program to "X", and enter a "0" in the DATA bit immediately to the right of it.
- 21. After testing for "0" in the word recognizer DATE bit, test for "1" in the DATE bit. Repeat the previous procedure for the remaining data lines (referring to the circuit diagram of the extender for P4039 pin numbers), and remember that:

Word Recognizer DATA Bit	PG 502 COMPLEMENT Button	Multibus Data	
1	Normal (out)	False	
0	Complemented (in)	True	

- 22. Refer to Figure 5-8.
- 23. If any failures occur, refer to Troubleshooting Error List, Error 14, in the Maintenance and Troubleshooting section of this manual.
- 24. If you are proceeding to tests 2, 3, 4, or 5, leave all oscilloscope probes and test clips connected.

TEST 2 -- DATA (DATO(L)-DATF(L)) HOLD TIME

- Connect the red EZ Ball hook from the PG 502 to the PM 112 P4039, pin 60 (DATF(L)).
- 2. Connect the scope CH 1 probe to P4039, pin 60 (DATF(L)).
- 3. Connect the black ground clips from the scope CH l and the PG 502 to P4039, pin l (GND).
- 4. Press the PG 502 Complement button (in).
- Adjust the PG 508 Variable Delay knob so that the rising edge of DATF(L) occurs 35 ns after the falling edge of XACK(L).
- Confirm that the oscilloscope waveforms are as shown in Figure 5-9.

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Figure 5-9. DATA hold time (DATA TRUE).

- 7. Turn the 7D02 power off for five seconds, then on again, to delete any previous programs.
- 8. Press the 7D02 TRIGGER key to get the program shown in Figure 5-10.

TEST 1 1IF				
1 WORD RECOGNIZER # 1				
1 DATA=XX XX /BHEN=X				
1 ADDR=XXXXX				
1 R/W=X MEM/IO=X INTA+AVAL=X				
1 INTR=X IPR=X				
1 (TNH1=X (TNH2=X EXT. TRIG. IN=X				
1THEN DO				
1 TRIGGER O-MAIN				
O-BEFORE DATA				
O-SYSTEM UNDER TEST CONT.				
O STANDARD CLOCK GUAL				
END TEST 1				
4288-17				

Figure 5-10. 7D02 program for DATA hold time (Test 2).

- 9. Enter the Format mode by pressing the 7D02 FORMAT key.
- 10. Using the CURSOR and NUMERIC ENTRY keys, change the Word Recognizer DATA field to binary radix.

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- 11. Exit the Format mode by pressing the FORMAT key.
- 12. Check that the Word Recognizer DATA field appears as follows:

1 DATA=XXXXXXXX XXXXXXXX

- 13. Change DATF, the leftmost DATA bit in the 7D02 program, to "0". All other elements should be in the "X" (don't care) state.
- 14. Run the program by pressing the START/STOP key.
- 15. The program should run without triggering, and without indicating SLOW CLOCK. This will demonstrate that the 7D02 is seeing the minimum clock and data pulse widths, and is meeting the 35 ns maximum hold time.
- 16. Stop the program by pressing the 7D02 STOP key.
- 17. If any failures occur, refer to Troubleshooting Error List, Error 15, in the Maintenance and Troubleshooting section of this manual.
- 18. Change the PG 502 Complement button to the NORM position (out) and adjust the oscilloscope to bring the pulses on the screen. Verify that the pulse out of the PG 502 is 0 ns before and 50 ns after the falling edge of the XACK(L) pulse (PG 508). Refer to Figure 5-11.



Figure 5-11. DATA hold time (DATA FALSE).

- 19. Change DATF, the far left DATA bit in the 7D02 program, to "1". Press the START/STOP key.
- 20. No SLOW CLOCK message should be present on the 7D02 display, and no trigger should be received. Press the STOP key.
- 21. Repeat the test for DATE. Move the PG 502 and scope probes from pin 60 of P4039 to pin 59 (located on the other side of the board).
- 22. Change the leftmost bit in the DATA field of the 7D02 program to "X", and enter a "0" in the DATA bit immediately to the right of it.
- 23. After testing for "0", test for "1" in the DATE bit. Repeat the previous procedure for the remaining data lines (referring to the circuit diagram of the extender for pin numbers), and remember that:

Word Recognizer DATA Bit	PG 502 COMPLEMENT Button	Multibus Data	
1	Normal (out)	False	
0	Complemented (in)	True	

- 24. Refer to Figure 5-11.
- 25. If any failures occur, refer to Troubleshooting Error List, Error 15, in the Maintenance and Troubleshooting section of this manual.
- 26. If you are proceeding to tests 3, 4, or 5, leave all oscilloscope probes and test clips connected.
- TEST 3 -- COMMAND SETUP TIME (MRDC(L), MWTC(L), IORC(L), IOWC(L), & INTA(L))
 - Connect the red EZ Ball hook from the PG 502 to the PM 112 P4039, pin 19 (MRDC(L)).
 - 2. Connect the scope CH 1 probe to P4039, pin 19 (MRDC(L)).
 - 3. Connect the black ground clips from the scope CH l and the PG 502 to P4039, pin l (GND).
 - 4. Press the PG 502 Complement button (in).

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- 5. Adjust the PG 508 VARIABLE DELAY knob to align the falling edges of the two traces.
- 6. Confirm that the oscilloscope waveforms are as shown in Figure 5-12.



Figure 5-12. Command setup time.

- 7. Turn the 7D02 power off for five seconds, then on again, to delete any previous programs.
- Press the following 7D02 keys in sequence: NOT, WD RECOG-NIZER, [], and TRIGGER.
- 9. Using the CURSOR and NUMERIC ENTRY keys, change the R/W field to "1", the MEM/IO field to "1", and the INTA+AVAL field to "0", as shown in Figure 5-13.
- 10. Run the program by pressing the START/STOP key.
- 11. The program should run without triggering, and without the SLOW CLOCK message appearing on the display screen. This will demonstrate that the 7D02 is seeing the minimum clock pulse width, and is meeting the 0 ns maximum setup time.
- 12. Stop the program by pressing the START/STOP key.
- 13. If any failures occur, refer to Troubleshooting Error List, Error 16, in the Maintenance and Troubleshooting section of this manual.

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```
TEST 1
1 IF
1
1 INOT
1 WORD RECOGNIZER # 1
1:DATA=XX XX /BHEN=X
1 ADDR=XXXXX
1:R/W=1 MEM/IO=1
                    INTA+AVAL=0
1 INTR=X IPR=X
1:/INH1=X /INH2=X EXT. TRIG. IN=X
1 |TIMING WR=X
1 _____
1THEN DO
1 TRIGGER O-MAIN
     O-BEFORE DATA
1
1
     O-SYSTEM UNDER TEST CONT.
     O-STANDARD CLOCK QUAL.
1
END TEST 1
                               4288-20
```

Figure 5-13. 7D02 program for command setup time.

- 14. Move the red lead from the PG 502 and CH 1 scope probe to P4039, pin 20 (MWTC(L)).
- 15. Using the CURSOR and NUMERIC ENTRY keys, change the R/W field to "0".
- 16. Run the program by pressing the START/STOP key.
- 17. The program should run without triggering, and without the SLOW CLOCK message appearing, as before.
- 18. Repeat the previous procedure for IORC(L), IOWC(L), INTA(L), and BUSY(L), using the setups summarized in Table 5-4.
- 19. If any failures occur, refer to Troubleshooting Error List, Error 16, in the Maintenance and Troubleshooting section of this manual.
- 20. If you are proceeding to Tests 4 or 5, leave all oscilloscope probes and test clips connected.

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COMMAND CHECK CONNECTION SETUP SUMMARY						
CYCLE TYPE	R/W	MEM/IO	INTA+AVAL	CMND	P4039 PIN	
MRDC(L)	1	1	0	MRD	19	
MWTC(L)	0	1	0	MWT	20	
IORC(L)	1	0	0	IOR	21	
IOWC(L)	0	0	0	IOW	22	
INTA(L)	1	0	1	INA	33	
BUSY(L)	0	0	1	AVLa	17 ^b	

Table 5-4 COMMAND CHECK CONNECTION SETUP SUMMARY

^aAVL means bus Available (BUSY not asserted).

^bDisconnect the grounded jumper lead to J1030 pin 17 when testing the BUSY(L) command line. It must remain grounded for testing all the other command lines (Tests 1-5 only).

TEST 4 -- COMMAND HOLD TIME

(MRDC(L), MWTC(L), IORC(L), IOWC(L), & INTA(L))

- Connect the red EZ Ball hook from the PG 502 to the PM 112 P4039, pin 19 (MRDC(L)).
- 2. Connect the scope CH 1 probe to P4039, pin 19 (MRDC(L)).
- 3. Connect the black ground clips from the scope CH l and the PG 502 to P4039, pin l (GND).
- 4. Press the PG 502 Complement button (in).
- Adjust the PG 508 VARIABLE DELAY knob so that the rising edge of MRDC(L) occurs 35 ns after the falling edge of XACK(L).
- Confirm that the oscilloscope waveforms are as shown in Figure 5-14.

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Figure 5-14. Command hold time.

- 7. Turn power to the 7D02 off for five seconds, then on again, to delete any previous programs.
- Press the following 7D02 keys in sequence: NOT, WD RECOG-NIZER, [], and TRIGGER.
- 9. Using the CURSOR and NUMERIC ENTRY keys, change the R/W field to "1", the MEM/IO field to "1", and the INTA+AVAL field to "0", as shown in Figure 5-15.

TEST 1 1IF 1 -1 INOT 1 WORD RECOGNIZER # 1 1 DATA=XX XX /BHEN=X 1 ADDR=XXXXX 1 | R/W=1 MEM/IO=1 INTA+AVAL=0 1 INTR=X IPR=X 1:/INH1=X /INH2=X EXT. TRIG. IN=X 1 |TIMING WR=X 1 _____ **1THEN DO** 1 TRIGGER O-MAIN 1 O-BEFORE DATA 1 O-SYSTEM UNDER TEST CONT. 1 O-STANDARD CLOCK QUAL. END TEST 1 4288-22

Figure 5-15. 7D02 program for command hold time (Test 4).

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- 10. Run the program by pressing the START/STOP key.
- 11. The program should run without triggering, and without the SLOW CLOCK message appearing on the display screen. This will demonstrate that the 7D02 is seeing the minimum clock pulse width, and is meeting the 35 ns maximum hold time.
- 12. Stop the program by pressing the START/STOP key.
- If any failures occur, refer to Troubleshooting Error List, Error 17, in the Maintenance and Troubleshooting section of this manual.
- 14. Move the red lead from the PG 502 and CH 1 scope probe to P4039, pin 20 (MWTC(L)).
- 15. Using the CURSOR and NUMERIC ENTRY keys, change the R/W field to "0".
- 16. Run the program by pressing the START/STOP key.
- 17. The program should run without triggering,, and without the SLOW CLOCK message appearing, as before.
- 18. Repeat the previous procedure for IORC(L), IOWC(L), INTA(L), and BUSY(L), using Table 5-4.
- 19. If any failures occur, refer to Troubleshooting Error List, Error 17, in the Maintenance and Troubleshooting section of this manual.
- 20. Unless proceeding to Test 5, disconnect all oscilloscope probes and test clips from the PG 502 and the PG 508.

TEST 5 -- TIMING OPTION SETUP AND HOLD TIMES

(For Timing Option-equipped 7D02s only.) The following test confirms the ability of the Timing Option to meet the specified performance requirements for Timing Option setup and hold times, while operating synchronously with a clock derived by the PM 112 from XACK(L).

- Plug the P6451 Timing Option Probe into the 7D02 front panel.
- 2. Connect the colored leads from the P6451 to the square pin row, in the sequence listed in Table 5-2.
- 3. Connect the red EZ ball hook from the PG 502 to the P6451 violet lead (bit 7), via the square pin row.

- 4. Connect the scope CH l probe to the P6451 violet lead in the same manner.
- 5. Connect the black ground clips from the scope CH l and the PG 502 to the P6451 white lead (GND), via the square pin row.
- 6. Set the PG 502 Complement button to NORM (out).
- 7. Adjust the PG 502 Variable Duration knob for a 45 ns pulse width high.
- Adjust the PG 508 Variable Delay knob to align the falling edge of the data pulse from the PG 502 with the rising edge of the XACK(L) pulse from the PG 508. Refer to Figure 5-16.



Figure 5-16. Timing Option Data (TRUE) setup and hold time.

- 9. Turn the 7D02 power off for five seconds, then on again, to delete any previous programs.
- 10. Press the 7D02 TRIGGER key.
- 11. Using the CURSOR keys, move the cursor to the TIMING WR box and enter a "1".
- 12. Move the cursor to the ASYNC box and enter a "0" to specify SYNC.
- 13. Move the cursor to the msb bit of the timing WORD RECOGNIZER field (far left box), and enter a "0". The program is now set to recognize and trigger if the requirements of the Word Recognizer and the Trigger sections are met.

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- 14. Run the program by pressing the 7D02 START/STOP key.
- 15. The program should run without triggering, and without indicating SLOW CLOCK. This will demonstrate that the 7D02 is seeing the minimum clock pulse width, and is meeting the -5 ns setup and 50 ns hold time requirements.
- 16. Stop the program by pressing the 7D02 STOP key.
- 17. If any failures occur refer to the Troubleshooting Error List, Error 18, in the Maintenance and Troubleshooting section of this manual.
- 18. Press the PG 502 COMPLEMENT button (in). Verify that the data pulse out of the PG 502 starts 5 ns after the falling edge of XACK(L) (from the PG 508), and ends 50 ns after the falling edge of XACK(L). Refer to Figure 5-17.



Figure 5-17. Timing Option Data (FALSE) setup and hold time.

- 19. Change the msb bit in the WORD RECOGNIZER field to "1". Press the START/STOP key.
- 20. Again, there should be no trigger and no SLOW CLOCK message.
- 21. Stop the 7D02 program.
- 22. Repeat the test for the next bit to the right of the msb. Move the PG 502 output and CH 1 scope probe from the violet wire to the blue wire.
- 23. Change the 7D02 program. Return the leftmost (msb) bit of the timing option word recognizer to "X", and change the next bit right to "0". Press the START/STOP key.

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- 24. Again, there should be no trigger and no SLOW CLOCK message.
- 25. Stop the 7D02 program.
- 26. After testing for "0" in the timing option word recognizer bit 6, repeat steps 17-20 of the previous procedure for a "1" in DATA bit 6.
- 27. Repeat steps 13 through 26 of this procedure to test the remaining timing option data lines 5 through 0. Use Table 5-2 and the following guide:

Timing Word Recognizer	PG 502 COMPLEMENT Button	Timing Option Data	
0	Normal (out)	True	
1	Complemented (in)	False	

- 28. Refer to Figures 5-16 and 5-17.
- 29. If any failures occur, refer to Troubleshooting Error List, Error 18, in the Maintenance and Troubleshooting section of this manual.
- 30. Switch off power to the 7D02 and test equipment. Disconnect all equipment and jumper leads.

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TEST 6 -- SELF-TEST CLOCK FREQUENCY ACCURACY

This test checks the ability of the self-test clock circuitry to operate within the 20 MHz \pm 5% frequency accuracy specification. It uses its own test equipment setup procedure.

If you use a frequency counter other than the DC 504, modify the following procedure to suit the requirements of the actual frequency counter used.

- 1. Insert the PM 112 logic analyzer plug into the 7D02.
- Plug the DC 504 Counter/Timer into the TM 503 mainframe. Unplug unused pulse generators as required to make room.
- 3. Set the DC 504 FUNCTION switch to Frequency, 1 kHz Resolution. Set the SOURCE switch to EXT.
- 4. Connect an oscilloscope probe to the INPUT of the DC 504.
- 5. Power up the TM 503 mainframe to power the DC 504.
- 6. Move the strap on jumper W3085 on the PM 112 to the NORM position.
- 7. Remove the strap on W4075.
- 8. Connect the probe tip from the DC 504 to W4075, pin 1.
- 9. Connect the ground clip from the frequency counter probe to TP4085 (GND).
- 10. Turn on the 7D02 power.
- 11. Adjust the DC 504 TRIGGER LEVEL knob for a stable reading.
- Confirm that the DC 504 indicates a frequency of between 19 MHz and 21 MHz.
- 13. If the frequency is not within this range, refer to Troubleshooting Error List, Error 19, in the Maintenance and Troubleshooting section of this manual.
- 14. Replace the strap on W4075 in the INT position.
- 15. Turn off and disconnect all test equipment.

Section 6 - PM 112

MAINTENANCE AND TROUBLESHOOTING

MAINTENANCE

REPAIR

The PM 112 requires no periodic maintenance. Properly handled and cared for, your personality module will give dependable service for many years. However, should repair service be needed at any time, Tektronix provides complete instrument repair at local Field Service Centers and at the Factory Service Center. Contact your local Tektronix Field Office or representative for further information.

OBTAINING REPLACEMENT PARTS

Most electrical and mechanical parts can be ordered through your local Tektronix Field Office or representative. Many of the standard electronic components may also be available from a local source in your area. However, before you purchase or order a part from a source other than Tektronix, Inc., please check the Replaceable Electrical List and the Replaceable Mechanical Parts List for the proper value, rating, tolerance, and description.

ORDERING PARTS

When ordering replacement parts from Tektronix, it is important that all of the following information be included to ensure receiving the proper parts.

- 1. Instrument type (include modification or option numbers).
- 2. Instrument serial number (located on a stamped plastic tag, affixed to the PM 112 circuit board).
- 3. A description of the part (if electrical, include component number from the Replaceable Electrical Parts List).
- 4. The Tektronix part number.
- 5. The quantity of each part desired.

CLEANING INSTRUCTIONS

This instrument should be cleaned as often as the operating environment requires. Accumulation of dirt on components acts as an insulating blanket and prevents efficient heat dissipation. This condition can cause overheating and component breakdown.

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Use a jet of dry, low pressure air and a soft brush to remove dust from the circuit board. After soldering or when otherwise required, use isopropyl alcohol with a soft cloth or cotton swab to remove flux, resin, and dirt. As the board is cleaned, make certain that the square pins are not contaminated with residual flux, to prevent impairing electrical contact.

REMOVAL OF INSULATING SHIELD

To access the underside of the circuit board you must remove the personality module insulating shield. If it becomes necessary to do so, as when troubleshooting or soldering, find a clean open space on a table and be sure that screws and other small parts are placed where they will not be lost.



Always turn off the mainframe power before connecting or disconnecting any personality module. Observe static precautions at all times when disassembling or repairing the PM 112.

To remove the insulating shield:

- 1. Remove the screw, nut, and lock washer in each corner of the circuit board. Store them in a safe place.
- 2. Remove and store the insulating shield and its spacers.
- 3. Reverse the above procedure for reassembly.

LOGIC ANALYER PLUG DISASSEMBLY

To disassemble the logic analyzer plug:

- Remove the four screws holding the logic analyzer plug together with a 3/32" Allen wrench.
- 2. Pull the halves of the plug apart and remove the cable hold-down clamp.
- 3. Remove the circuit board by lifting up on the cable end and sliding the board out of the plastic hold-down flanges.
- 4. Reverse the above procedure to reassemble the logic analyzer plug.

6-2

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TROUBLESHOOTING

OVERVIEW

Several methods are available to the service technician for localizing and identifying a faulty circuit in the PM 112. Nearly all PM 112 failure modes can be detected by the 7D02 Diagnostic Module 9 (PER. MOD. - SYSTEM). They can be identified by Module 9 Subtest error codes, and by the Self-Test Acquisition Check.

Subtest 7 error codes have directly corresponding numbers and procedures in the Troubleshooting Error List.

Because the PM 112's circuitry is approximately 55% self-test and only 45% acquisition, it cannot be assumed that a diagnostics failure is due to faulty acquisition circuitry. The Acquisition vs. Self-Test Check, detailed in the Performance Checks section, is an efficient way to determine which portion of the PM 112's circuitry is at fault. To perform this test, you must have access to the optional equipment listed in Table 5-1: a known-good PM 112 and a second 7D02 Logic Analyzer with mainframe.

The Self-Test Acquisition Check, also located in the Performance Checks section, will detect improperly encoded command and interrupt priority lines, and will reveal stuck address and data lines. By selecting binary radix (using Format mode) for display of the faulty address or data fields, you can observe each bit in the field (and its corresponding line) individually.

Locate faulty components using the Troubleshooting Error List and/or Circuit Diagrams and Illustrations. Replace suspected components and run the Diagnostic Monitor (located in the Performance Checks section), to confirm that the PM 112 is now functioning properly.

Should problems remain with the PM 112, refer to the word recognizer Control Line Check and the Clock Qualification Check located in the Performance Checks section. These checks are in the Extended Diagnostics subsection, and are complete with references to error numbers and procedures in the Troubleshooting Error List.

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SUBSTITUTION METHOD

If another 7D02 Logic Analyzer and/or PM 100 Series Personality Module is available, try substituting and running the diagnostics again. In this way you can immediately determine whether the PM 112 or the 7D02 being used is at fault.



A 7D02 power supply that is seriously out of tolerance could damage a personality module. If you suspect power supply problems, check the 7D02 before connecting a personality module.

DIAGNOSTIC MONITOR

Power-up diagnostic routines are built in and automatically run each time the 7D02 Logic Analyzer/PM 112 Personality Module system is powered on. If a failure is detected, the 7D02 will display the POWER-UP VERIFICATION test results. This display offers you the choice between beginning normal operation (by pressing the START key) or displaying the DIAGNOSTIC MONITOR MENU (by pressing the X key).

Diagnostic Module subtests 0 (TEST ALL), 9 (PER.MOD.-SYSTEM), and B (TIMNG OPTION) will pass only if the PM 112 is configured in the self-test mode. Self-test configuration is described in the Preliminary Setup procedure located in the Performance Checks section. Following the Preliminary Setup you will find procedures for running Diagnostic Modules 9 (PER. MOD.-SYSTEM) and B (TIMING OPTION).

Refer to Diagnostic Module 9 and Diagnostic Module B in this section of the manual for explanation of Diagnostic Module subtests and their failure codes. Refer to the 7D02 Service manual for additional diagnostics information.

Diagnostic Module 9 (PER. MOD.-SYSTEM)

Diagnostic Module 9 contains 7 subtests. Subtests 1, 2, 3, 4, and 7 are personality module specific, and are discussed in the following subsection. Subtests 5 and 6 are the same for all personality modules; refer to the 7D02 Service Manual for more information.

Subtests 1, 2, 3, 4, and 7 require that the PM 112 be configured in the self-test mode. Refer to the Preliminary Setup in the Performance Checks section for connection instructions, and to the procedure following it for test instructions.

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Subtest 1. This test reads a byte at address 3:E010 in the personality module EPROM to determine the EPROM length. This indicates the location (E7FC) of the EPROM trailer. The value at E7FC is compared to the value in the next byte, E7FD, which should be its complement. If the two bytes are not complementary, a failure message is displayed as follows:

1 FAIL 3E7FD-X (indicating incorrect value @ 3:E010)

where X is the first non-complementary bit after the two bytes are compared on a bit-by-bit basis.

If the part number is correct, the following message is displayed:

1 PASS 1566-00

Subtest 2. This test calculates a 16-bit checksum on the EPROM. If the checksum does not match the expected value, the calculated value is reported as the following failure message:

2 FAIL XXXX

where XXXX = the calculated value.

Subtest 3. This test assigns the following program to the 7D02 State Machine:

IF WR1 TRUE THEN TRIGGER TIMING AND MAIN

The 7D02 Acquisition Memory board is set for zero delay. All clock qualifiers are disabled, and the state clock is defined as the falling edge of the PM 112 CLK signal by data stored in the personality module EPROM. After all setups are complete, a DISPLAY command is sent and the 7D02 slow clock detector is checked. A slow clock results in the following failure message:

3 FAIL 0FF60-1 (indicating slow or no clock)

This can be caused by an erratic or missing clock signal from the personality module. Anything that generates or transfers the test clock to the 7D02 should be checked.

If the clock appears to be running, the 7D02 reads the personality module EPROM to determine how long to wait for a trigger to occur. Then a STORE command is sent. After waiting the specified amount of time (2 ms), the activity monitor on the Acquisition Memory board is examined to see if the Main Section has triggered

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and returned to DISPLAY mode. If the Main Section is still in STORE mode, the following failure message is generated:

3 FAIL 2E803-7

(indicating Main Section failed to trigger)

Failure to trigger can be caused by failure of the personality module to generate and/or acquire the word recognizer 1 (WR1) value (refer to Table 6-1).

PROGRAMMED WORD RECOGNIZER VALUES					
		WR 1	WR 2	WR 3	WR 4
DATA*	-	АААА	7E55	AFAA	5555
ADDRESS*		ААААА	55555	ААААА	55555
INTR* (A2	23)	1	1	0	1
IPR (A22-A2	20)	101	010	111	100
/INH2 (C	:5)	0	1	1	1
/INH1 (C	:4)	1	0	1	1
/BHEN (C	:3)	0	1	1	0
INTA+AVAL (C	2)	0	0	1	0
MEM/IO (C	:1)	0	1	0	1
R/W (C	:0)	0	1	1	1
Cycle Type		I/O Write	Mem. Read	Int. Ack.	Mem. Read

Table 6-1 PROGRAMMED WORD RECOGNIZER VALUES

*The word recognizer values specified for the DATA, ADDRESS, and INTR fields are inverted before being supplied to the diagnostics (they are actually active low in the the hardware, inverted by firmware in displays).

Subtest 4. This test involves all four of the 7D02 word recognizers, the two 7D02 Counters, the 7D02 State Machine, and the 7D02 Acquisition Memory.

Subtest 4 programs the 7D02 word recognizers in the same way as described for Subtest 3 (refer to Table 6-1). Also, the test in effect programs the 7D02 State Machine as follows:

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lif wrl then [GO TO 2, RESET CTR 1 AND 2]

2IF WR2 THEN [INCR CTR 1, GO TO 3] 2 ELSE INC. CTR 1

3IF WR3 THEN [INCR CTR 2, GO TO 4] 3 ELSE INC. CTR 2

4IF WR4 THEN TRIGGER MAIN

All cycles are qualified except the trigger; therefore all cycles are stored except the trigger cycle. The clock qualifiers are the same as for subtest 3 in that all clock qualifiers are disabled, and the state clock is defined as the falling edge of the PM 112 CLK signal.

After all steps are complete, a DISPLAY command is sent and the slow clock detector is checked. A slow clock indication results in the following failure message:

4 FAIL 0FF60-1 (indicating slow or no clock)

This can be caused by an erratic or missing personality module clock. Anything in the personality module that generates or transfers the test clock should be checked.

If the clock appears to be running, the personality module EPROM is read to determine how long to wait for a trigger. Then, a STORE command is sent. After waiting 2 ms, the activity monitor on the 7D02 Acquisition Memory board is examined to see if the Main Section has triggered and returned to DISPLAY mode. If it is still in the STORE mode, the following failure message is generated:

4 FAIL 2E803-7

(indicating Main Section failed to trigger)

Failure to trigger can be caused by failure of the personality module to generate and/or acquire any one of the four word recognizer values.

The next part of the test is a check of the counters. This verifies that the personality module's clock and self-test generator are working properly. First the msb (most significant bit) of Counter 1 is read and compared with the expected value stored in the personality EPROM. If it matches, the 1sb (least significant bit) is compared. Then Counter 2 is checked in the same way. If any byte fails to match exactly, the appropriate error message is displayed as follows:

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4 FAIL 1E202-X (indicating CTR 1 msb bit X is wrong)

4 FAIL 1E203-X (indicating CTR 1 lsb bit X is wrong)

4 FAIL 1E302-X (indicating CTR 2 msb bit X is wrong)

4 FAIL 1E303-X (indicating CTR 2 lsb bit X is wrong)

Any of these messages can be the result of a faulty clock signal or self-test generator (incorrect pattern).

The Main Acquisition Memory and Expansion Option Acquisition Memory are checked by summing all bytes between 2:E000 and 2:E3FF in the Main Acq. Memory, and all bytes between 2:E400 and 2:E7FF in the Exp. Opt. Acq. Memory. The checksums are compared with the expected values stored in the personality EPROM. Main Acq. Memory and Exp. Opt. Acq. Memory checksum failures result, respectively, in the following failure messages:

4 FAIL 3E035-X (indicating one or more dead or intermittent channels among any of the personality module's outputs except A23-A16 and D15-D8.)

4 FAIL 3E036-X (indicating one or more dead or intermittent channels among A23-A16 and D15-D8.)

Subtests 5 and 6. Subtests 5 and 6 are intended to test only the 7D02, and are described in the 7D02 Service Manual.

Subtest 7. This test checks the clock qualifier lines C9-C4 on the 7D02 front end board.

The test programs the 7D02 State Machine with the following test sequence:

1IF WR1 THEN TRIGGER MAIN 1 ELSE GO TO 1

C9-C4 are set equal to XXXXXX.

Word Recognizer 1 was programmed in an earlier subtest to a value specified by the personality module EPROM (refer to Table 6-1). This test uses each of the control lines in turn to qualify out the value to which Word Recognizer 1 has been programmed.

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If the control line works correctly, the state clock that occurs with Word recognizer 1 will be inhibited and the State Machine will not see the word recognizer output. A PASS condition, then, is indicated by the failure of the Main Section to trigger. The processor waits 2 ms to trigger.

Six bytes in the personality module EPROM specify the value to be sent to the 7D02 front end to inhibit state clocks when word recognizer 1 occurs for each of the six control lines. The following sequence is repeated six times, once for each control line or until a failure occurs:

- Read value from personality module EPROM.
- Write value to front end latch.
- Send STORE command.
- Wait specified length of time.
- Check activity monitor on Acquisition Memory board.
- If in DISPLAY mode, print FAIL and stop.

If Subtests 3 and 4 pass, it is safe to assume C9-C4 are operating correctly.

The Subtest 7 failure messages should be interpreted as follows:

7 FAIL 3E039 (C4 didn't inhibit trigger - Error 13^a)

- 7 FAIL 3E03A (C5 didn´t inhibit trigger - Error 12^a)
- 7 FAIL 3E03B (C6 didn't inhibit trigger - Error ll^a)
- 7 FAIL 3E03C (C7 didn't inhibit trigger - Error 10^a)

7 FAIL 3E03D
(C8 didn't inhibit trigger - Error 9^a)^b
7 FAIL 3E03E

(C9 didn't inhibit trigger - Error 8^a)^b

a Refer to Troubleshooting Error List in this section. These two failure codes will not be indicated appropriately when looping mode is enabled.

Subtest 8. The 7D02 does not perform Subtest 8 with the PM 112.

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Diagnostic Module B (TIMING OPTION) (Timing Option-equipped 7D02s only)

This module consists of 3 subtests. Subtests 1 and 2 are the same for every personality module. Refer to the 7D02 Service Manual for more information. Subtest 3 is personality module specific.

This test requires that the P6451 Timing Option Probe be connected in order to carry the stimulus from the self-test circuitry. Subtest 3 is not run during the POWER-UP VERIFICATION.

The timing option word recognizer is set to trigger on the occurrence of AOH.

Subtest 3. The 7D02 State Machine is in effect programmed as follows:

11F TIMING OPTION WR=A0H 1THEN GO TO 4

4IF TIMING OPTION WR=A0H 4THEN TRIGGER TIMING AND MAIN

The timing option memory address counter is set to 0. All word recognizers, except the timing option, are set to X (don't care).

The slow clock indicator is checked for the presence of a clock. If none is detected, the following failure is displayed.

3 FAIL 0FF60-1 (slow or no clock detected)

If the clock appears to be running, a byte is read from the personality module EPROM that specifies how long to wait for the trigger. Then a STORE command is sent. After waiting the specified amount of time (2 ms), the 7D02 Acquisition Memory activity monitor is examined to see if the Main Section has triggered. If it hasn't, the following failure is reported.

3 FAIL 2E803-7 (indicating Main Section failed to trigger)

This can be caused by the self-test circuitry not generating the AOH value or the P6451 not transferring data properly.

If the trigger occurred, the timing option memory address counter is examined to determine the last data location and the trigger location is calculated. The value saved in the trigger location is then compared with the value in the personality module EPROM that was used to program the timing option word recognizer. If the two are not complementary (data inverted), the following failure is reported.
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3 FAIL 3E03F-X (indicating trigger value incorrect)

where X is the first offending bit.

This can be caused by a faulty timing relationship between the clock and the data.

If the trigger test passes, the timing option acquisition memory at address 2:F000 - 2:F0FF is checksummed (with the exception of one data byte which is Xs), and the result compared with the expected value stored in the personality module EPROM. If the values are not the same, the following failure is reported.

3 FAIL 3E040-X (checksum error 2:F000 - 2:F0FF)

where X is the first bit that didn't match.

This can be caused by the PM 112 self-test circuitry not generating the correct pattern all the time, or an intermittent failure in the P6451.

JUMPER PLUGS AND TEST POINTS

The following Table 6-2 provides the signal name and number of the jumper plugs and test points located on the PM 112 circuit board.

Jumper Plug or Test Point	Board Location	Common Name
TP1010 TP1025 TP4075 TP4085 W3011 W3015 W3085	Al Al D2 D2 A2 A2 A2 D2	GND /HALT SUT EXT CLK IN GND 8 8/16 PAR SER TEST NORM (mode)
W4075	C2 B1	TEST CLK
""-2 -3 ""-4	H H	$\begin{array}{c} \text{XACK (L)}^{a} \\ \text{BREQ (L)}^{a} \\ \text{BUSY (L)}^{a} \\ \end{array}$
-5 " "-6		BPRO(L) ^a BCLK(L) ^a
TP4079-13 -17 " "-19 -20	D3 ""	PFSR(L) ^D PFSN(L) ^D PFIN(L) ^D MPBO(L) ^b
" "-27 -28 " "-29	99 97 19 97	PAR1 (L) b HALT (L) b PAR2 (L) b
-30 " "-31 -32 " "-36	11 11	WAIT(L) ^b PLC(H) ^b ALE(H) ^b
-38		AUX RESET(L) ^b
TP4079-55 -56	D3	ADR16(L) ^b ADR17(L) ^b
" "-57 -58	11 11	ADR14(L) ^D ADR15(L) ^D

Table 6-2 PM 112 JUMPER PLUGS AND TEST POINTS

^aMultibus signals from Pl (P4039) connector. ^bMultibus signals from P2 (P4079) connector.

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TROUBLESHOOTING ERROR LIST and PROCEDURES

When performance checks or troubleshooting detect a failure, reference notes will direct the service technician to a specific error number listing. This list may in turn direct the technician to a specific procedure to isolate the problem.

This error list assumes the 7D02 is known to be operating correctly, the personality module has been properly connected, and all power supplies are within their specified tolerances.

Error No.	Symptom	Possible Causes/Suggestions
1	Diagnostic Module 9 (PER. MOD SYSTEM) Fails	Run Extended Diagnostics tests (located in Performance Checks sec- tion). See Error numbers refer- enced in Extended Diagnostics. Test and repair as suggested for particular Error number. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.
2	Diagnostic Module B (TIMING OPTION) Fails	Go to Troubleshooting Procedure 2.
3	SELF-TEST ACQUISITION CHECK Fails	If possible (Optional Test Equip- ment is available), run Acquisition vs. Self-Test Check, located in Performance Checks section, to determine whether acquisition or self-test circuitry is faulty. Re- run Self-Test Acquisition Check, using the 7D02 FORMAT mode to change address and data field displays to binary radix. Lines stuck high or low are now easily identified. Consult circuit diagrams to locate corresponding parts. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.

Table 6-3 PM 112 TROUBLESHOOTING ERROR LIST

Maintenance and Troubleshooting - PM 112

		Table	6-3	(cont	z.)	
РМ	112	TROUBLE	SHOC	TING	ERROR	LIST

Error No.	Symptom	Possible Causes/Suggestions
4	Does not trigger on correct command	Command Encoder or Self-Test Com- mand Generator faulty. Check CIO- CI2 circuitry: Acquisition U4021, U2021; Self-Test U4061, U4065, U3071, U2065, U2071, U4071, U3075, U4079, Q4083, U4015, U2031. Replace suspected parts and retest. If unsuccessful, go to Troub- leshooting Procedure 1.
5	Does not trigger on 8- or 16-bit cycles when appropriate	BHEN(L) buffers or Self-Test Gen- erator faulty. Check CI3 circuitry: Acquisition U4025, U2031; Self- Test U3025, U2065, U2071, U3071, U4071, U3075, U4079, U4015, Q4083, Q4071. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.
6	Does not trigger on INH1(L) low or high when appropriate	<pre>INH1(L) buffers or Self-Test Gen- erator faulty. Check CI4 circuitry: Acquisition U4025, U1015; Self- Test U3025, U2065,U2071, U3071, U4015, U4071, U3075, U4079, Q4083, Q4071. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.</pre>
7	Does not trigger on INH2(L) low or high when appropriate	<pre>INH2(L) buffers or Self-Test Gen- erators faulty. Check CI5 circui- try: Acquisition U4025, U1015; Self-Test U3025, U2065,U2071, U3071, U4015, U4071, U3075, U4079, Q4083, Q4071. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.</pre>
8	Does not store all or does not store any AVL cycles when appropriate	BUSY buffers or Self-Test Generator faulty. Check CI9 circuitry: Acquisition U2031, U4025, DL3081, Q2087, Q2084, Q2085, Q2081, Q2083, Q2086, U2021; Self-Test U4061, U2031, U3071, U3075, U2065, U4071, U2071, U4079, U4015, Q4083, Q4071. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.

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Maintenance and Troubleshooting - PM 112

		Table	6-3	(cont	t.)	
ΡM	112	TROUBLE	ESHOO	TING	ERROR	LIST

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Error No.	Symptom	Possible Causes/Suggestions
9	Does not store all or does not store any ACLO cycles when appropriate	ACLO(L) buffers or Self-Test Gen- erator faulty. Check CI8 circuitry: Acquisition U2031, U1021, U4025, U1015; Self-Test U4015, U3025, U2065, U2071, U3071, U4071, U3075, U4079, Q4083, Q4071. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.
10	Does not store all or does not store any LOCK(L) cycles when appropriate	LOCK(L) buffers or Self-Test Gen- erator faulty. Check CI7 circuitry: Acquisition U4025, U1015, U2031, U1021; Self-Test U3025, U2065, U2071, U3071, U4071, U3075, U4079, U4015, Q4083, Q4071. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.
11	Does not store all or does not store any CBRQ(L) cycles when appropriate	CBRQ(L) buffers or Self-Test Gen- erator faulty. Check CI6 circuitry: Acquisition U2031, U1021, U4025, U1015; Self-Test U4015, U3025, U2065, U2071, U3071, U4071, U3075, U4079, Q4083, Q4071. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.
12	Does not store all or does not store any INH2(L) cycles when appropriate	<pre>INH2(L) buffers or Self-Test Gen- erator faulty. Check CI5 circuitry: Acquisition U4025, U1015, U2031, U1021; Self-Test U3025, U2065, U2071, U3071, U4071, U3075, U4079, U4015, Q4083, Q4071. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.</pre>

Maintenance and Troubleshooting - PM 112

Table 6-3 (cont.) PM 112 TROUBLESHOOTING ERROR LIST

Error No.	Symptom	Possible Causes/Suggestions
13	Does not store all or does not store any INH1(L) cycles when appropriate	<pre>INH1(L) buffers or Self-Test Gen- erator faulty. Check CI4 circuitry: Acquisition U4025, U1015, U2031, U1021; Self-Test U3025, U2065, U2071, U3071, U4071, U3075, U4079, U4015, Q4083, Q4071. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.</pre>
14	DATA Setup Time failure	Data buffers too slow or dead; XACK(L) delay too fast, or dead; Self-Test Generator faulty. Check DATA buffers: U4051, U2055, U4045, U1045, U4025. XACK(L) delay: U4021, DL3081, Q2081, Q2083, Q2084, Q2085, Q2086, Q2087. Self-test: U3045, U2061, U3065, U3051, U3061, U3079, U4015, U2031, U4075, U2071, U2065, U3071, U4071, U3075, U4079, Q4083, Q4071. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.
15	DATA Hold Time failure	Data buffers too fast or dead; XACK(L) delay too slow or dead; Self-Test Generator faulty. Check DATA buffers: U4051, U2055, U4045, U1045, U4025. Check XACK(L) delay: U4021, DL3081, Q2081, Q2083, Q2084, Q2085, Q2086, Q2087. Self-Test: U3045, U2061, U3065, U3051, U3061, U3079, U4015, U2031, U4075, U2071, U2065, U3071, U4071, U3075, U4079, Q4083, Q4071. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.

Maintenance and Troubleshooting - PM 112

Table 6-3 (cont.) PM 112 TROUBLESHOOTING ERROR LIST

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Error No.	Symptom	Possible Causes/Suggestions
16	COMMAND Setup Time failure	COMMAND buffer or encoder too slow or dead; XACK(L) delay too fast or dead; Self-Test Generator faulty. Check buffers and encoder: U4021, U2031, U2021. XACK(L) delay: U4021, DL3081, Q2081, Q2083, Q2084, Q2085, Q2086, Q2087. Self-Test: U4061, U4065, U3071, U2065, U2071, U4071, U3075, U4079, U4015, U2031, Q4083, Q4071. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.
17	COMMAND Hold Time failure	COMMAND buffer or encoder too fast or dead; XACK(L) delay too slow or dead; Self-Test Generator faulty. Check buffers and encoder: U4021, U2031, U2021. XACK(L) delay: U4021, DL3081, Q2081, Q2083, Q2084, Q2085, Q2086, Q2087. Self-Test: U4061, U4065, U3071, U2065, U2071, U4071, U3075, U4079, U4015, U2031, Q4083, Q4071. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.
18	TIMING OPTION Setup and/or Hold Time failure	XACK(L) delay too fast or dead; Timing Option Self-Test Generator faulty. Check XACK(L) delay: U4021, DL3081, Q2081, Q2083, Q2084, Q2085, Q2086, Q2087. Self-Test: U1021, U2031, U4021, U4025, U1045, U4045, U3045, U2061, U3065, U4075, U2031, U2071, U4015, U2065, U3071, U4071, U3075, U4079, U4061, U4065, U3025, Q4083, Q4071, Q4085. Replace suspected parts and retest. If unsuccessful, go to Troubleshooting Procedure 1.
19	Self-Test Clock Frequency not as specified	Slow or dead transistor; inductor or capacitors out of tolerance. Check Q4083, U4079, L4083, C4081, C4083, and -15V power supply. Replace suspected parts and retest. If unsuccessful, go to Trouble- shooting Procedure 1.

Maintenance and Troubleshooting - PM 112



Figure 6-1. Troubleshooting Procedure 1.





Maintenance and Troubleshooting - PM 112





Maintenance and Troubleshooting - PM 112

SIGNATURE ANALYSIS

The Signature Analysis Procedure allows the service technician to check the condition of a logic circuit node in the PM 112 with respect to a specific operating time window.

Troubleshooting With Signature Analysis Procedure

A signature is a four-digit hexadecimal number representing time-dependent logic activity during a specified measurement interval (referred to as a window) for a given circuit node. Any change in the behavior of this node (even a transition that occurs one clock cycle late) will produce a different signature, indicating a probable malfunction in the circuit.

The signal that causes the node to produce a signature is the stimulus. In signature analysis, the stimulus is supplied by the personality module itself when it is in the self-test mode. This way, a controlled environment is created wherein selected portions of the circuit are tested independently, while maintaining full dynamic operation.

Preliminary Setup

- 1. Use the Sony/Tektronix 308 Data Analyzer with P6451 probe.
- 2. Leave the mainframe power off. Insert the personality module logic analyzer plug into the logic analyzer.
- 3. Set all PM 112 jumpers to their default pin 1 positions (indicated by tick marks).
- 4. Set jumper W3085 to the TEST position.
- Connect the signature analyzer probe clock lead to U4071, pin 2.
- Connect the signature analyzer start/stop leads to U4061, pin 15.
- 7. Switch the signature analyzer power on.
- 8. Set the START triggering to falling edge.
- 9. Set the STOP triggering to rising edge.
- 10. Set CLOCK to rising edge.
- 11. Switch on logic analyzer power while holding down any 7D02 key (except X and START). This will force the 7D02 into the diagnostic mode.

Maintenance and Troubleshooting - PM 112

- 12. Press the 7D02 X key to obtain a display of the diagnostic menu.
- 13. Press the F key to select SIGNATURE EXERCISER MENU.
- 14. Press the 7 key to select PER.MOD.-SYSTEM.
- 15. The serial signature probe ground clip must be connected to TP4085, TP1010, or another grounded point on the PM 112. The following signature table lists the PM 112 signatures.

NOTE

The signature for +5 V = 9FA8, and the signature for GND = 0000. An asterisk (*) denotes an unstable signature.

U	1015	U	1021	U	1045	J	1075
1)	0000	1)	UFP7	1)	62HA	1)	0000
2)	93H7	2)	2A41	2)	PC5A	2)	0000
3)	62HA	3)	8294	3)	F951	3)	0000
4)	AHU5	4)	C438	4)	PC5A	4)	0000
5)	19UH	5)	33P6	5)	5H33	5)	Pl2U
6)	*	6)	93H7	6)	PC5A	6)	6AC7
7)	19UH	7)	1933	7)	78HC	7)	Pl2U
8)	*	8)	93H7	8)	PC5A	8)	6AC7
9)	9FA8	9)	C07P	9)	78HC	9)	Pl2U
10)	0000	10)	0000	10)	0000	10)	6AC7
11)	9FA8	11)	1C69	11)	77U2	11)	Pl2U
12)	9FA8	12)	78HC	12)	C07P	12)	6AC7
13)	1C69	13)	AHU5	13)	77U2	13)	Pl2U
14)	9FA8	14)	78HC	14)	1933	14)	6AC7
15)	1C69	15)	470H	15)	77U2	15)	Pl2U
16)	AHU5	16)	5433	16)	33P6	16)	6AC7
17)	604U	17)	57F6	17)	77U2	17)	Pl2U
18)	9982	18)	F951	18)	8294	18)	6AC7
19)	0000	19)	UFP7	19)	62HA	19)	Pl2U
20)	9FA8	20)	9FA8	20)	9FA8	20)	6AC7

Table 6-4 PM 112 SIGNATURES

Maintenance and Troubleshooting - PM 112

		PM 112 SI	GNATURES	
J1075	(cont.)	U2021	U2031 (cont.)	U2045
21)	Pl2U	1) 2A41	5) 052A	1) 9FA8
22)	6AC7	2) 57F6	6) 5CPA	2) *
23)	Pl2U	3) C438	7) OH10	3) *
24)	6AC7	4) 470H	8) 9FA9	4) *
25)	FHPH	5) 0000	9) 8C99	5) *
26)	16A3	6) 121A	10) 0000	6) *
27)	U9FF	7) 60P2	11) 1731	7) PC5A
28)	07CU	8) 0000	12) 0001	8) *
29)	5664	9) 8F63	13) 91C8	9) *
30)	FAFF	10) 9FA8	14) F742	10) 0000
31)	5664	11) 9FA8	15) 9982	11) 7702
32)	FAFF	12) 93H7	16) 1730	12) *
33)	5664	13) 9FA8	17) 0000	13) *
34)	FAFF	14) 1H65	18) UFP7	14) *
35)	5664	15) 81FH	19) 0000	15) *
36)	FAFF	16) 9FA8	20) 9FA8	16) *
37)	89C4		,	17) *
38)	8397			18) *
39)	1нн6	U2025	U2041	19) 9FA8
40)	32P5			20) 9FA8
41)	383P	1) 672C	1) 8688	•
42)	U205	2) 1HUO	2) 1A20	
43)	30UP	3) C4CH	3) 8688	02055
44)	26A3	4) A156	4) 1A20	
45)	9FA8	5) 0000	5) 8688	1) 0000
46)	8F63	6) U399	6) 1A20	2) PC5A
47)	60P2	7) *	7) 8688	3) *
48)	121A	8) 0000	8) 1A20	4) PC5A
49)	62HA	9) *	9) *	5) *
50)	8HC4	10) 7U80	10) *	6) PC5A
51)	56UA	11) 829A	11) *	7) 7702
52)	8HC4	12) 9H4C	12) 0000	8) PC5A
53)	9982	13) 9FC6	13) *	9) 77U2
54)	62HC	14) 052A	14) *	10) 0000
55)	9FA8	15) 9982	15) *	11) 77U2
56)	9FA8	16) 9FA8	16) *	12) *
57)	9FA8		17) *	13) 77U2
58)	9FA8		18) 9FA8	14) PC5A
59)	0000	U2031	19) 1A20	15) 77U2
60)	0000		20) 0000	16) PC5A
61)	9FA8	1) 0000	21) 9FA8	17) 77U2
62)	0000	2) 604U	22) 8688	18) PC5A
63)	9FA8	3) 9FA8	23) 1A20	19) 0000
64)	0000	4) 8C98	24) 9FA8	20) 9FA8

Table 6-4 (cont.) PM 112 SIGNATURES

Maintenance and Troubleshooting - PM 112

		1	-M 112 51	GNATURE	5		
U	2061	U2071	(cont.)	U3025	(cont.)	U3035	(cont.)
1)	F742	8)	1730	13)	0H10	12)	1A20
2)	1730	9)	0000	14)	91C8	13)	91C8
3)	9FA8	10)	8098	15)	1A20	14)	0H10
4)	*	11)	8098	16)	8688	15)	8688
5)	1730	12)	5CPA	17)	0H10	16)	1A20
6)	9FA8	13)	2196	18)	9108	17)	9108
7)	H6C5	14)	9528	19)	1A20	18)	0H10
81	0000	±-1)	<i>J11</i> 0	20)	9FA8	19)	8688
9)	н6С5			20)	52110	20)	9FA8
10)	9FA8	TT.	3021			20,	21110
111	1730	0.		TT	2031		
$\frac{1}{12}$	H6C5	1)	0000	0.		TT 1	3041
131	9FA8	2)	*	1)	0000	0.	
14)	1730	2)	8688	2)	71180	1)	0000
15)	9108	4)	*	3)	*	2)	8688
161	9F78		1220	4)	9116D	2)	0000 0H10
10)	JINO	5)	8688		9H4C	4)	9108
		0) 7)	1220	5)	6720		1 1 2 0
TT	2065	7)	1AZU *	0) 7)	U72C	5)	2688
0.	2005	8)	110 FF	8)	FFJ/ P61/	7)	0000
1١	9528	10)	0000	9)	CACH	8)	9108
2)	2008	11)	11300	10)	0000	9)	1220
2)	0000	12)	0599 0 E 7 8	10)	1730	10)	0000
3) A)	0000	13)	1220	12)	A156	11)	1730
/ 5\	0000	14)	8688	13)	CSUF	12)	1220
5)	0000	14)	1720	14)	0010	13)	9108
71	0000 0 17 7 9	16)	THZU FUDU	15)		14)	0410
/) 0\	91 A0	17)	r nr n 0600	16)	11100 9706	15)	8688
0)	0000	10)	0000 1670	17)	9500	16)	1720
101	95 AO 0570	10)	1042	19	7574 እበምሀ	17)	1A20 01C9
11)	95 AO	19)	0000	10)	AUFH 0207	10)	9100
121	26112	20)	9FA0	20)	023A 0770	10)	0620
12)				20)	9F AO	19) 20)	0000 0 tr 1 0
13)	DLCPA		0005			20)	JFAO
14)	10110	0.	5025	TT (0025		
10)		1 \	0000	0.	5035	11.	045
το)	9FA8	1)	6041	1 \	0000	0.	5045
		2) 2)	6567	1) 2)	1220	1)	0000
TT	2071	3) 4)	8257	2) 3)	9108	2)	7712
U	2071	41) 5)	0257	3)	0410	2)	6747
٦ ١	1721	5)			8688		97A7 46C5
2) 1	8C08 TIST	0) 7\	50DA	5)	1220	₩) 5\	PC5A
2) 21	0000	7) Q \	3643	0) 7\	9108	5)	77112
5)	0003	0)	1069	// 8\	0010	0) 7\	*
4) 5)	0000 Q IT N Q	9) 101	1009	0) Q1	8688	/) 8\	*
5)	0 77 70 0 77 70	10)	1730	<i>رد</i> ۱۵۱	0000	0) Q\	PC5A
0) 7)	0000	⊥⊥ <i>)</i> 1 2\	7/20 T/20	10)	1730	<i>ן כ</i> וחו	1000
()	0000	1Z)	0000)	T120	TO)	0000

Table 6-4 (cont.) PM 112 SIGNATURES

Maintenance and Troubleshooting - PM 112

Table 6-4 (cont.) PM 112 SIGNATURES

U3045	(cont.)	U3055	(cont.)	U	3071	U3079	(cont.)
11)	F742	10)	9P19	1)	0528	12)	67A7
12)	PC5A	11)	FP57	2)	8257	13)	9fa8
13)	н6С5	12)	9F94	3)	9980	14)	1730
14)	67A7	13)	9U6P	4)	lPUU	15)	91C8
15)	77U2	14)	AOFH	5)	lPUU	16)	9FA8
16)	PC5A	15)	5UH2	6)	8257		
17)	*	16)	9FA8	7)	0000		
18)	4AlH			8)	9FA9	U4	4015
19)	77U2			9)	0003		
20)	9FA8	US	3061	10)	9980	1)	0000
				11)	1730	2)	*
		1)	F742	12)	9FA8	3)	0000
U 3	3051	2)	1730	13)	8098	4)	93H7
		$\overline{3}$	9FA8	14)	9FA8	5)	9FA8
1)	0000	4)	UCOU	/	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	6)	60411
2)	77U2	5)	1730			7)	9FA8
3)	67A7	6)	9FA8	U	3075	8)	1069
4)	UCOU	7)	*	C		9)	9108
5)	PC5A	8)	0000	1)	9FA8	10)	0000
6)	7702	9)	UCOU	2)	9980	11)	9168
7)	67A7	10)	9FA8	$3\hat{)}$	8C98	12)	1C69
8)	UCOU	11)	1730	4)	9FA8	13)	*
<u>9</u>)	PC5A	12)	UCOU	5)	9FAC	14)	60411
10)	0000	13)	9FA8	5) 6)	0003	15)	*
11)	F742	14)	1730	3) 7)	0000	16)	9347
12)	PC5A	15)	9108	8)	0000 9 F7 8	17)	9 3 H 7
13^{-1}	*	16)	9528	9)	0000	18)	9528
14)	6747	10,	J1110	10	0000 9 F 7 8	10)	0000
15)	77112			11)	9FA8	20)	9578
16)	PC5A	11	3065	12)	9F78	20)	JIAU
17)	UCOU	0.		13)	9FA8		
18)	67A7	1)	F742	14)	9F78	TI	4021
19)	77112	2)	1730	1 4)	JINO	0	1021
20)	9FA8	3)	9F28			1)	0000
	51110	3) 4)		TT	3070	1) 2)	0000 0207
			1730	0	3079	2) 3)	2387 1704
TT	3055	5, 6)	9F28	11	F742	5) 4)	27/11
0.	5033	7)	67 2 7	1 I I I I I I I I I I I I I I I I I I I	1730	47 5)	1730
1)	5000	8)	0000	2)	1730 9778	5)	5786
2)	3683	9)	6727	3) 4)	67A7	0) 7)	92U7
3)	6567	10)	9F28		1730	7) 8)	C139
4)	0000	111	1730	5)	7730 9770	0) Q1	1069
- / 5)		121	*	0) 71	6747	ן כ ו ח ו	1009
6)	9FA8	131	9FA8	(/ 8 \	0000	10)	1060
7)	C5UF	14)	1730	91	6747	121	C438
8)	0000	151	9108	101	9F28	12)	93H7
9)	P614	16)	9FA8	11)	1730	14)	57F6
•				,		= - /	•

Maintenance and Troubleshooting - PM 112

Table 6-4 (cont.) PM 112 SIGNATURES

U4021	(cont.)	U4031	(cont.)	U4041	(cont.)	U4051	(cont.)
15)	1730	14)	9H4C	13)	1A20	12)	77U2
16)	2A41	15)	lHUO	14)	1A20	13)	PC5A
17)	470H	16)	672C	15)	8688	14)	PC5A
18)	93H7	17)	A156	16)	8688	15)	77U2
19)	0000	18)	C4CH	17)	1A20	16)	77U2
20)	9FA8	19)	0000	18)	1A20	17)	PC5A
		20)	9FA8	19)	0000	18)	PC5A
				20)	9FA8	19)	0000
U	4025			·		20)	9FA8
		U	4035				
1)	0000	-		U4	4045		
2)	1C69	1)	0000	-		U	4061
3)	9FA8	2)	8688	1)	0000	·	
4)	AHU5	3)	1A20	2)	PC5A	1)	0000
5)	604U	4)	1A20	3)	PC5A	2)	2A41
6)	93H7	5)	8688	4)	77112	-,	1117A
7)	8HC4	6)	8688	5)	77112	4)	0474
8)	6040	3) 7)	1A20	6)	PC5A	5)	5756
9)	62HA	8)	1A20	3) 7)	PC5A	5) 6)	C438
10)	0000	9)	8688	8)	77112	3) 7)	FH89
11)	60411	10)	0000	9)	7712	8)	1069
12)	6040	10)	8688	101	0000	0) 9)	8404
13)	8HC4	12)	1220	11)	77112	10)	0000
14)	93H7	13)	1020	12)	7702	10)	0000
15)	60411	14)	8688	12)	DC5A	12)	0000
16)	ΔHU5	15)	8688	14)	PC5A	12)	8257
17)	9F28	15)	1220	15)	77112	14)	0237
18)	1069	17)	1 1 2 0	16)	7702	15)	0001
10)	0000	10)	0600	17)	7702	15)	1730
201	0000 9578	10)	0000	10)	PCJA DC5A	10)	1730
20)	91 AO	19)		10)	PC5A 0000	10)	2072
		20)	9f Ao	19)	0000	10)	2CP3
TT.	1031			20)	9r Ao	19)	470H
0.	1031		1047			20)	JFAO
1)	0000	04	1041	TT			
1) 2)		٦.	0000	04	1021	TT	1065
2) 2)	V156	1) 2)	10000	1 \	0000	04	1005
3) 4)	A100	2)		1) 2)		1)	1 7 2 0
4) 5)	14110	3)	1A20 0600	2) 2)	PC5A DC5A	1) 2)	
5)		4)	0000		PC3A 77112	2)	AHUJ
(0 7)	9040	5)	1720	4) 5)	7702	3) 4)	8000
/) 8)	71180	0) 7)	1220	5)	7702 DC5A	4) 5)	
0) 0)	8297	/) Q\	7420	0) 7\		5)	9 F 2 C
<i>י</i> פ 101	0000	0) Q1	8688	/) Q\	77112	0) 7)	9 F 2 8
111	8292	<i>י</i> ק וחו	0000	G) G1	77112	// 81	0000
1 2 1	71180	111	8688	י גר ני גר	0000	() G	9FA8
121	9706	エエノ 1 つ \	8688	111	77112	101	9F28
T J)	J L C U	/	0000		1102	T O)	

Maintenance and Troubleshooting - PM 112

	Table 6-4 (cont.) PM 112 SIGNATURES							
U4065	(cont.)	U	4079	P4039	(cont.)			
11)	9FA8	1)	9FA8	63)	77U2			
12)	FH89	2)	9FA8	65)	77U2			
13)	Ul7A	3)	0000	67)	77U2			
14)	2CP3	4)	9FA8	69)	77U2			
15)	0A74	5)	9FA8	71)	77U2			
16)	9FA8	6)	0000	73)	77U2			
		7)	0000					
		8)	9FA8	P	4039			
U	4071	9)	0000					
. .	-	10)	0000	(even	<pre># pins)</pre>			
1)	9FA8	11)	9FA8	14)	93H7			
2)	0000	12)	9FA8	16)	8HC4			
3)	0000	13)	0000	18)	0000			
4)	0000	14)	9FA8	20)	57F6			
5)	0000			22)	4/0H			
6) 7)			4020	24)	TC69			
/)	9FA8	P	4039	26)	AHUS			
0)	0000	(-33	#	28)				
3)	95A0 Q57Q		# pins)	30)	0000			
11)	1069	15)	9100	3Z) 24)				
12)		17)	0000	34)	71180			
13)	1220	19)	2241	38)	9H4C			
14)	8098	21)	C438	40)	6720			
15)	0528	23)	1730	42)	CACH			
16)	9FA8	25)	93H7	44)	8688			
,	22110	23)	60411	46)	8688			
		29)	1069	48)	8688			
U	4075	31)	0000	50)	8688			
-		33)	93H7	52)	8688			
1)	9FA8	35)	829A	54)	8688			
2)	0000	37)	9FC6	56)	8688			
3)	9FA8	39)	lHUO	58)	8688			
4)	9FA8	41)	A156	60)	PC5A			
5)	8C98	43)	1A20	62)	PC5A			
6)	1730	45)	1A20	64)	PC5A			
7)	0000	47)	1A20	66)	PC5A			
8)	F742	49)	1A20	68)	PC56			
9)	2196	51)	1A20	70)	PC5A			
10)	0000	53)	1A20	72)	PC5A			
11)	0000	55)	1A20	74)	PC5A			
12)	0000	57)	1A20	•				
13) 14:	SCPA	59)	7702					
⊥4)	9FA8	6⊥)	1102					

Section 7 - PM 112

REPLACEABLE ELECTRICAL PARTS PARTS ORDERING INFORMATION

Replacement parts are available from or through your local Tektronix, Inc. Field Office or representative.

Changes to Tektronix instruments are sometimes made to accommodate improved components as they become available, and to give you the benefit of the latest circuit improvements developed in our engineering department. It is therefore important, when ordering parts, to include the following information in your order: Part number, instrument type or number, serial number, and modification number if applicable.

If a part you have ordered has been replaced with a new or improved part, your local Tektronix, Inc. Field Office or representative will contact you concerning any change in part number.

Change information, if any, is located at the rear of this manual.

LIST OF ASSEMBLIES

A list of assemblies can be found at the beginning of the Electrical Parts List. The assemblies are listed in numerical order. When the complete component number of a part is known, this list will identify the assembly in which the part is located.

CROSS INDEX-MFR. CODE NUMBER TO MANUFACTURER

The Mfr. Code Number to Manufacturer index for the Electrical Parts List is located immediately after this page. The Cross Index provides codes, names and addresses of manufacturers of components listed in the Electrical Parts List.

ABBREVIATIONS

Abbreviations conform to American National Standard Y1.1.

COMPONENT NUMBER (column one of the Electrical Parts List)

A numbering method has been used to identify assemblies, subassemblies and parts. Examples of this numbering method and typical expansions are illustrated by the following:



Read: Resistor 1234 of Subassembly 2 of Assembly 23

Only the circuit number will appear on the diagrams and circuit board illustrations. Each diagram and circuit board illustration is clearly marked with the assembly number. Assembly numbers are also marked on the mechanical exploded views located in the Mechanical Parts List. The component number is obtained by adding the assembly number prefix to the circuit number.

The Electrical Parts List is divided and arranged by assemblies in numerical sequence (e.g., assembly A1 with its subassemblies and parts, precedes assembly A2 with its subassemblies and parts).

Chassis-mounted parts have no assembly number prefix and are located at the end of the Electrical Parts List.

TEKTRONIX PART NO. (column two of the Electrical Parts List)

Indicates part number to be used when ordering replacement part from Tektronix.

SERIAL/MODEL NO. (columns three and four of the Electrical Parts List)

Column three (3) indicates the serial number at which the part was first used. Column four (4) indicates the serial number at which the part was removed. No serial number entered indicates part is good for all serial numbers.

NAME & DESCRIPTION (column five of the Electrical Parts List)

In the Parts List, an Item Name is separated from the description by a colon (:). Because of space limitations, an Item Name may sometimes appear as incomplete. For further Item Name identification, the U.S. Federal Cataloging Handbook H6-1 can be utilized where possible.

MFR. CODE (column six of the Electrical Parts List)

Indicates the code number of the actual manufacturer of the part. (Code to name and address cross reference can be found immediately after this page.)

MFR. PART NUMBER (column seven of the Electrical Parts List)

Indicates actual manufacturers part number.

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CROSS INDEX-MFR. CODE NUMBER TO MANUFACTURER

Mfr. Code	Manufacturer	Address	City, State, Zip
00853	SANGAMO ELECTRIC CO., S. CAROLINA DIV.	P O BOX 128	PICKENS, SC 29671
01121	ALLEN-BRADLEY COMPANY	1201 2ND STREET SOUTH	MILWAUKEE, WI 53204
01295	TEXAS INSTRUMENTS, INC., SEMICONDUCTOR	P O BOX 5012, 13500 N CENTRAL	
	GROUP	EXPRESSWAY	DALLAS, TX 75222
01961	PULSE ENGINEERING, INC.	7250 CONVOY COURT	SAN DIEGO, CA 92111
04713	MOTOROLA, INC., SEMICONDUCTOR PROD. DIV.	5005 E MCDOWELL RD, PO BOX 20923	PHOENIX, AZ 85036
07263	FAIRCHILD SEMICONDUCTOR, A DIV. OF		
	FAIRCHILD CAMERA AND INSTRUMENT CORP.	464 ELLIS STREET	MOUNTAIN VIEW, CA 94042
09353	C AND K COMPONENTS, INC.	103 MORSE STREET	WATERTOWN, MA 02172
18324	SIGNETICS CORP.	811 E. ARQUES	SUNNYVALE, CA 94086
27014	NATIONAL SEMICONDUCTOR CORP.	2900 SEMICONDUCTOR DR.	SANTA CLARA, CA 95051
56289	SPRAGUE ELECTRIC CO.	87 MARSHALL ST.	NORTH ADAMS, MA 01247
72982	ERIE TECHNOLOGICAL PRODUCTS, INC.	644 W. 12TH ST.	ERIE, PA 16512
75042	TRW ELECTRONIC COMPONENTS, IRC FIXED		
	RESISTORS, PHILADELPHIA DIVISION	401 N. BROAD ST.	PHILADELPHIA, PA 19108
80009	TEKTRONIX, INC.	P O BOX 500	BEAVERTON, OR 97077
91637	DALE ELECTRONICS, INC.	P. O. BOX 609	COLUMBUS, NE 68601

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Component No.	Tektronix Part No.	Serial/Model No. Eff Dscont	Name & Description	Mfr Code	Mfr Part Number
A01	670-7458-00		CKT BOARD ASSY: PERSONALITY MODULE	80009	670-7458-00
A02	670-6149-00 		CKT BOARD ASSY:PROBE CONNECTOR (NO ELECTRICAL PARTS)	80009	670-6149-00
A01			CKT BOARD ASSY: PERSONALITY MODULE		
A01C1010	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ50104
A01C1012	281-0775-00		CAP., FXD, CER DI:0.10F, 20% , 50V	72982	8005D9AAB250104
A0101025	281-0775-00		CAP., FXD, CER DI: $0.10F$, 20% , $50V$	72982	800509448250104
A01C1045	281-0775-00		CAP., FXD, CER DI:0.10F, 20%, 50V CAP., FXD, CER DI:0.10F, 20%, 50V	72982	8005D9AABZ5U104
A01C1053	290-0747-00		CAP., FXD, ELCTLT: 100UF, +50-10%, 25V	56289	500D148
A01C1055	281-0775-00		CAP.,FXD,CER DI:0.1UF,20%,50V	72982	8005D9AABZ5U104
A01C1057	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C2025	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C2035	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C2051	281-0775-00		CAP.,FXD,CER DI:0.1UF,20%,50V	72982	8005D9AABZ5U104
A01C2065	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C2075	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C2080	281-0775-00		CAP.,FXD,CER DI:0.1UF,20%,50V	72982	8005D9AABZ5U104
A01C2081	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C2085	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C2086	281-0758-00		CAP.,FXD,CER DI:15PF,20%,100V	72982	314022C0G0150M
A01C3025	281 - 0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C3035	281-0775-00		CAP., FXD, CER DI:0.10F, 20%, 50V	72982	8005D9AAB250104
A01C3039	281-0775-00		CAP., FXD , CER DI:0.10F, 20%, 50V	72982	8005D9AAB250104
A01C3045	281-0775-00		CAP., FXD, CER DI:0.10F, 20%, 50V	72902	800509448250104
A01C3049 A01C3055	281-0775-00		CAP., FXD, CER DI:0.10F, 20%, 50V CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C3065	281-0775-00		CAP., FXD.CER DI:0.1UF.20%.50V	72982	8005D9AABZ5U104
A01C3071	281-0775-00		CAP., FXD.CER DI:0.1UF.20%,50V	72982	8005D9AABZ5U104
A01C3075	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C4025	281-0775-00		CAP., FXD, CER DI: Q. 1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C4035	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C4045	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C4049	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C4051	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AABZ5U104
A01C4061	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AAB250104
A01C4071	281-0775-00		CAP., FXD, CER DI:0.1UF, 20%, 50V	72982	8005D9AAB250104
A01C4075 A01C4081	281-0775-00 283-0625-00		CAP.,FXD,CER DI:0.1UF,20%,50V CAP.,FXD,MICA D:220PF,1%,500V	00853	D105F221F0
40104082	282 0625 00		CAR EVE MICA D. 2200E 19 5000	00853	D105F221F0
A01C4085	203-0023-00		CAP. FYD FICTIT $1000 \pm 50 - 10\%$	56289	500D149
A01CP/085	152-0141-02		SEMICOND DEVICE SILICON 30V 150MA	01295	1N4152R
A01DL3081	119-1169-00		DELAY LINE: DUAL, 30NS, 120 OHM, 16 DIP	01961	PE22376
A01DS2037	150-1001-02		LT EMITTING DIO: RED, 660NM, 50MA MAX	80009	150-1001-02
A01J1030	131-2848-01		CONN, RCPT, ELEC: EDGE CARD, 2 X 43	80009	131-2848-01
A01L4083	108-0735-00		COIL, RF: FIXED, 560NH	80009	108-0735-00
A01Q2081	151-0271-00		TRANSISTOR: SILICON, PNP	04713	SPS8236
A01Q2083	151-0271-00		TRANSISTOR: SILICON, PNP	04713	SPS8236
A01Q2084	151-0216-00		TRANSISTOR: SILICON, PNP	04713	SPS8803
A01Q2085	151-0188-00		TRANSISTOR: SILICON, PNP	04/13	5150000K
A01Q2086	151-0188-00		TRANSISTOR: SILICON, PNP	04713	2120000K
A01Q2087	151-0188-00		TRANSISTOR: SILICON, PNP	04713	SPS6868K
A01Q3085	151-0190-00		TRANSISTOR: SILICON, NPN	07263	3U320// S032677
A01Q4071	151-0190-00		TRANSISTOR: SILICON, NPN	01203	SKA6516
A01Q4083	151-0367-00		TRANSISTOR: SILICON, NPN, SEL FROM 35/ITP	01295	2VV0110

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Component No	Tektronix Part No	Serial/	Model No.	Name & Description	Mfr Codo	Mfr Dart Number
	Tart No.	LI1				
A01Q4085	151-0188-00			TRANSISTOR: SILICON, PNP	04713	SPS6868K
A01R1031	307-0721-00			RES NTWK,FXD,FI:5,68 OHM,2%,1.5W	91637	MSP10A03680G
A01R1033	307-0721 - 00			RES NTWK,FXD,F1:5,68 OHM,2%,1.5W	91637	MSP10A03680G
A01R1035	307-0721-00			RES NTWK,FXD,F1:5,68 OHM,2%,1.5W	91637	MSP10A03680G
A01R1041	307-0721-00			RES NTWK,FXD,FI:5,68 OHM,2%,1.5W	91637	MSP10A03680G
A01R1051	307-0721-00			RES NTWK, FXD, FI:5,68 OHM, 2%, 1.5W	91637	MSP10A03680G
A01R1053	307-0721-00			RES NTWK, FXD, FI: 5, 68 OHM, 2%, 1.5W	91637	MSP10A03680G
A01R1083	322-0612-00			RES.,FXD,FILM:500 OHM,1%,0.25W	75042	CEBT0-5000F
A01R1085	315-0272-00			RES.,FXD,CMPSN:2.7K OHM,5%,0.25W	01121	CB2725
A01R1087	315-0272-00			RES.,FXD,CMPSN:2.7K OHM,5%,0.25W	01121	CB2725
A01R2037	315-0221-00			RES.,FXD,CMPSN:220 OHM,5%,0.25W	01121	CB2215
A01R2051	307-0721-00			RES NTWK, FXD, FI:5, 68 OHM, 2%, 1.5W	91637	MSP10A03680G
A01R2065	315-0202-00			RES.,FXD,CMPSN:2K OHM,5%,0.25W	01121	CB2025
A01R2075	307-0721-00			RES NTWK,FXD,FI:5,68 OHM,2%,1.5W	91637	MSP10A03680G
A01R2077	307-0721-00			RES NTWK, FXD, FI: 5, 68 OHM, 2%, 1.5W	91637	MSP10A03680G
A01R2079	307-0721-00			RES NTWK, FXD, FI: 5, 68 OHM, 2%, 1.5W	91637	MSP10A03680G
A01R2081	321-0170-00			RES.,FXD,FILM:576 OHM,1%,0.125W	91637	MFF1816G576R0F
A01R2082	321-0181-00			RES., FXD, FILM: 750 OHM, 1%, 0.125W	91637	MFF1816G750R0F
A01R2083	315-0470-00			RES.,FXD,CMPSN:47 OHM,5%,0.25W	01121	CB4705
A01R2084	315-0103-00			RES.,FXD,CMPSN:10K OHM,5%,0.25W	01121	CB1035
A01R2085	315-0102-00			RES.,FXD,CMPSN:1K OHM,5%,0.25W	01121	CB1025
A01R2086	315-0101-00			RES., FXD, CMPSN: 100 OHM, 5%, 0.25W	01121	CB1015
A01R2087	315-0241-00			RES.,FXD,CMPSN:240 OHM,5%,0.25W	01121	CB2415
A01R2088	315-0101-00			RES.,FXD,CMPSN:100 OHM,5%,0.25W	01121	CB1015
A01R2089	315-0241-00			RES., FXD, CMPSN: 240 OHM, 5%, 0.25W	01121	СВ2415
A01R3075	315-0472-00			RES., FXD, CMPSN: 4.7K OHM, 5%, 0.25W	01121	CB4725
A01R3079	315-0222-00			RES., FXD, CMPSN: 2.2K OHM, 5%, 0.25W	01121	CB2225
A01R3080	315-0241-00			RES., FXD, CMPSN: 240 OHM, 5%, 0.25W	01121	CB2415
A01R3081	315-0241-00			RES., FXD, CMPSN: 240 OHM, 5%, 0.25W	01121	CB2415
A01R3085	315-0103-00			RES.,FXD,CMPSN:10K OHM,5%,0.25W	01121	СВ1035 .
A01R3087	315-0102-00			RES., FXD, CMPSN: 1K OHM, 5%, 0.25W	01121	CB1025
A01R3089	315-0511-00			RES., FXD, CMPSN: 510 OHM, 5%, 0.25W	01121	CB5115
A01R4021	315-0472-00			RES.,FXD,CMPSN:4.7K OHM,5%,0.25W	01121	CB4725
A01R4025	315-0472-00			RES.,FXD,CMPSN:4.7K OHM,5%,0.25W	01121	CB4725
A01R4061	317-0181-00			RES.,FXD,CMPSN:180 OHM,5%,0.125W	01121	BB1815
A01R4071	315-0102-00			RES.,FXD,CMPSN:1K OHM,5%,0.25W	01121	CB1025
A01R4081	315-0272-00			RES.,FXD,CMPSN:2.7K OHM,5%,0.25W	01121	CB2725
A01R4083	315-0103-00			RES.,FXD,CMPSN:10K OHM,5%,0.25W	01121	CB1035
A01R4084	315-0472-00			RES., FXD, CMPSN: 4.7K OHM, 5%, 0.25W	01121	CB4725
A01R4085	315-0391-00			RES.,FXD,CMPSN:390 OHM,5%,0.25W	01121	CB3915
A01SW1085	260-1962-00			SWITCH, PUSH: SPDT, 0.4VA, 20V	09353	8125AE
A01U1015	156-0956-02			MICROCIRCUIT, DI: OCTAL BFR W/3STATE OUT	01295	SN74LS244NP3
A01U1021	156-0914-03			MICROCIRCUIT, DI: OCT ST BFR W/3 STATE OUT	18324	N74LS240N
A01U1045	156-0956-04			MICROCIRCUIT, DI: OCTAL BFR W/3STATE OUT	80009	156-0956-04
A01U2021	156-1252-00			MICROCIRCUIT, DI:8/3 LINE PRIORITY ENCODER	80009	156-1252-00
A01U2025	156-1252-00			MICROCIRCUIT, DI:8/3 LINE PRIORITY ENCODER	80009	156-1252-00
A01U2031	156-0914-02			MICROCIRCUIT, DI: OCT ST BFR W/3 STATE OUT	01295	SN74LS240
A01U2041	160-1566-00			MICROCIRCUIT, DI: 2048 X 8 EPROM	80009	160-1566-00
A01U2045	156-0916-02			MICROCIRCUIT, DI:8-2 INP 3-STATE BFR, BURN	27014	DM81LS97
A01U2055	156-0956-04			MICROCIRCUIT, DI: OCTAL BFR W/3STATE OUT	80009	156-0956-04
A01U2061	156-0530-02			MICROCIRCUIT, DI:QUAD 2 INP MUX	01295	SN74LS157P3
A01U2065	156-0844-02			MICROCIRCUIT, DI: SYN 4 BIT CNTR, SCRN	01295	SN74LS161A
A01U2071	156-0690-03			MICROCIRCUIT, DI: QUAD 2 INP NOR GATE, BURN IN	01295	SN74S02
A01U3021	156-0956-02			MICROCIRCUIT, DI: OCTAL BFR W/3STATE OUT	01295	SN74LS244NP3
A01U3025	156-0982-03			MICROCIRCUIT, DI: OCTAL-D-EDGE FF, SCRN	07263	74LS374
A01U3031	156-0982-03			MICROCIRCUIT, DI: OCTAL-D-EDGE FF, SCRN	07263	74LS374
A01U3035	156-0982-03			MICROCIRCUIT, DI: OCTAL-D-EDGE FF, SCRN	07263	74LS374

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	Tektronix	Serial/I	Model No.		Mfr	
Component No.	Part No.	Eff	Dscont	Name & Description	Code	Mfr Part Number
A01U3041	156-0982-03			MICROCIRCUIT, DI: OCTAL-D-EDGE FF, SCRN	07263	74LS374
A01U3045	156-0982-03			MICROCIRCUIT, DI: OCTAL-D-EDGE FF, SCRN	07263	74LS374
A01U3051	156-0982-03			MICROCIRCUIT, DI: OCTAL-D-EDGE FF, SCRN	07263	74LS374
A01U3055	156-0469-02			MICROCIRCUIT, DI: 3/8 LINE DCDR	01295	SN74LS138NP3
A01U3061	156-0530-02			MICROCIRCUIT, DI:QUAD 2 INP MUX	01295	SN74LS157P3
A01U3065	156-1395-01			MICROCIRUIT, DI: QUAD 2 LINE TO 1 LINE DATA	01295	SN74LS158
A01U3071	156-0180-04			MICROCIRCUIT, DI:QUAD 2 INP NAND GATE	01295	SN74S00NP3
A01U3075	156-0331-03			MICROCIRCUIT, DI: DUAL D TYPE POSITIVE EDGE	80009	156-0331-03
A01U3079	156-1395-01			MICROCIRCUIT, DI:QUAD 2 LINE TO 1 LINE DATA	01295	SN74LS158
A01U4015	156-0956-02			MICROCIRCUIT, DI: OCTAL BFR W/3STATE OUT	01295	SN74LS244NP3
A01U4021	156-0956-04			MICROCIRCUIT, DI: OCTAL BFR W/3STATE OUT	80009	156-0956-04
A01U4025	156-0956-02			MICROCIRCUIT, DI: OCTAL BFR W/3STATE OUT	01295	SN74LS244NP3
A01U4031	156-0956-02			MICROCIRCUIT, DI: OCTAL BFR W/3STATE OUT	01295	SN74LS244NP3
A01U4035	156-0956-02			MICROCIRCUIT, DI: OCTAL BFR W/3STATE OUT	01295	SN74LS244NP3
A01U4041	156-0956-02			MICROCIRCUIT, DI: OCTAL BFR W/3STATE OUT	01295	SN74LS244NP3
A01U4045	156-0956-04			MICROCIRCUIT, DI: OCTAL BFR W/3STATE OUT	80009	156-0956-04
A01U4051	156-0956-04			MICROCIRCUIT, DI: OCTAL BFR W/3STATE OUT	80009	156-0956-04
A01U4061	156-0982-03			MICROCIRCUIT, DI: OCTAL-D-EDGE FF, SCRN	07263	74LS374
A01U4065	156-0469-02			MICROCIRCUIT, DI: 3/8 LINE DCDR	01295	SN74LS138NP3
A01U4071	156-0844-02			MICROCIRCUIT, DI: SYN 4 BIT CNTR, SCRN	01295	SN74LS161A
A01U4075	156-1040-01			MICROCIRCUIT, DI:2 WIDE 2 INPUT/INVERT GATE	80009	156-1040-01
A01U4079	156-0721-02			MICROCIRCUIT, DI: QUAD 2-IN NAND SCHMITT TRI	04713	SN74LS132NDS
A01VR4085	152-0744-00			SEMICOND DVC, DI: ZEN, SI, 3.6V, 5%, 0.4W	04713	1N747A

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DIAGRAMS AND CIRCUIT BOARD ILLUSTRATIONS

Symbols

Graphic symbols and class designation letters are based on ANSI Standard Y32.2-1975.

Logic symbology is based on ANSI Y32.14-1973 in terms of positive logic. Logic symbols depict the logic function performed and may differ from the manufacturer's data.

The overline on a signal name indicates that the signal performs its intended function when it is in the low state.

Abbreviations are based on ANSI Y1.1-1972.

Other ANSI standards that are used in the preparation of diagrams by Tektronix, Inc. are:

		PM 112					
are	Y14.15, 1966	Drafting Practices.					
	Y14.2, 1973	Line Conventions and Lettering.					
:	Y10.5, 1968	Letter Symbols for Quantities Used in					
n aio		Electrical Science and Electrical					
gic ac-		Engineering.					
nal	Americ Ne	American National Standard Institute 1430 Broadway New York, New York 10018					
ite.	Component Values						
	Electrical components shown on the diagrams are in the following units unless noted otherwise:						
	Capacitors = V	Values one or greater are in picofarads (pF).					
	,	Values less than one are in microfarads					
on		(μF).					

Resistors = Ohms (Ω).

The information and special symbols below may appear in this manual.-

Assembly Numbers and Grid Coordinates

Each assembly in the instrument is assigned an assembly number (e.g., A20). The assembly number appears on the circuit board outline on the diagram, in the title for the circuit board component location illustration, and in the lookup table for the schematic diagram and corresponding component locator illustration. The Replaceable Electrical Parts list is arranged by assemblies in numerical sequence; the components are listed by component number *(see following illustration for constructing a component number). The schematic diagram and circuit board component location illustration have grids. A lookup table with the grid coordinates is provided for ease of locating the component. Only the components illustrated on the facing diagram are listed in the lookup table. When more than one schematic diagram is used to illustrate the circuitry on a circuit board, the circuit board illustration may only appear opposite the first diagram on which it was illustrated; the lookup table will list the diagram number of other diagrams that the circuitry of the circuit board appears on.





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Table 8-1

Device Type	VCC	GND
2716	24	12
74S00	14	7
74S02	14	7
74S51	14	7
74S74	14	7
74LS132	14	7
74LS138	16	8
74LS148	16	8
74LS157	16	8
74LS158	16	8
74LS161	16	8
74LS240	20	10
74LS244	20	10
74LS374	20	10
81LS97	20	10

PM 112 ACQUISITION



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PMIIZ INSTRUCTION

4288-50

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PMI12 ACQUISITION

PM 112 ACQUISITION $\langle \cdot \rangle$

PM 112 ACQUISITION



ASSEMBL	LY A01	
CIRCUIT NUMBER	SCHEM LOCATION	BOARD LOCATION
J 1075 J 1075 J 1075 P 4039 Q 3085 R 103 1A R 103 1B R 103 1C R 103 1C R 103 1C R 103 3A R 103 3B R 103 3C R 103 3B R 103 3C R 103 3B R 103 3C R 105 3A R 105 1A R 105 1B R 105 1C R 105 1B R 105 1C R 105 1B R 105 3C R 105 3C R 105 3C R 105 3C R 205 1C R 205 1C R 205 1C R 207 5B R 207 5C R 207 7C R 207 7C R 207 7C R 207 7C R 207 7C R 207 9C R 207 9C R 207 9C R 207 9C R 207 1 R 205 1 R 205 1 R 205 1 R 207 9C R 207 9C R 207 9C R 207 9C R 207 9C R 207 1 R 205 1 R 205 1 R 207 9C R	F A A B A B F F F F F F F F F F F F F F	C1 C1 C1 B3 B3 D2 B1 B1 B1 B1 B1 B1 B1 B1 B1 C1 C1 C1 C1 C1 C1 C1 C1 C1 C1 C1 C1 C1

......



ATION	
J 10	75
9 R2019E	5
7 R2079D	6
5 B2079C	
W 3 P2019B	-X
1 R20794	1°
N 9 R2017A	
W 7 RZOTTE	
W C CONTO	
7 K2051E	12
8 R2051D	13
6 R2051C	14
4 R2051B	15
1 R2051A	16
7 R1031D	17)
9 R1031E	18)
7 R1033D	19
9 R1033E	20,
I RIOSIA	21)
1 R1033A	22
3 R1031 B	23
3 R1033B	24
5 RIOJIC	25
5 R1033C	26
2 R1051A	27
2 R1053A	28
*	\neg
5 R2077C	29
3 R2077B	30
1 R2077A	31)
9 R2075E	32)
7 R2075D	33)
5 R2075C	34
3 R2075B	35)
1 R2075A	36
4 R1051 B	37
4 R1053B	38
6 R1051C	39
6 R1053C	40
8 R1051D	41
8 RI053D	42
IO RIOSIE	43
IO RIOSZE	44
~	<
l	$- \gamma -$
8-1 shows IC & Gnd).	

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PM 112

PM 112 SELF-TEST

ASSEMBLY A01 BOARD LOCATION BOARD LOCATION CIRCUIT SCHEM CIRCUIT SCHEM NUMBER LOCATION NUMBER LOCATION R4083 R4084 C1025 A5 A5 A 1 A 3 A 4 D2 C1045 D2 Β1 C1053 C1055 R4085 A5 C 1 A4 D2 A5 C 1 TP1010 A5 A 1 A5 C2025 A2 TP1027-5 F4 B 1 A5 A5 C2035 **B**1 TP4075 A2 D2 TP4085 C2051 C2 A5 D2 C2065 C2075 B3 C4 A5 C2 U2031B B2 A5 A5 C2 U2031C B2 C2080 D1 U2031D E5 B2 C2085 C3025 D2 U2031E E5 B2 B2 U2031F U2061 A2 B2 C3035 C2 C2 C2 C2 C2 E2 C4 E5 B2 U2065 U2071A U2071B U2071C U2071D C3039 B2 C3045 B2 C3049 B2 B3 C3055 C2 B4 C5 F5 C2 C2 C3065 C3071 C2 C2 C2 U3025A A2 C3075 C4025 E1 F2 U3025B A2 03031 B2 A2 B2 C4035 03035 D1 **B**2 A5 A5 A5 C4045 03041 C 1 B2 B2 C4049 03045 E2 B2 B2 C4051 C2 U3051 D2 B2 C4061 A5 C2 U3055 F2 C2 C4071 Α5 C2 03061 C2 C2 C2 C2 C2 C2 C2 C2 C4075 A5 D2 U3065 D2 U3071A U3071B C4081 A3 D2 D4 C4083 ΑĴ D2 D4 C4089 A4 D3 U3071C E5 C2 C2 CR4085 Α4 DŽ U3071D Β4 DS2037 J1075 U3075A U3075B A4 B2 E4 A5 C 1 Β3 C2 L4083 A3 D2 U3079 B3 F54 C3 F4 E4 D2 P4039 F4 B3 U4015A A2 P4039 A2 F5 ΒĴ U4015E U4015H U4061 P4039 A 1 Β3 A2 P4079 Q4071 D3 C2 F5 A4 С2 Ŭ4065 C2 C2 C2 C2 U4071 U4075A Q4083 B4 A3 D2 Q4085 R2037 R2065 R3075 R3079 A4 B2 D2 U4075B U4079A U4079D C5 Α4 Β1 D2 D2 D2 A2 D2 B4 С2 A4 E5 A3 F4 A3 A4 F4 D2 D2 VR4085 W3015 W3085 R4061 C2 C2 D2 R4071 A4 A3 A5 A2 R4081 W4075 c2



PMII2 INSTRUCTION

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PM 112

MULTIBUS P1 EXTENDER

ASSEMBLY A01					
CIRCUIT NUMBER	SCHEM LOCATION	BOARD LOCATION			
C1010 C1012 C1051 C1057 J1030 J1030 P4039 P4039	B2 B2 E5 F1 C1 D1 A1	A 1 A 1 C 1 B 1 B 1 B 3 B 3			

				Scan by Zenith				
	Α	В	С	D	V	E	V	F
1	P/0 P4039)	P/0 J1030		P/0 P4036	9		P/0 J1030
	-	GND	-	(44	(ADRF	44
	2	Į	2		45		ADRC	45
	3	+5V MB	3		46		ADRD	46
	4	C1010	4		(47		ADRA	47
	5	- I O. INF	5		48		ADRB	48
	6		6		(49		ADR8	49
	$\left\langle \begin{array}{c} 7 \\ \end{array} \right\rangle$	+12V MB		J.	(50		ADR9	
	< <u>8</u>		L		< <u>51</u>		ADR6	
2	< <u></u>	RESERVED (-SV MB)			(52		ADRI	
	< <u></u>				< <u>55</u>		ADRS	
		I I		, ,	(<u>5</u> 5		ADR2	
			13		56		ADR3	56
		INIT			57		ADRØ	57
		BPRN	15	C	58		ADRI	58
		BPRO	16		, 59		DATE	59
	517	BUSY	17	(2)	,60		DATE	60
	> 18	BREQ	18		61		DATC	61
	19	MRDC	19		62		DATD	62
3	20	MWTC	20		63		DATA	63
Ŭ	21	IORC	21		264		DATB	64
	22	Iowc	22	\sim	65		DATE	65
	23	XACK	23	3	266		DAT9	66
	24		24		67	anna an	DATG	67
	25	LOCK			268		DAT7	
	(26)	INHZ	26		69		DAT4	
		BHEN			< 71		DATS	
	2 (20	CREO			<		DATZ	
		CBRQ	ADDU (HEX) 30		<		DATA	
4	2 31	CCLK			<74		DATI	74
- 1			ADRIZ (HEX) 32	Ĺ	< 75		GND	75
	2 33	INTA	33		576	1	ţ.	76
	34		ADRIB (HEX) 34		577		RESERVED	רר '
	35	INTO	35		78			78
	36	רדאו	36		79		-IZV MB	79
	37	INT4	37		80	0.10F C1051		80
	38	INT5	38		281		+5V MB	81
	1 239	INT2	39		82	C 1057		82
	40		40		283	_ [O.INF		83
5	41	INTØ	41		84			84
Ĭ	42	INTI	42		< 85	•	GND	85
	2 (43		ADRE 43		< 86		\checkmark	86
	× ⊫≁-1							لم
		P/O AØI PMIIZ	CIRCUIT BD.					
-1								
	PMII2 I	NSTRUCTION 428	8-53			MULTIBU.	S P1 EXTE	NDER 🚯



PM 112

PM 112

A02 LOGIC ANALYZER PLUG BOARD



Figure 8-2. A02 Logic Analyzer Plug Board.

	ΔΤΦ	5	29	DIØ	
+			• 30		
	SIA				
		4	32	013	
	A14			014	
1	A15	6	9.34	DI 5	
	AIG	8	• 35	DIG	
	AI7		936	DI7	
	AIB	12	37	BID	
	AI9	13	938	DI9	
	OIIA	15	39	DIIO	
	AID	14	940	DIII	
	SIIA	17	41	DII2	
	EIIA	16	42	DI 3	
	AII4	19	943	DII4	
	AII5	18	9 44	DIIS	
	AIIG	21	46	CØ (CIØ)	
	AII7	22	9 47	CI (CII)	
	BIIA	23	48	C2(C12)	
	e II e	24	49	C3(CI3)	
	ALZO	26	50	C4(CI4)	
	AISI	25	5 1	C5 (C15)	
	AI 22	28	52	C G(CI6)	
	AI23	27	53	(717) (717)	
	+15VD	58	54	CB (CI8)	
	+5V	45	55	C9(CI9)	
I		57	63	SELP	
I		10	261	HALT PUT (HALT SUT)	
	GND	20	2	CLOCK (CLK)	
	Ţ	30	23	CLOCK (CLK)	
		40	62	LOOK	
		50	COMPONENT NUMB	ER EXAMPLE	
	-15VD	59	A23, A2, R	1234	
		L	Assembly	Schematic Circuit	
		1	Number (il u	ue no Assembly Number Static Sens	itive De

PMILE INSTRUCTION

4288-54





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REPLACEABLE MECHANICAL PARTS

PARTS ORDERING INFORMATION

Replacement parts are available from or through your local Tektronix, Inc. Field Office or representative.

Changes to Tektronix instruments are sometimes made to accommodate improved components as they become available, and to give you the benefit of the latest circuit improvements developed in our engineering department. It is therefore important, when ordering parts, to include the following information in your order: Part number, instrument type or number, serial number, and modification number if applicable.

If a part you have ordered has been replaced with a new or improved part, your local Tektronix, Inc. Field Office or representative will contact you concerning any change in part number.

Change information, if any, is located at the rear of this manual.

SPECIAL NOTES AND SYMBOLS

X000 Part first added at this serial number

00X Part removed after this serial number

FIGURE AND INDEX NUMBERS

Items in this section are referenced by figure and index numbers to the illustrations

INDENTATION SYSTEM

This mechanical parts list is indented to indicate item relationships. Following is an example of the indentation system used in the description column.

1 2 3 4 5

Name & Description

Assembly and/or Component Attaching parts for Assembly and/or Component - - - * - -Detail Part of Assembly and/or Component Attaching parts for Detail Part . . . * . . .

Parts of Detail Part Attaching parts for Parts of Detail Part - - - * - - -

Attaching Parts always appear in the same indentation as the item it mounts, while the detail parts are indented to the right. Indented items are part of, and included with, the next higher indentation. The separation symbol - - - * - - - indicates the end of attaching parts.

Attaching parts must be purchased separately, unless otherwise specified.

ITEM NAME

In the Parts List, an Item Name is separated from the description by a colon (:). Because of space limitations, an Item Name may sometimes appear as incomplete. For further Item Name identification, the U.S. Federal Cataloging Handbook H6-1 can be utilized where possible.

ABBREVIATIONS

NIP

OD

PL

ΡN

RLF

INCH ELCTRN NUMBER SIZE ELEC ACTUATOR ACTR ELCTLT ADPTR ADAPTER ELEM ALIGN ALIGNMENT EPL ALUMINUM EQPT ASSEM ASSEMBLED EXT ASSY ASSEMBLY FIL ATTEN ATTENUATOR FLEX AMERICAN WIRE GAGE AWG FLH ВD BOARD FLTR BRKT BRACKET FR FSTNR BRS BRASS BRZ BRONZE BSHG BUSHING FXD CAB CABINET GSKT CAP CAPACITOR HDL HEX CHAS CHASSIS HEX HD CKT COMP CIRCUIT COMPOSITION HEX SOC HLCPS CONN CONNECTOR HLEXT COV CPLG COVER COUPLING нν IC CATHODE RAY TUBE īD CRT DEG DEGREE IDENT DWR DRAWER IMPLR

AL

ELECTRICAL ELECTROLYTIC **FI EMENT** ELECTRICAL PARTS LIST EQUIPMENT EXTERNAL FILLISTER HEAD FLEXIBLE FLAT HEAD FILTER FRAME or FRONT FASTENER FOOT FIXED GASKET HANDLE HEXAGON HEXAGONAL HEAD HEXAGONAL SOCKET HELICAL COMPRESSION HELICAL EXTENSION HIGH VOLTAGE INTEGRATED CIRCUIT INSIDE DIAMETER IDENTIFICATION IMPELLER

ELECTRON

INCH INCAND INCANDESCENT INSUL INSULATOR INTERNAL INTL LPHLDR LAMPHOLDER MACH MACHINE MECHANICAL MECH MTG MOUNTING NIPPLE NOT WIRE WOUND NON WIRE ORDER BY DESCRIPTION OBD OUTSIDE DIAMETER оун PH BRZ PHOSPHOR BRONZE PLSTC PLASTIC PART NUMBER PNH POWER PWR RECEPTACLE RCPT BES. RIGID RGD RELIEF RETAINER RTNR SOCKET HEAD SCH SCOPE OSCILLOSCOPE SCR SCREW

SINGLE END SE SECT SECTION SEMICONDUCTOR SEMICOND SHLD SHIELD SHOULDERED SHLDR SOCKET sкт SL SLFLKG SLIDE SELF-LOCKING SLEEVING SLVG SPR SPRING SQUARE so STAINLESS STEEL SST STL STEEL sw SWITCH TUBE TERM TERMINAL THREAD THICK THD THK TENSION TNSN TAPPING TRUSS HEAD TPG TRH VOLTAGE VAR VARIABLE W/ WITH WASHER WSHR XEMB TRANSFORMER XSTR TRANSISTOR
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Replaceable Mechanical Parts - PM 112

CROSS INDEX-MFR. CODE NUMBER TO MANUFACTURER

Mfr. Code	Manufacturer	Address	City, State, Zip
000AH	STANDARD PRESSED STEEL CO., UNBRAKO DIV.	8535 DICE ROAD	SANTA FE SPRINGS, CA 90670
000вк	STAUFFER SUPPLY	105 SE TAYLOR	PORTLAND, OR 97214
00779	AMP, INC.	P O BOX 3608	HARRISBURG, PA 17105
09922	BURNDY CORPORATION	RICHARDS AVENUE	NORWALK, CT 06852
12327	FREEWAY CORPORATION	9301 ALLEN DRIVE	CLEVELAND, OH 44125
18677	SCANBE MFG. CORP.	3445 FLETCHER AVE.	EL MONTE, CA 91731
22526	BERG ELECTRONICS, INC.	YOUK EXPRESSWAY	NEW CUMBERLAND, PA 17070
80009	TEKTRONIX, INC.	P O BOX 500	BEAVERTON, OR 97077
83385	CENTRAL SCREW CO.	2530 CRESCENT DR.	BROADVIEW, IL 60153
93907	TEXTRON INC. CAMCAR DIV	600 18TH AVE	ROCKFORD, IL 61101

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Replaceable Mechanical Parts - PM 112

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FIQ. &

Index No.	Tektronix Part No.	Serial/Model No. Eff Dscont	Qty	12345	Name & Description	Mfr Code	Mfr Part Number
1-	131-2613-0	1	1	CONN, RCPT, ELE	C:CABLE,32/64 MALE	80009	131-2613-01
-1	334-3722-0	0	1	. PLATE, IDENT	PERSONALITY MODULE PM100 SERIES	80009	334-3722-00
-2	380-0591-0	0	1	. HSG HALF,CK	F BD:TOP (ATTACHING PARTS)	80009	380-0591-00
-3	211-0225-0	0	2	. SCR, CAP, SOC	HD:4-40 X 0.312 INCH, STL	000AH	OBD
-4	211-0093-0	0	2	. SCR, CAP, SOC	HD:4-40 X 0.75 INCH L,STL	000BK	OBD
-5	210-0551-0	0	4	. NUT, PLAIN, H	EX.:4-40 X 0.25 INCH, STL	000BK	OBD
-6	380-0590-0	1	1	. HSG, HALF: BO	гтом	80009	380-0590-01
-7	343-0836-0	0	2	. CLAMP, CABLE	:3.72 L	80009	343-0836-00
-8	213-0055-0	0	4	. SCR, TPG, THD	FOR:2-32 X 0.188 INCH, PNH STL	93907	OBD
-9		-	1	. CKT BOARD A	SSY:(SEE A02 REPL)		
-10	131-0608-0	0	64	TERMINAL,	PIN:0.365 L X 0.025 PH BRZ GOLD	22526	47357
-11	175-3537-0	2	1	. CA ASSY, SP,	ELEC:64,28 AWG,48.0 L,RIBBON	80009	175-3537-02
-12	343-1059-0	0	1	CLAMP, CABLE: A	LUMINUM (ATTACHING PARTS)	80009	343-1059-00
-13	211-0510-0	0	2	SCREW, MACHINE	:6-32 X 0.375, PNH, STL, CD PL	83385	OBD
-14	210-0802-0	0	2	WASHER.FLAT:0	.15 ID X 0.312 INCH OD	12327	OBD
-15	343-1058-0	0	1	CLAMP.CABLE:A	LUMINUM	80009	343-1058-00
-16		-	1	CKT BOARD ASS	Y:(SEE A01 REPL)		
-17	105-0144-0	0	1	. EJECTOR, CKT	CD:MOLD PLASTIC, W/ROLL PIN	18677	S203
-18	213-0055-0	0	4	. SCR, TPG, THD	FOR: 2-32 X 0.188 INCH, PNH STL	93907	OBD
-19		-	1	. CONN, RCPT, E	LEC:(SEE A01J1030 REPL)		
-20	131-0608-0	0	139	. TERMINAL, PI	N:0.365 L X 0.025 PH BRZ GOLD	22526	47357
-21	131-0993-0	0	13	. BUS, CONDUCT	OR:2 WIRE BLACK	00779	530153-2
-22	136-0751-0	0	1	. SKT, PL-IN E	LEK:MICROCKT,24 PIN	09922	DILB24P108
-23	337-3058-0	0	1	SHIELD, CKT BD	PLASTIC LAMINATE (ATTACHING PARTS)	80009	337-3058-00
-24	211-0038-0	0	4	SCREW, MACHINE	:4-40 X 0.312, FLH, 100 DEG	83385	OBD ·
-25	210-0586-0	0	4	NUT, PL, ASSEM	WA:4-40 X 0.25, STL CD PL	83385	OBD
-26	210-1006-0	0	4	WASHER, FLAT: 0	.12 ID X 0.062 THK, AL, 0.25	80009	210-1006-00



FIGURE 1 EXPLODED

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Fig. & Index No.	Tektronix Part No.	Serial/ Eff	Model No. Dscont	Qty	12345	Name & Description	Mfr Code	Mfr Part Number
					STAN	DARD ACCESSORIES		
	070-4288-0	00		1	MANUAL, TECH:	INSTRUCTION	80009	070-4288-00
	OPTIONAL ACCESSORIES							
	012-0655-	01		1	LEAD SET,ELE	C:INPUT,W/10 40CM L WIRES	80009	012-0655-01

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SIGNAL GLOSSARY

This section contains an alphabetical listing of all the signals which go to or from the PM 112 Personality Module, and a brief description of what each signal does.

A23-A0 PM 112 Address Lines (24 lines). These lines are labeled as AI23-AI0 on circuit diagrams. Al9-A0 carry Multibus address information to the logic analyzer (the Multibus address bit values are inverted by the PM 112's firmware to appear active high to the user). Al0-A0 are bidirectional and are used to address the PM 112's PROM, following the completion of data acquisition. A23 is used to carry INTR(L) (also firmware inverted), and lines A22-A20 are used to carry IPR(H). In newer Multibus systems using 24 address lines, the four most significant address bits can be monitored using the PM 112's UDC lines.

- AACK(L) Multibus Advance Acknowledge Signal. In some early versions of the Multibus specification, a master that detects AACK(L)=0 may avoid some wait states. In later versions of the bus specification, this line is redefined as LOCK(L). See LOCK(L) listing in this glossary.
- ACLO(H) Multibus AC Low Signal. This signal is produced by the power supply when ac voltage drops, indicating dc power failure is imminent. (This line is reserved and not bussed in the IEEE P796 bus specification.)
- ADR0(L)-ADR17(L) Multibus Address Lines (24 lines). The original Multibus specification called for 20 address lines (ADR0(L)-ADR13(L)). Newer Intel and IEEE specifications provide 24 lines, the upper four being carried on the P2 connector of the board. The PM 112 has test point pins for these upper four address lines, allowing the user to connect them to UDC lines with jumper wires.

AI23-AI0 PM 112 Address Lines. See A23-A0.

ALE(H) Multibus Address Latch Enable Signal. A signal used by the CPU to enable an auxiliary address latch. (This line is reserved in the IEEE P796 bus specification.)

- BD RESET Multibus Board Reset Signal. BD RESET is an externally generated signal used to initiate a power-up sequence, and is carried on P2 connector pin 36. (This line is reserved and not bussed in the IEEE P796 bus specification.)
- BCLK(L) Multibus Bus Clock Signal. This signal is used to synchronize bus contention logic. It may be slowed, stopped, or single-stepped.
- BHEN(L) Multibus Byte High Enable Signal. In systems having 16-bit memory and I/O modules, the most significant byte of a 16-bit data word is enabled by BHEN(L)=0.
- BPRO(L) Multibus Bus Priority Out Signal. Used with serial (daisy chain) bus priority resolution, BPRO((L)=0 is passed to the BPRN(L) input of the master currently next highest in priority.
- BPRN(L) Multibus Bus Priority In Signal. A master that detects BPRN(L)=0 is assured that no bus requests of higher priority are pending.
- BREQ(L) Multibus Bus Request Signal. Used with parallel bus priority resolution, a master uses BREQ(L)=0 to request bus control.
- BUSY(L) Multibus Bus Busy Signal. The current bus master generates BUSY(L)=0 to maintain control of the bus. BUSY(L) goes high when the bus is inactive, or when a Bus Exchange is taking place. The PM 112 always inverts this signal to form BUSY(H), except at Test Point TP1027-3 and in generation of BUSY(L) as a self-test stimulus. To generate the PM 112 CLK(H) and CLK(L) signals, the falling edge of BUSY(H) is ORed with the falling edge of XACK(L).
- C9-C0 PM 112 Control lines. These lines are labeled as CI9-CI0 on circuit diagrams. This is a loosely defined category of signals from the PM ll2 to the logic analyzer, which fall into the following subcategories of use:
 - C0 through C3 are available for word recognition and are stored by the logic analyzer's acquisition memory.
 - C4 and C5 are available for word recognition and clock qualification, but are not stored by the acquisition memory.

• C6 through C9 are available for clock qualification, but are not available for word recognition and are not stored.

C9-C0 are assigned to the following signals:

C0:	R(H)/W(L)	C5:	INH2(L)
Cl:	MEM(H)/IO(L)	C6:	CBRQ(L)
C2:	INTA+AVAL(H)	C7:	AACK(L)
C3:	BHEN(L)	C8:	ACLO(H)
C4:	INHL(L)	С9:	BUSY(H)

- CBRQ(L) Multibus Common Bus Request Signal. CBRQ(L)=0 indicates that a master wants control of the bus. Conversely, CBRQ(L)=1 indicates to the bus master that it may retain control of the bus.
- CCLK(L) Multibus Common Clock Signal. This is a constant frequency, active low clock signal. It is generated by a single master and used as the system clock.
- CI9-CI0 PM 112 Control Lines (see C9-C0).
- CLK(H), CLK(L) PM 112 Clock Signals. These differential ECL signals cause the logic analyzer to perform an acquisition strobe. The CLK signals are generated by ORing the falling edge of XACK(L) with the rising edge of BUSY(L).
- D7-D0 PM 112 Data Lines (least significant byte). These lines are labeled as DI7-DI0 on circuit diagrams. The Multibus data bus values are inverted by the PM 112's firmware to appear active high to the user. These lines are also used to carry information from the PM 112's PROM, following the completion of data acquisition.
- D15-D8 PM 112 Data Lines (most significant byte). These lines are labeled as DI15-DI8 on circuit diagrams. The Multibus data bus values are inverted by the PM 112's firmware to appear active high to the user. These 8 lines are also used to carry UDC7-UDC0 when BHEN(L)=1.
- DATO(L)-DATF(L) Multibus Data Lines. Sixteen bidirectional data lines are available for 16-bit systems (the Multibus BHEN(L) signal enables the high data byte on 16-bit data transfer operations). Only DATO(L)-DAT7(L) are used with 8-bit systems.

- DI15-DI0 PM 112 Data Lines. See D15-D8 and D7-D0.
- HALT(L) Multibus Halt Signal. HALT(L)=0 indicates that the CPU is halted. (This line is reserved and not bussed in the IEEE P796 bus specification.)
- HALT SUT(L) Logic Analyzer Halt System Under Test Signal. This signal (called HALT PUT on 7D02 circuit diagrams) is generated by the logic analyzer. If selected in the trigger menu, the HALT SUT(L) signal goes low when data acquisition is completed. HALT SUT can only be accessed via a square pin on the personality module. It must be connected to the appropriate SUT line using a jumper wire. If you connect this signal, be sure that there is no electrical contention with an existing Halt line input to the microprocessor.
- INH1(L) Multibus Inhibit RAM Signal. INH1(L)=0
 prevents RAM from responding to addresses and
 commands on the bus, thus enabling ROM and
 memory-mapped I/O devices to share RAM
 addresses.
- INH2(L) Multibus Inhibit ROM Signal. INH2(L)=0
 prevents ROM from responding to addresses and
 commands on the bus, allowing shadow ROMs to
 share memory space.
- INIT(L) Multibus Initialize Signal. INIT(L)=0 resets the entire system to a known state.
- INTA(L) Multibus Interrupt Acknowledge Signal. This signal is generated by the bus master in response to an interrupt request. This causes the interrupt status to freeze and the interrupt vector address to be placed on the data bus.
- INTA+AVAL(H) PM 112 Interrupt Acknowledge + Bus Available Signal. This signal is generated by PM 112 hardware from the Multibus MWTC(L), MRDC(L), IORC(L), IOWC(L), INTA(L), and BUSY(L) signals. INTA+AVAL(H)=1 indicates either an Interrupt Acknowledge cycle or a cycle on which the bus is available (i.e., not Busy, no master has control of the bus). The R(H)/W(L) line can be used to distinguish these two cycles from each other.
- IPRPM 112 Interrupt Priority Lines (3 lines car-
ried on A22-A20). This is a 3-bit word

recognizer field into which the PM 112 hardware encodes the Multibus INTO(L)-INT7(L) signals. The value of the IPR field on any given cycle is the number of the highest priority pending request, where 0 is the highest possible priority, and 7 is the lowest. In the data display I field (interrupt request information) a "." indicates that no requests are pending.

- INTO(L)-INT7(L) Multibus Interrupt Request Signals (8 lines).
 Used for parallel resolution of interrupt
 priority. INTO(L) is the highest priority and
 INT7(L) is the lowest.
- INTR(L) PM 112 Interrupt Request Signal (carried on A23). This signal is generated by the PM112 hardware from the Multibus INTO(L)-INT7(L) lines, and is then inverted by PM 112 firmware to appear active high to the user. The signal indicates that an interrupt has been requested.
- IORC(L) Multibus I/O Read Command. This signal indicates that the address of an I/O port is on the address bus, and that the port's output should be placed on the data bus.
- IOWC(L) Multibus I/O Write Command. This signal indicates that the address of an I/O device is on the address bus, and that the port should output the information on the data bus.
- LOCK(L) Multibus Lock Signal. This signal is used by a master when locked access to the bus during read-modify-write cycles is required.
- LOOK(H) Logic Analyzer Look Signal. This is a control signal from the logic analyzer to the PM 112. It serves to tri-state some of the personality module input buffers, preventing electrical contention from them when it reads the personality module's PROM.
- MEM(H)/IO(L) PM 112 Memory/IO Line. The signal is generated by PM 112 hardware from the Multibus MWTC(L), MRDC(L), IOWC(L), IORC(L), INTA(L), and BUSY(L) signals. MEM(H) or I/O(L)=1 normally indicates that a data transfer is to or from memory. MEM(H)/IO(L)=0 normally indicates that an I/O operation of some type is taking place.
- MPRO(L) Multibus Memory Protect Signal. When dc power is faulty, this signal prevents memory operation by inhibiting memory requests. MPRO(L) is

carried on P2 connector pin 20. (This line is reserved and not bussed in the IEEE P796 bus specification.)

- MRDC(L) Multibus Memory Read Command. This signal indicates that the address on the bus is valid, and that the contents of that address are to be placed on the data bus.
- MWTC(L) Multibus Memory Write Command. This signal indicates that the address on the bus is valid and that the information on the data bus is to be written there.
- PAR1(L), PAR2(L) Multibus Parity Lines 1 and 2. These signals are located on the P2 connector at pins 27 and 29, respectively. (These lines are reserved and not bussed in the IEEE P796 bus specification.)
- PFIN(L) Multibus Power Fail Interrupt Signal. This signal interrupts the processor when a power failure has occurred. It is driven by an auxiliary power source, and is carried on P2 connector pin 19. (This line is reserved and not bussed in the IEEE P796 bus specification.)
- PFSN(L) Multibus Power Fail Sense Signal. This signal indicates that a power failure has occurred. It is driven by an auxiliary power source, and is carried on P2 connector pin 17. (This line is reserved and not bussed in the IEEE P796 bus specification.)
- PFSR(L) Power Fail Sense Reset Signal. This signal resets PFSN(L). It is carried on P2 connector pin 13. (This line is reserved and not bussed in the IEEE P796 bus specification.)
- PLC(H) Multibus Power Line Clock. Carried on P2 connector pin 31. (This line is reserved and not bussed in the IEEE P796 bus specification.)
- R(H)/W(L) PM 112 Read/Write Line. This signal is generated by the PM 112 hardware from the Multibus MWTC(L), MRDC(L), IOWC(L), IORC(L), INTA(L), and BUSY(L) signals. R(H)/W(L)=1 normally indicates that a Read operation of some type is taking place, and R(H)/W(L)=0 normally indicates a Write operation.
- RESET(L) Multibus Reset Signal. This signal initiates a power-up sequence. It is carried on P2 connector pin 36. (This line is reserved and not

bussed in the IEEE P796 bus specification.)

SELP(L)

- Logic Analyzer Select PROM Signal. This is a control signal from the logic analyzer to the PM 112. SELP(L) enables the PM 112 PROM to be read by the logic analyzer.
- UDC7-UDC0 PM 112 User-Defined Control Lines. These user-definable lines can be used to monitor a variety of Multibus signals. These signals are accessed with movable jumper straps and/or flying leads. They are carried on the PM 112's data lines D15-D8 when 8-bit bus transactions are performed by the SUT (or whenever BHEN(L)=1). For use with 16-bit processors, a jumper is provided on the PM 112 hardware to force BHEN(L)=1 (as seen by the PM 112) on all cycles.

The most significant eight data bits in the logic analyzer's word recognizer menu can be used for UDC7-UDC0 values as well as for data -- see WORD RECOGNIZER MENU and USING UDC LINES in Operation Instructions section.

The default assignments of the UDC lines are as follows:

MRDC(L)	UDC4:	INTA(L)
MWTC(L)	UDC5:	INH2(L)
IORC(L)	UDC6:	LOCK(L)
IOWC(L)	UDC7:	INH1(L)
	MRDC(L) MWTC(L) IORC(L) IOWC(L)	MRDC(L)UDC4:MWTC(L)UDC5:IORC(L)UDC6:IOWC(L)UDC7:

WAIT(L)

Multibus Bus Master Wait State Signal. This signal indicates that the master's processor is in a wait state. (This line is reserved and not bussed in the IEEE P796 bus specification.)

XACK(L) Multibus Transfer Acknowledge Signal. A slave module uses this signal to acknowledge that a master's command has been executed, and that information has been received from or placed onto the data lines. The PM 112 uses the falling edge of this signal ORed with the rising edge of BUSY(L) to generate the PM 112 CLK(H) and CLK(L) signals. This in turn causes the 7D02 to generate an acquisition strobe.